

Test Report

Test Report No. : **TS0817-005**

Date of issue : **2017-09-21**

Subject:

Type test Numerical Line Protection SIPROTEC 5 - V07.50 / Edition 12

The tests were performed by:

SIEMENS AG
Development
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The tests were performed for:

SIEMENS AG
Products
EM DG PRO LM
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This test report consists of 152 pages.

Tested equipment

Multifunction Protection Relays SIPROTEC 5

Product group: Numerical Line Protection

7SA84, 7SA86, 7SA87, 7SD84, 7SD86, 7SD87, 7SJ86, 7SL86, 7SL87, 7VK87,
7SA82, 7SD82, 7SL82

Firmware V07.50

Tests are according to:

IEC/EN 60255, VDE 0435, IEC/ EN 60870-2-1, UL 508,
IEC/EN 60255-25/26, IEC/EN 61000-6-2, IEC/EN 61000-6-4,
IEEE Std C37.90.1/2

Performed tests:

Properties at reference conditions

Test results:

The equipment has successfully passed the type test. The equipment did not show any changes and was fully in order subsequent to these tests.

SIEMENS AG - EM DG PRO
Division Energy Management
Digital GridPlace: EM DG PRO D
13629 Berlin (Siemensstadt)


Date: 2017-09-21

Tested by: Ryzek



Signature

Reviewed by: Rochow



Signature

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Range of validity

SIPROTEC 5 Platform and Hardware Characteristics

The SIPROTEC 5 series includes both modular and non-modular devices.

Modular devices consist of a base module (1/3 of 19 inches) and can be expanded with expansion modules (1/6 of 19 inches). The device type identifier for modular devices is XXX85, XXX86 or XXX87, for example, 7SA86 Type XXX84 devices have the same hardware properties as the modular devices, but they cannot be expanded with expansion modules.

All non-modular devices consist of just a base module (1/3 of 19 inches) and cannot be expanded with expansion modules (1/6 of 19 inches). The device type identifier for non-modular devices is 7XX82, e.g., 7SJ82.

Hardware Characteristics of Modular Devices

A modular device always consists of a base module and optionally of expansion modules. The modules can be chosen according to hardware characteristics. These characteristics are:

- Module size
- Type of construction
- Mounting of the on-site operation panel
- Layout (or design) of the on-site operation panel
- Input and output module
- Plug-in modules

The modules are available in 2 sizes:

- Base module (1/3 of 19 in)
- Extension module (1/6 of 19 in)

The devices are available in 3 designs:

- Flush-mounting devices with on-site operation panel fitted directly on the device
- Surface-mounting devices with integrated on-site operation panel
- Surface-mounting devices with detached on-site operation panel

The on-site operation panels of the base modules can be selected from 3 variants:

- With a large display, keypad, and 16 2-colored LEDs
- With a small display, keypad, and 16 2-colored LEDs
- Without a display, without a keypad, but with 16 2-colored LEDs

The on-site operation panels of the extension modules can be selected from 4 variants:

- With 16 1-colored LEDs and 2 key switches
- With 16 1-colored LEDs
- With 8 push-buttons and 8 1-colored LEDs
- Without display elements

The base module always contains the power-supply module PS201 and an input and output module IO2XX.

The extension module contains an input and output module IO2XX or a plug-in module assembly with integrated power supply CB202.

The 1st extension module in the 2nd device row always contains power supply module PS203.

The plug-in modules are available for various applications. The following plug-in modules can be installed in the base module or in an extension module with plug-in module assembly with integrated power supply CB202:

- Communication module
- Measuring-transducer module

Range of validity

Hardware Characteristics of Non-Modular Devices

A non-modular device always consists of just one module (1/3 of 19 inches) and cannot be expanded with expansion modules (1/6 of 19 inches). These hardware characteristics are:

- Module size: 1/3 of 19 in.
- Type of construction: Flush-mounting devices with on-site operation panel fitted directly on the device

The on-site operation panels can be chosen from 2 variants:

- With a large display, keypad, and 16 2-colored LEDs
- With a small display, keypad, and 16 2-colored LEDs

The module always contains the power supply module PS101 and an input and output module IO10X. The input and output module IO10X includes the terminals for current and voltage transformers. Optionally, the module can be equipped an additional input and output module IO110 for extra binary inputs and outputs. The plug-in modules are available for various applications. The following plug-in modules can be installed in the module:

- Communication modules
- Measuring-transducer modules

Range of validity**SIPROTEC 5 devices**

All type tests were performed at various combinations of all modules of the SIPROTEC 5 platform. As a result the following devices were covered:

Model of Protective Relay	Trip Detection	Quantity structure
7SA82 Distance Protection	3 pole trip	I/Os not extendable
7SD82 Differential Protection	3 pole trip	I/Os not extendable
7SL82 Line Protection	3 pole trip	I/Os not extendable
7SA84 Distance Protection	3 pole trip	I/Os not extendable
7SD84 Differential Protection	3 pole trip	I/Os not extendable
7SA86 Distance Protection	3-pole trip	I/Os fully modular
7SD86 Differential Protection	3-pole trip	I/Os fully modular
7SL86 Line Protection	3-pole trip	I/Os fully modular
7SJ86 Over Current Protection	3-pole trip	I/Os fully modular
7SA87 Distance Protection	1 and 3 pole trip	I/Os fully modular
7SD87 Differential Protection	1 and 3 pole trip	I/Os fully modular
7SL87 Line Protection	1 and 3 pole trip	I/Os fully modular
7VK87 Breaker Management Device	1 and 3 pole trip	I/Os fully modular

Range of validity

SIPROTEC 5, functional description of power supply, CPU, IO boards and plug-in modules

All hardware type tests were performed at various combinations with all modules of the SIPROTEC 5 platform. As a result all realized devices were covered:

SIPROTEC 5

Functional description of boards for modular devices

Board name	Functional description
PS201	Power Supply Board (DC: 24 V/48 V or 60 V to 250 V and AC: 100 V to 230 V), mounted in 1/3 19-inch size housing, including 3 binary inputs, 2 binary outputs and one status life contact
PS203	Power Supply Board for the 2 nd row of devices, (DC: 24 V/48 V or 60 V to 250 V and AC: 100 V to 230 V), mounted in 1/6 19-inch size housing
CB202	Plug-in module assembly, including an additional power supply, (DC: 24 V/48 V or 60 V to 250 V and AC: 100 V to 230 V), mounted in 1/6 19-inch size housing
CP200/CP300	Processor (CPU) Board, mounted into the front cover of the 1/3 19-inch size housing, different variants for the available device designs
IO201	Input Output Board, 4 current inputs, 8 binary inputs, 6 binary outputs, reduced assembled variant of IO202
IO202	Input Output Board, 4 current measuring inputs, 4 voltage measuring inputs, 8 binary inputs, 6 binary outputs, mounted in 1/6 or 1/3 19-inch size housing
IO203	Input Output Board, 8 current measuring inputs, 4 binary inputs, 4 binary outputs, mounted in 1/6 19-inch size housing
IO204	Input Output Board, 10 binary inputs, 4 binary outputs, 4 power relays for controlling 2 motors, mounted in 1/6 19-inch size housing
IO205	Input Output Board, 12 binary inputs, 16 binary outputs, mounted in 1/6 19-inch size housing
IO206	Input Output Board, 6 binary inputs, 7 binary outputs, mounted in 1/6 19-inch size housing, reduced assembled variant of IO205
IO207	Input Output Board, 16 binary inputs, 8 binary outputs, mounted in 1/6 19-inch size housing
IO208	Input Output Board, 4 current measuring inputs, 4 voltage measuring inputs, 4 binary inputs, 11 binary outputs, mounted in 1/3 or 1/6 19-inch size housing
IO209	Input Output Board, 8 binary inputs, 4 High Speed Outputs, mounted in 1/6 19-inch size housing
IO210	Input Output Board, 4 current measuring inputs, 3 voltage measuring inputs, 7 binary outputs, 4 high-speed measuring-transducer inputs for current or voltage, mounted in 1/6 19-inch size housing
IO211	Input Output Board, 8 voltage measuring inputs, 8 binary inputs, mounted in 1/6 or 1/3 19-inch size housing
IO212	Input Output Board, 8 high-speed measuring-transducer inputs for current or voltage, 8 binary inputs, mounted in 1/6 19-inch size housing
IO214	Input Output Board, 4 current measuring inputs, 4 voltage measuring inputs, 2 binary in-puts, 5 binary outputs, mounted in 1/6 or 1/3 19-inch size housing, reduced assembled variant of IO202
IO215	Input Output Board, 4 current measuring inputs, 4 voltage measuring inputs (designed for a measuring range up to 7.07 V) 8 binary inputs, 6 binary outputs, mounted in 1/6 or 1/3 19-inch size housing
IO230	Input Board, 48 binary inputs, mounted in 1/6 19-inch size housing
IO231	Input Output Board, 24 binary inputs, 24 binary outputs, mounted in 1/6 19-inch size housing
IO233	Input Board, 48 binary inputs (a fixed pickup threshold value of DC 105 V

Range of validity

	applies), mounted in 1/6 19-inch size housing
PB201	Process-Bus Module, 7 LC Duplex interfaces of which one is a service port, mounted in 1/6 19-inch size housing

Functional description of boards for non-modular devices

Board name	Functional description
PS101	Power Supply Board (DC: 24 V/48 V or DC: 60 V to 125 V or DC: 110 V to 250 V and AC: 100 V to 230 V), including 3 binary inputs, 2 binary outputs and one status life contact
IO101	Input Output Board, 4 current inputs, 8 binary inputs, 6 binary outputs, reduced assembled variant of IO102
IO102	Input Output Board, 4 current inputs, 4 voltage inputs, 8 binary inputs, 6 binary outputs
IO103	Input Output Board, 8 current inputs, 4 binary inputs, 4 binary outputs
IO110	Input Output Board, 12 binary inputs, 7 binary outputs
IO111	Temperature module, 12 resistance temperature detectors
CP100	Processor (CPU) Board, mounted into the front cover of the device

Functional description of plug-in modules for modular devices and for non-modular devices

USART-xx ¹ -y ² EL	Serial communication module, electrical connection
USART-xx ¹ -y ² FO	Serial communication module, optical connection
USART-xx ¹ -y ² LDFO	Serial communication module for long distances, optical connection
ETH-xx ¹ -2EL	Ethernet module, electrical connection
ETH-xx ¹ -2FO	Ethernet module, optical connection
ANAI-CA-4EL	Measuring-transducer module
ARC-CD-3FO ³	Arc Protection module

Valid for all firmware and DIGSI versions.

¹ xx: two letters, unique code for the module in the product code of the device

² y: 1 = 1 channel;
2 = 2 channels

³ Not available for Busbar Protection and Fault Recorder

Scope of editions

Edition	Date	Modifications or supplements compared to the former edition
01	2012-02-17	First edition, Software V01.00
02	2012-04-20	Revision and extended at Software V01.11
03	2012-12-03	Revision and extended at Software V02.00
04	2013-04-09	Revision and extended at Software V03.00
05	2013-12-20	Revision and extended at Software V04.00
06	2014-07-18	Revision and extended at Software V05.00
07	2014-12-19	Revision and extended at Software V06.00
08	2015-04-25	Extended at Software V06.04
09	2015-12-18	Revision and extended at Software V07.00
10	2016-07-18	Revision and extended at Software V07.30
11	2017-02-28	Revision and extended at Software V07.34
12	2017-09-21	Revision and extended at Software V07.50

Subcontracting**Testing laboratory****Marking**

Technical information; Technical Data

Technical Information; Description:

Manual			Edition
1. SIPROTEC 5 Protection Devices Product Information	Part No.	C53000-B5000-C001-B	German
		C53000-B5040-C001-B	English
2. SIPROTEC 5 Hardware Manual	Part No.	C53000-G5000-C002-A	German
		C53000-G5040-C002-A	English
3. SIPROTEC 5 Operating Manual	Part No.	C53000-G5000-C003-6	German
		C53000-G5040-C003-6	English
4. SIPROTEC 5 Distance Protection, Line Differential Protection and Overcurrent Protection for 3-Pole Tripping 7SA82, 7SD82, 7SL82, 7SA84, 7SD84, 7SA86, 7SD86, 7SL86, 7SJ86 Manual	Part No.	C53000-G5000-C010-7	German
		C53000-G5040-C010-7	English
5. SIPROTEC 5 Distance Protection, Line Differential Protection and Breaker Management for 1-Pole and 3-Pole Tripping 7SA87, 7SD87, 7SL87, 7VK87 Manual	Part No.	C53000-G5000-C011-7	German
		C53000-G5040-C011-7	English
6. SIPROTEC 5 Distance Protection, Line Differential Protection and Breaker Management for 1-Pole and 3-Pole Tripping 7SA87, 7SD87, 7SL87, 7VK87 Manual	Part No.	C53000-G5000-C011-9	German
		C53000-G5040-C011-9	English

For the Technical Data see the description (Technical Information).

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Summary

1 Properties at reference conditions

1.1 General

1.1.1 Standards

For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

1.1.2 Time specifications and measurings

If not otherwise declared, all specifications/results of pickup/tripping/reset times refer to the output of signals via fast output relays (Type F).

BO = Binary output

Binary outputs:

Number and data acc. to the order variant, see also general diagrams of devices

1.1.3 Relay operating times

Switching time (OOT)

Type S = standard relay

Type F = fast relay

Type HS = High-Speed Relay

OOT (Output Operating Time): additional delay of the output medium used

OOT:

Closing time: typical: 8 ms; maximum: 10 ms;

Opening time: typical: 2 ms; maximum: 5 ms;

OOT:

Closing time: typical: 4 ms; maximum: 5 ms;

Opening time: typical: 2 ms; maximum: 5 ms;

OOT:

Closing time: typical: 0,2 ms; maximum: 0,2 ms;

Opening time: typical: 9 ms; maximum: 9 ms;

Summary

1.2 87L Line Differential Protection

1.2.1 Specifications

- VDE 0435
- IEC/EN 60255-1, Item 7, Annex A, B
- Time measurements done with fast relays

1.2.2 Tripping threshold Idiff stage

1.2.2.1 Pickup values

Test condition: fault L-N, $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 $0.100 I_{rated} \leq I_{ph} < 20.000 I_{rated}$

Test values: $0.100 \text{ A} \leq I_{ph} < 0.000 \text{ A}$ for $I_{rated} = 1 \text{ A}$
 $0.500 \text{ A} \leq I_{ph} < 0.000 \text{ A}$ for $I_{rated} = 5 \text{ A}$

Permissive tolerance/Limiting values: deviation d of set point value
 $|d| \leq 5\%$ of setting value for up to 3 line ends
 $|d| \leq 10\%$ of setting value for up to 6 line ends
 or
 $|d| \leq 1\%$ of I_{rated} for each line end

Test results/Remarks: $|d| \leq 5\%$ or $< 1\%$ I_{rated} for 2 line ends

1.2.2.2 Dropout ratio

Test condition: see item 1.2.2.1

Test values: see item 1.2.2.1

Permissive tolerance/Limiting values: $r = 0.5$ if process monitor indicates circuit breaker close
 $r = 0.8$ if process monitor indicates circuit breaker open

Test results/Remarks: $r \approx 0.5$ if process monitor indicates circuit breaker close
 $r \approx 0.8$ if process monitor indicates circuit breaker open
 depending on measuring tolerances

1.2.2.3 Pickup times

Test condition: fault L-N, $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}, I_{rated} = 1 \text{ A}$
 Topology = 2...6 ends, 3 in ring (3R)
 Transmission rate 64 kbit/s, 128 kbit/s, 512 kbit/s, 2048 kbit/s
 100 shots per topology, frequency, transmission rate

Test values: $I_{fault} = 1 \text{ A}, I_{ph} = 0.300 \text{ A}$
 $t_{min}/t_{typ}/t_{max}$ in ms

Permissive tolerance/Limiting values: up to 40 ms for 2 ends, 3 in ring with 512 kbit/s, 2048 kbit/s
 up to 41 ms for 3 ends with 512 kbit/s, 2048 kbit/s
 up to 42 ms for 4 ends with 512 kbit/s, 2048 kbit/s
 up to 43 ms for 5 ends with 512 kbit/s, 2048 kbit/s
 up to 45 ms for 6 ends with 512 kbit/s, 2048 kbit/s

Test results/Remarks:

Topology	Frequency	2048 kbit/s	512 kbit/s	128 kbit/s	64 kbit/s
2	50	28/31/34	28/31/39	31/36/42	36/47/58
2	60	26/28/32	25/28/32	27/34/39	33/44/58
3R	50	28/31/35			
3R	60	26/29/33			
3	50	28/32/35			
3	60	26/29/33			
4	50	29/32/36			
4	60	27/31/35			
5	50	30/33/38			
5	60	27/32/36			
6	50	30/35/40			
6	60	28/32/37	31/36/42	38/47/66	53/74/124

$t_{min}/t_{typ}/t_{max}$ in ms, e.g. for 2048 kBit/s: 28/31/34

Summary

1.2.2.4 Dropout times

Test condition:	see item 1.2.2.3					
Test values:	see item 1.2.2.3					
Permissive tolerance/Limiting values:	up to 50 ms					
Test results/Remarks:	Topology	Frequency	2048 kbit/s	512 kbit/s	128 kbit/s	64 kbit/s
	2	50	27/28/29	28/31/39	36/38/41	45/48/52
	2	60	28/28/29	27/30/35	27/35/40	35/45/62
	3R	50	27/28/30			
	3R	60	27/28/30			
	3	50	26/28/29			
	3	60	26/28/30			
	4	50	26/28/33			
	4	60	25/28/31			
	5	50	26/30/36			
	5	60	25/27/33			
	6	50	29/32/36			
	6	60	24/29/34	28/34/40	35/46/70	50/72/107
	$t_{min}/t_{typ}/t_{max}$ in ms, e.g. for 2048 kBit/s: 27/28/29					

1.2.2.5 Delay times

Test condition:	0.00 s $\leq T_{diff}$ \leq 60.00 s 0.00 s $\leq T_{310}$ \leq 0.50 s
Test values:	0.00 s $\leq T_{diff}$ \leq 60.00 s 0.00 s $\leq T_{310}$ \leq 0.50 s
Permissive tolerance/Limiting values:	d 1 % of setting value or d \leq 10 ms
Test results/Remarks:	d < 1 % of setting value or < 10ms

1.2.3 Tripping threshold Idiff fast stage

1.2.3.1 Pickup values

Test condition:	fault L-N , $f_{rated} = 50$ Hz, 60 Hz 0.800 I_{rated} $\leq I_{ph} <$ 100.000 I_{rated}
Test values:	0.800 A $\leq I_{ph} <$ 7.000 A for $I_{rated} = 1$ A 4.000 A $\leq I_{ph} <$ 8.000 A for $I_{rated} = 5$ A
Permissive tolerance/Limiting values:	deviation d of set point value d 5 % of setting value for up to 3 line ends d 10 % of setting value for up to 6 line ends or d 1 % of I_{rated} for each line end
Test results/Remarks:	d 5 % of setting value or < 1 % I_{rated} for 2 line ends

1.2.3.2 Dropout ratio

Test condition:	see item 1.2.3.1
Test values:	see item 1.2.3.1
Permissive tolerance/Limiting values:	$r = 0.5$ if process monitor indicates circuit breaker close $r = 0.7$ if process monitor indicates circuit breaker open
Test results/Remarks:	r approx. 0.5 if process monitor indicates circuit breaker close r approx. 0.7 if process monitor indicates circuit breaker open depending on measuring tolerances

Summary

1.2.3.3 Pickup times

Test condition:	fault L-N, $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}, I_{rated} = 1 \text{ A}$ Topology = 2...6 ends, 3 in ring (3R) Transmission rate 64 kbit/s, 128 kbit/s, 512 kbit/s, 2048 kbit/s 100 shots per topology, frequency, transmission rate					
Test values:	$I_{fault} = 2 \text{ A}, I_{ph} > = 1.000 \text{ A}$ $t_{min}/t_{typ}/t_{max}$ in ms					
Permissive tolerance/Limiting values:	up to 22 ms for 2 ends, 3 in ring with 512 kbit/s, 2048 kbit/s up to 25 ms for 3 ends with 512 kbit/s, 2048 kbit/s up to 27 ms for 4 ends with 512 kbit/s, 2048 kbit/s up to 29 ms for 5 ends with 512 kbit/s, 2048 kbit/s up to 31 ms for 6 ends with 512 kbit/s, 2048 kbit/s					
Test results/Remarks:	Topology	Frequency	2048 kbit/s	512 kbit/s	128 kbit/s	64 kbit/s
	2	50	12/15/18	12/15/18	13/17/21	17/24/33
	2	60	11/14/17	12/15/18	12/17/21	17/24/31
	3R	50	13/16/19			
	3R	60	13/16/19	14/17/20	15/19/23	20/26/33
	3	50	14/17/20	15/18/22	15/21/30	21/33/52
	3	60	13/17/20			
	4	50	14/17/21			
	4	60	14/18/22			
	5	50	13/18/23			
	5	60	14/18/24			
	6	50	13/20/25			
	6	60	14/19/26			
	$t_{min}/t_{typ}/t_{max}$ in ms, e.g. for 2048 kBit/s: 12/15/18					

1.2.3.4 Dropout times

Test condition:	see item 1.2.3.3					
Test values:	see item 1.2.3.3					
Permissive tolerance/Limiting values:	up to 50 ms					
Test results/Remarks:	Topology	Frequency	2048 kbit/s	512 kbit/s	128 kbit/s	64 kbit/s
	2	50	29/35/41	33/36/40	35/38/41	39/45/54
	2	60	29/35/40	34/37/39	35/38/44	39/46/52
	3R	50	30/36/40			
	3R	60	29/35/40	33/36/39	34/38/42	38/45/57
	3	50	30/36/41	33/36/42	34/39/45	39/50/66
	3	60	29/36/41			
	4	50	30/37/42			
	4	60	29/37/42			
	5	50	24/37/43			
	5	60	23/37/46			
	6	50	23/38/45			
	6	60	23/38/45			
	$t_{min}/t_{typ}/t_{max}$ in ms, e.g. for 2048 kBit/s: 29/35/41					

1.2.4 Tripping threshold Idiff fast 2 stage

1.2.4.1 Pickup values

Test condition:	fault L-N, $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $0.500 I_{rated} \leq I_{ph} < 100.000 I_{rated}$
Test values:	$0.500 \text{ A} \leq I_{ph} < 7.000 \text{ A}$ for $I_{rated} = 1 \text{ A}$ $4.000 \text{ A} \leq I_{ph} < 8.000 \text{ A}$ for $I_{rated} = 5 \text{ A}$
Permissive tolerance/Limiting values:	deviation d of set point value d 5 % of setting value for up to 3 line ends d 10 % of setting value for up to 6 line ends or d 1 % of I_{rated} for each line end
Test results/Remarks:	d 5 % of setting value or < 1 % I_{rated} for 2 line ends

Summary

1.2.4.2 Dropout ratio

Test condition: see item 1.2.3.1
 Test values: see item 1.2.3.1
 Permissive tolerance/Limiting values: $r = 0.5$ if process monitor indicates circuit breaker close
 $r = 0.7$ if process monitor indicates circuit breaker open
 Test results/Remarks: r approx. 0.5 if process monitor indicates circuit breaker close
 r approx. 0.7 if process monitor indicates circuit breaker open
 depending on measuring tolerances

1.2.4.3 Pickup times

Test condition: fault L-N, $f_{rated} = 50$ Hz, 60 Hz, $I_{rated} = 1$ A
 Topology = 2...6 ends, 3 in ring (3R)
 Transmission rate 64 kbit/s, 128 kbit/s, 512 kbit/s, 2048 kbit/s
 100 shots per topology, frequency, transmission rate

Test values: $I_{fault} = 2$ A, $I_{ph} > = 1.000$ A
 $t_{min}/t_{typ}/t_{max}$ in ms

Permissive tolerance/Limiting values: up to 22 ms for 2 ends, 3 in ring with 512 kbit/s, 2048 kbit/s
 up to 25 ms for 3 ends with 512 kbit/s, 2048 kbit/s
 up to 27 ms for 4 ends with 512 kbit/s, 2048 kbit/s
 up to 29 ms for 5 ends with 512 kbit/s, 2048 kbit/s
 up to 31 ms for 6 ends with 512 kbit/s, 2048 kbit/s

Test results/Remarks:

Topology	Frequency	2048 kbit/s	512 kbit/s	128 kbit/s	64 kbit/s
2	50	14/16/18	14/16/18	13/15/18	13/15/16
2	60	13/15/18	13/15/18	13/15/18	13/15/18
3R	50	13/16/19			
3R	60	13/16/19	14/17/20	15/19/23	20/26/33
3	50	14/17/20	15/18/22	15/21/30	21/33/52
3	60	13/17/20			
4	50	14/17/21			
4	60	14/18/22			
5	50	13/18/23			
5	60	14/18/24			
6	50	13/20/25			
6	60	14/19/26			

$t_{min}/t_{typ}/t_{max}$ in ms, e.g. for 2048 kBit/s: 14/16/18

1.2.4.4 Dropout times

Test condition: see item 1.2.3.3

Test values: see item 1.2.3.3

Permissive tolerance/Limiting values: up to 50 ms

Test results/Remarks:

Topology	Frequency	2048 kbit/s	512 kbit/s	128 kbit/s	64 kbit/s
2	50	27/29/31	27/29/31	26/28/31	26/28/30
2	60	26/28/31	26/28/30	26/28/31	26/28/31
3R	50	30/36/40			
3R	60	29/35/40	33/36/39	34/38/42	38/45/57
3	50	30/36/41	33/36/42	34/39/45	39/50/66
3	60	29/36/41			
4	50	30/37/42			
4	60	29/37/42			
5	50	24/37/43			
5	60	23/37/46			
6	50	23/38/45			
6	60	23/38/45			

$t_{min}/t_{typ}/t_{max}$ in ms, e.g. for 2048 kBit/s: 27/29/31

Summary**1.2.5 Auto-stabilization**

Test condition	fault L-N, L-L-L 1.00 ϵ CT error changeover ϵ 10.00 0.50 % ϵ CT error A ϵ 50 % 0.50 % ϵ CT error B ϵ 50 %
Test values:	CT error changeover = 1 CT error A = 0.5 %, 5 %, 15 % Charging-Current compensation CT error B = 0.5 %, 5 %, 15 %
Permissive tolerance/Limiting values:	funct. acc. to manual
Test results/Remarks:	function correct

1.2.6 Transformer inside protection range

Test condition	fault L-N, L-L-L , $f_{rated} = 50$ Hz, 60 Hz
Test values:	Voltage vector group Current vector group Residual current elimination
Permissive tolerance/Limiting values:	funct. acc. to manual
Test results/Remarks:	function correct

1.2.7 Charging-Current compensation

Test condition	fault L-N, $f_{rated} = 50$ Hz, 60 Hz 1 ϵ Ic-stabilization / Ic-rated ϵ 4 0.1 km ϵ Total line length ϵ 1000 km
Test values:	1 ϵ Ic-stabilization / Ic-rated ϵ 4 0.1 km ϵ Total line length ϵ 1000 km
Permissive tolerance/Limiting values:	funct. acc. to manual
Test results/Remarks:	function correct

Summary

1.3 Stub Protection

1.3.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.3.2 Tripping threshold S-DIFF stage

1.3.2.1 Threshold values

Test condition: fault L-N , $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 $0.100 I_{rated} \leq I_{ph} < 20.000 I_{rated}$

Test values: $0.100 \text{ A} \leq I_{ph} < 04.000 \text{ A}$ for $I_{rated} = 1 \text{ A}$
 $0.500 \text{ A} \leq I_{ph} < 04.000 \text{ A}$ for $I_{rated} = 5 \text{ A}$

Permissive tolerance/Limiting values: deviation d of set point value
 $|d| \leq 5 \%$ of setting value or $\leq 1 \%$ of I_{rated}

Test results/Remarks: $|d| < 5 \%$ or $< 1 \%$ of I_{rated}

1.3.2.2 Operating times

Test condition: fault L-N , $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}, I_{rated} = 1 \text{ A}$

Test values: $I_{fault} = 1 \text{ A}, I_{ph} = 0.300 \text{ A}$
t in ms

Permissive tolerance/Limiting values: appr. 29 ms + OOT at $f_{rated} = 50 \text{ Hz}$
appr. 26 ms + OOT at $f_{rated} = 60 \text{ Hz}$

Test results/Remarks: $t_{min} \geq 26 \text{ ms} + \text{OOT}, t_{typ} \geq 28 \text{ ms} + \text{OOT}$ at $f_{rated} = 50 \text{ Hz}$
 $t_{min} \geq 23 \text{ ms} + \text{OOT}, t_{typ} \geq 25 \text{ ms} + \text{OOT}$ at $f_{rated} = 60 \text{ Hz}$

1.3.2.3 Dropout times

Test condition: see item 1.3.2.2

Test values: see item 1.3.2.2

Permissive tolerance/Limiting values: 34 ms to 50 ms

Test results/Remarks: 34 ms $\leq t \leq$ 49 ms

1.3.2.4 Delay times

Test condition: 0.00 s $\leq T \leq$ 60.00 s

Test values: 0.00 s $\leq T \leq$ 60.00 s

Permissive tolerance/Limiting values: $|d| \leq 1 \%$ of setting value or $\leq 10 \text{ ms}$

Test results/Remarks: $|d| < 1 \%$ or $< 10 \text{ ms}$

1.3.3 Tripping threshold S-DIFF fast stage

1.3.3.1 Threshold values

Test condition: fault L-N , $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 $0.800 I_{rated} \leq I_{ph} < 100.000 I_{rated}$

Test values: $0.800 \text{ A} \leq I_{ph} < 09.000 \text{ A}$ for $I_{rated} = 1 \text{ A}$
 $4.000 \text{ A} \leq I_{ph} < 10.000 \text{ A}$ for $I_{rated} = 5 \text{ A}$

Permissive tolerance/Limiting values: deviation d of set point value
 $|d| \leq 5 \%$ of setting value or $\leq 1 \%$ of I_{rated}

Test results/Remarks: $|d| < 5 \%$ or $< 1 \%$ of I_{rated}

Summary

1.3.3.2 Tripping times

Test condition: fault L-N , $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}, I_{rated} = 1 \text{ A}$
 Test values: $I_{ph>} = 1.000 \text{ A}$
 t in ms
 Permissive tolerance/Limiting values: appr. 12 ms + OOT
 Test results/Remarks: $t_{min} 8 \text{ ms} + \text{OOT}, t_{typ} 11 \text{ ms} + \text{OOT}$

1.3.3.3 Dropout times

Test condition: see item 1.3.3.2
 Test values: see item 1.3.3.2
 Permissive tolerance/Limiting values: 34 ms to 50 ms
 Test results/Remarks: 34 ms £ t £ 49 ms

1.3.4 Tripping threshold S-DIFF fast 2 stage

1.3.4.1 Threshold values

Test condition: fault L-N , $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}$
 $0.800 I_{rated} \text{ £ } I_{ph>} \text{ £ } 100.000 I_{rated}$
 Test values: $0.800 \text{ A} \text{ £ } I_{ph>} \text{ £ } 09.000 \text{ A for } I_{rated} = 1 \text{ A}$
 $4.000 \text{ A} \text{ £ } I_{ph>} \text{ £ } 10.000 \text{ A for } I_{rated} = 5 \text{ A}$
 Permissive tolerance/Limiting values: deviation d of set point value
 $|d| \text{ £ } 5 \% \text{ of setting value or } \text{ £ } 1 \% \text{ of } I_{rated}$
 Test results/Remarks: $|d| < 5 \% \text{ or } < 1 \% \text{ of } I_{rated}$

1.3.4.2 Tripping times

Test condition: fault L-N , $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}, I_{rated} = 1 \text{ A}$
 Test values: $I_{ph>} = 1.000 \text{ A}$
 t in ms
 Permissive tolerance/Limiting values: appr. 12 ms + OOT
 Test results/Remarks: $t_{min} 8 \text{ ms} + \text{OOT}, t_{typ} 11 \text{ ms} + \text{OOT}$

1.3.4.3 Dropout times

Test condition: see item 1.3.3.2
 Test values: see item 1.3.3.2
 Permissive tolerance/Limiting values: 34 ms to 50 ms
 Test results/Remarks: 34 ms £ t £ 49 ms

Summary

1.4 21 Distance Protection Reactance Method

1.4.1 Specifications

- VDE 0435
- IEC/EN 60255-1, Item 7, Annex A, B

1.4.2 Minimum current threshold

1.4.2.1 Phase current threshold

Test condition:	fault L-N, $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}$ $0.03 I_{rated} \leq I_{ph} \leq 4.00 I_{rated}$
Test values:	$0.10 I_{rated} \leq I_{ph} \leq 4.00 I_{rated}$
Permissive tolerance/Limiting values:	$ d \leq 5\%$ of setting value
Test results/Remarks:	$ d \leq 0.5\%$

1.4.2.2 Earth current threshold

Test condition:	fault L-N, $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}$ $0.03 I_{rated} \leq I_{ph} \leq 4.00 I_{rated}$
Test values:	$0.10 I_{rated} \leq I_{ph} \leq 4.00 I_{rated}$
Permissive tolerance/Limiting values:	$ d \leq 5\%$ of setting value
Test results/Remarks:	$ d \leq 0.5\%$

1.4.3 Pickup values phase-fault-detection

1.4.3.1 Current

Test condition:	fault L-L, $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}$ $0.03 I_{rated} \leq I_{ph} \leq 35.00 I_{rated}$
Test values:	$1.00 I_{rated} \leq I_{ph} \leq 4.00 I_{rated}$
Permissive tolerance/Limiting values:	$ d \leq 5\%$ of setting value
Test results/Remarks:	$ d \leq 0.5\%$

1.4.3.2 Voltage

Test condition:	fault L-L, $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}$ $0.500 \text{ V} \leq V_{ph-gnd} \leq 70.00 \text{ V}$ $1.000 \text{ V} \leq V_{ph-ph} \leq 130.0 \text{ V}$
Test values:	$5.00 \text{ V} \leq V_{ph-gnd} \leq 50.00 \text{ V}$ $8.00 \text{ V} \leq V_{ph-ph} \leq 80.0 \text{ V}$
Permissive tolerance/Limiting values:	$ d \leq 5\%$ of setting value
Test results/Remarks:	$ d < 0.5\%$

1.4.4 Pickup values ground-fault detection

1.4.4.1 Residual (ground) current

Test condition:	- $3I_0, 3V_0$ calculated - $3I_0, 3V_0$ measured fault L-N, $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}$ $0.030 I_{rated} \leq 3I_0 > \leq 35.00 I_{rated}$
Test values:	$3I_0 > = (0.1, 4, 10) I_{rated}$
Permissive tolerance/Limiting values:	$ d \leq 5\%$ of setting value
Test results/Remarks:	$ d \leq 0.5\%$

1.4.4.2 Displacement voltage

Test condition:	- $3I_0, 3V_0$ calculated - $3I_0, 3V_0$ measured fault L-N, $f_{rated}= 50 \text{ Hz}, 60 \text{ Hz}$ $0.300 \text{ V} \leq V_0 > \leq 35.000 \text{ V}$
Test values:	$V_0 > /3V_0 = 0.3 \text{ V to } 35 \text{ V}$
Permissive tolerance/Limiting values:	$ d \leq 5\%$ of setting value
Test results/Remarks:	$ d \leq 0.5\%$

Summary

1.4.5 Loop selection for double faults

Test condition: - grounded systems
 Permissive tolerance/Limiting values: function according to manual
 Test results/Remarks: function correct

1.4.6 Distance measurement

1.4.6.1 Balance-points for polygonal characteristic

Test condition: parameters:
 - Line Angle = 60°, DeltaDistAngle = α
 - Zone Z1: X1 = R1E = 2R1 = 2.5 W, $\alpha(Z1) = 30^\circ$
 - Zone Z2: X2 = 0.5 R2E = R2 = 5.0 W, $\alpha(Z2) = 20^\circ$
 - Zone Z3: X3 = R3E = R3 = 10.0 W, $\alpha(Z3) = 10^\circ$
 - Zone Z4: X4 = R4E = R4 = 12.0 W, $\alpha(Z4) = 15^\circ$
 Test values: I = 1.5 I_{rated}, Fault L-N,L-L,L-L-L ; Angle $\varphi(V,I)$ in range 0...360° with steps of 5°
 Permissive tolerance/Limiting values: X: |d| £ 5 % of setting value for 30° £ PHI(V,I) £ 90°
 R: |d| £ 5 % of setting value for 0° £ PHI(V,I) £ 60°
 Test results/Remarks: X, R:
 - Zone Z1: |d| £ 3 %
 - Zone Z2: |d| £ 3 %
 - Zone Z3: |d| £ 3 %
 - Zone Z4: |d| £ 3 %

1.4.6.2 Balance-points for MHO characteristic

Test condition: parameters:
 - Zone Z1: Z1 = 2.5 W
 - Zone Z2: Z2 = 5.0 W
 - Zone Z3: Z3 = 10.0 W
 - Zone Z4: Z4 = 12.0 W
 Test values: I = 1.5 I_{rated}, fault L-L,L-L-L-L ; Angle $\varphi(U,I)$ in range 0...360° with steps of 5°
 Test results/Remarks: Zone Z1: |d| £ 3 %
 Zone Z2: |d| £ 3 %
 Zone Z3: |d| £ 3 %
 Zone Z4: |d| £ 3 %

1.4.7 Directional measurement

Test condition: fault L-N,L-L,L-L-L,
 Permissive tolerance/Limiting values: function according to manual
 Test results/Remarks: function correct

1.4.8 Time stages of distance zones

1.4.8.1 Shortest trip

Test condition: fault L-N,L-L,L-L-L
 fault angle 90°
 SIR 1
 Permissive tolerance/Limiting values: - f_{rated} = 50 Hz: t_{op,min} approx. 17/12 ms (fast relay/high speed relay)
 - f_{rated} = 60 Hz: t_{op,min} approx. 15/10 ms (fast relay/high speed relay)
 Test results/Remarks: - f_{rated} = 50 Hz: t_{op,min} approx. 13.8 ms (fast relay)
 - f_{rated} = 60 Hz: t_{op,min} approx. 13.5 ms (fast relay)

1.4.8.2 Dropout times

Test condition: fault L-N,L-L,L-L-L
 Permissive tolerance/Limiting values: t approx. 30 ms
 Test results/Remarks: t approx. 20 ms

1.4.8.3 Tolerances of time stages

Test condition: time stages:
 T1_{1pol}; T2_{1pol}; T3_{1pol}; T4_{1pol}
 T1_{>1pol}; T2_{>1pol}; T3_{>1pol}; T4_{>1pol}
 Test values: 0.00 s £ T £ 60.00 s; ¥

Summary

Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 0.5 % or 5 ms
1.4.8.4 Zone directions	
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct
1.4.9 Dynamical performance	
1.4.9.1 Influence of SIR and Xk	
Test condition:	Zone 1 Angle $\phi_{line} = 85^\circ$ TAU _{source} = 100 ms $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ Tests for polygonal and MHO characteristics
Test values:	- Fault L-N,L-L,L-L-L - Phase angle $\phi(k)$ of fault at switching-on point varied in range of 0° to 90° in steps of 30° ; without loaded current - 4 test angles for each SIR value - all test for each kind of fault - $XI = 10 \text{ W}$
1.4.9.2 Operate times	
Test condition:	- Fault L-N: 0.5 £ SIR £ 60 , in 17 Steps - Fault L-L: 1 £ SIR £ 100 , in 18 Steps - Fault L-L-L: 1 £ SIR £ 120 , in 20 Steps
Test values:	- $Xk/XI = 0.0$ to 1.1 , Steps £ 0.05 with 5 repetitions at times of identical shots
Test results/Remarks:	Charts and tables with constant operate times available on request for L-N/L-L/L-L-L: SIR £ 50/90/80: $f_{rated} = 50 \text{ Hz}$: 0.00 £ Xk/XI £ 0.35 13.8 ms £ t_{op} £ 18.9 ms (fast relay) 0.40 £ Xk/XI £ 0.65 16.4 ms £ t_{op} £ 20.7 ms (fast relay) 0.75 £ Xk/XI £ 0.95 18.2 ms £ t_{op} £ 35.6 ms (fast relay) 1.01 £ Xk/XI £ 1.10 $t_{op} = T2$; Overreach < 1 % (fast relay) $f_{rated} = 60 \text{ Hz}$: 0.00 £ Xk/XI £ 0.35 13.5 ms £ t_{op} £ 18.5 ms (fast relay) 0.40 £ Xk/XI £ 0.65 15.9 ms £ t_{op} £ 19.5 ms (fast relay) 0.75 £ Xk/XI £ 0.95 17.0 ms £ t_{op} £ 32.2 ms (fast relay) 1.01 £ Xk/XI £ 1.10 $t_{op} = T2$; Overreach < 1 % (fast relay)
1.4.10 Processing of functions	
1.4.10.1 Residual compensation	
Test condition:	Configurable separately for each zone: -0.33 £ Kr £ +11.00 and -0.33 £ Kx £ +11.00 or 0.000 £ K0 £ +11.000 and -180.00° £ PHI(K0) £ +180.00°
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct
1.4.10.2 Emergency operation	
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct

Summary

1.5 21 Distance Protection

1.5.1 Specifications

- VDE 0435
- IEC/EN 60255-1, Item 7, Annex A, B
- IEC60255-121

1.5.2 Pickup values phase-fault-detection

1.5.2.1 Current

Test condition: 0.030 I_{rated} £ I_{ph} £ 35 I_{rated}
 Test values: 0.05 I_{rated} £ I_{ph} £ 10.00 I_{rated}
 Permissive tolerance/Limiting values: |d| £ 5 % of setting value
 Test results/Remarks: |d| £ 1.0 % or 1 % I_{rated}

1.5.2.2 Voltage

Test condition: 0.500 V £ V_{ph-gnd} £ 70.00 V
 1.000 V £ V_{ph-ph} £ 130.0 V
 Test values: 5.00 V £ V_{ph-gnd} £ 50.00 V
 8.00 V £ V_{ph-ph} £ 80.0 V
 Permissive tolerance/Limiting values: |d| £ 5 % of setting value
 Test results/Remarks: |d| < 5 % or 0.5 V

1.5.3 Dropout ratio

Test condition: see item 1.5.2
 Test values: see item 1.5.2
 Permissive tolerance/Limiting values: r approx. 0.95
 Test results/Remarks: r approx. 0.95

1.5.4 Pickup values ground-fault detection

Test condition: - 3I₀,3V₀ calculated
 - 3I₀,3V₀ measured
 Test values: fault L-N, f_{rated}= 50 Hz, 60 Hz

Residual (ground) current:

Test condition: 0.030 I_{rated} £ 3I₀> £ 10.00 I_{rated}
 Test values: 3I₀> = (0.05 , 0.1 , 0.5 , 1 , 10) I_{rated}
 Permissive tolerance/Limiting values: |d| £ 5 % of setting value
 Test results/Remarks: |d| £ 1.0 % or 1 % I_{rated}

Displacement voltage

Test condition: 0.300 V £ V₀> £ 35.000 V
 Test values: V₀> /3V₀ = 0.3 V to 35 V
 Permissive tolerance/Limiting values: |d| £ 5 % of setting value
 Test results/Remarks: |d| £ 1.0 % or 0.1 % V_{rated}

1.5.5 Loop selection for double faults

Test condition: - grounded systems
 - isolated systems
 - resonant-grounded
 Permissive tolerance/Limiting values: function according to manual
 Test results/Remarks: function correct

Summary

1.5.6 Distance measurement

1.5.6.1 Balance-points for polygonal characteristic

Test condition: parameters:
 - Zone Z1: $X1 = R1E = 2R1 = 2.5 W$, $\alpha(Z1) = 30^\circ$
 - Zone Z2: $X2 = 0.5 R2E = R2 = 5.0 W$, $\alpha(Z2) = 20^\circ$
 - Zone Z3: $X3 = R3E = R3 = 10.0 W$, $\alpha(Z3) = n/a$
 - Zone Z4: $X4 = R4E = R4 = 12.0 W$, $\alpha(Z4) = 15^\circ$

Test values: $I = 1.5 I_{rated}$; Fault L-N,L-L,L-L-L ; Angle $\varphi(V,I)$ in range $0 \dots 360^\circ$ with steps of 5°

Permissible tolerance/Limiting values: X: $|d| \leq 5\%$ of setting value for $30^\circ \leq \text{PHI}(V,I) \leq 90^\circ$
 R: $|d| \leq 5\%$ of setting value for $0^\circ \leq \text{PHI}(V,I) \leq 60^\circ$

Test results/Remarks: X, R:
 - Zone Z1: $|d| \leq 3\%$
 - Zone Z2: $|d| \leq 3\%$
 - Zone Z3: $|d| \leq 3\%$
 - Zone Z4: $|d| \leq 3\%$

1.5.6.2 Balance-points for MHO characteristic

Test condition: parameters:
 - Zone Z1: $Z1 = 2.5 W$
 - Zone Z2: $Z2 = 5.0 W$
 - Zone Z3: $Z3 = 10.0 W$
 - Zone Z4: $Z4 = 12.0 W$

Test values: $I = 1.5 I_{rated}$; fault L-N,L-L,L-L-L ; Angle $\varphi(U,I)$ in range $0 \dots 360^\circ$ with steps of 5°

Test results/Remarks: Zone Z1: $|d| \leq 3\%$
 Zone Z2: $|d| \leq 3\%$
 Zone Z3: $|d| \leq 3\%$
 Zone Z4: $|d| \leq 3\%$

1.5.6.3 Balance-points for circular characteristic

Test condition: parameters:
 - Zone Z1: $Z1 = 2.5 W$
 - Zone Z2: $Z2 = 5.0 W$
 - Zone Z3: $Z3 = 10.0 W$
 - Zone Z4: $Z4 = 12.0 W$

Test values: $I = 1.5 I_{rated}$; fault L-N,L-L,L-L-L ; Angle $\varphi(U,I)$ in range $0 \dots 360^\circ$ with steps of 5°

Permissible tolerance/Limiting values: X: $|d| \leq 5\%$ of setting value for $30^\circ \leq \text{PHI}(V,I) \leq 90^\circ$
 R: $|d| \leq 5\%$ of setting value for $0^\circ \leq \text{PHI}(V,I) \leq 60^\circ$

Test results/Remarks: Zone Z1: $|d| \leq 3\%$
 Zone Z2: $|d| \leq 3\%$
 Zone Z3: $|d| \leq 3\%$
 Zone Z4: $|d| \leq 3\%$

1.5.7 Directional measurement

Test condition: fault L-N,L-L,L-L-L,
 Permissible tolerance/Limiting values: function according to manual
 Test results/Remarks: function correct

1.5.8 Time stages of distance zones

1.5.8.1 Shortest trip time Z-Pickup

Test condition: fault L-N,L-L,L-L-L
 fault angle 90°
 SIR 1

Permissible tolerance/Limiting values: - $f_{rated} = 50 \text{ Hz}$: $t_{min} = 17/12 \text{ ms}$ (fast relay/high speed relay)
 - $f_{rated} = 60 \text{ Hz}$: $t_{min} = 15/10 \text{ ms}$ (fast relay/high speed relay)

Test results/Remarks: - $f_{rated} = 50 \text{ Hz}$: $t_{min} = 14 \text{ ms}$ (fast relay)
 - $f_{rated} = 60 \text{ Hz}$: $t_{min} = 13 \text{ ms}$ (fast relay)

1.5.8.2 Shortest trip time I-Pickup

Test condition: fault L-N,L-L,L-L-L
 fault angle 90°
 SIR 1

Summary

Permissive tolerance/Limiting values:	- $f_{rated} = 50 \text{ Hz}$: $t_{min} 17/12 \text{ ms}$ (fast relay/high speed relay) - $f_{rated} = 60 \text{ Hz}$: $t_{min} 15/10 \text{ ms}$ (fast relay/high speed relay)
Test results/Remarks:	- $f_{rated} = 50 \text{ Hz}$: $t_{min} 13 \text{ ms}$ (fast relay) - $f_{rated} = 60 \text{ Hz}$: $t_{min} 12 \text{ ms}$ (fast relay)
1.5.8.3 Shortest trip time V/I-Pickup	
Test condition:	fault L-N,L-L,L-L-L fault angle 90° SIR 1
Permissive tolerance/Limiting values:	- $f_{rated} = 50 \text{ Hz}$: $t_{min} 17/12 \text{ ms}$ (fast relay/high speed relay) - $f_{rated} = 60 \text{ Hz}$: $t_{min} 15/10 \text{ ms}$ (fast relay/high speed relay)
Test results/Remarks:	- $f_{rated} = 50 \text{ Hz}$: $t_{min} 14 \text{ ms}$ (fast relay) - $f_{rated} = 60 \text{ Hz}$: $t_{min} 13 \text{ ms}$ (fast relay)
1.5.8.4 Shortest trip time V/I/φ -Pickup	
Test condition:	fault L-N,L-L,L-L-L fault angle 90° SIR 1
Permissive tolerance/Limiting values:	- $f_{rated} = 50 \text{ Hz}$: $t_{min} 17/12 \text{ ms}$ (fast relay/high speed relay) - $f_{rated} = 60 \text{ Hz}$: $t_{min} 15/10 \text{ ms}$ (fast relay/high speed relay)
Test results/Remarks:	- $f_{rated} = 50 \text{ Hz}$: $t_{min} 13 \text{ ms}$ (fast relay) - $f_{rated} = 60 \text{ Hz}$: $t_{min} 12 \text{ ms}$ (fast relay)
1.5.8.5 Dropout times	
Test condition:	fault L-N,L-L,L-L-L
Test results/Remarks:	$t_{avg} = 30 \text{ ms}$
1.5.8.6 Tolerances of time stages	
Test condition:	time stages: $T1_{1pol}$; $T2_{1pol}$; $T3_{1pol}$; $T4_{1pol}$ $T1_{>1pol}$; $T2_{>1pol}$; $T3_{>1pol}$; $T4_{>1pol}$
Test values:	$0.00 \text{ s} \leq T \leq 60.00 \text{ s}$; \neq
Permissive tolerance/Limiting values:	$ d \leq 1 \%$ of setting value or 10 ms
Test results/Remarks:	$ d \leq 1 \%$ or 10 ms
1.5.8.7 Zone directions	
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct
1.5.9 Dynamical performance	
1.5.9.1 Influence of SIR and Xk	
Test condition:	Zone 1 Angle $\varphi_{line} = 85^\circ$ $TA_{source} = 100 \text{ ms}$ $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ Tests for polygonal characteristics, MHO and circular characteristics
Test values:	- Fault L-N,L-L,L-L-L - Phase angle $\varphi(k)$ of fault at switching-on point varied in range of 0° to 90° in steps of 30° ; without loaded current - 4 test angles for each SIR value - all test for each kind of fault - $XI = 10 \text{ W}$

Summary

1.5.9.2 Operate times

Test condition:	- Fault L-N: 0.5 £ SIR £ 60 , in 17 Steps
	- Fault L-L: 1 £ SIR £ 100 , in 18 Steps
	- Fault L-L-L: 1 £ SIR £ 120 , in 20 Steps
Test values:	- Xk/XI = 0.0 to 1.1, Steps £ 0.05 with 5 repetitions at times of identical shots
Test results/Remarks:	Charts and tables with constant operate times available on request for L-N/L-L/L-L-L: SIR £ 50/90/80:
	$f_{rated} = 50 \text{ Hz}$:
	0.00 £ Xk/XI £ 0.35 14 ms £ t £ 24 ms (fast relay)
	0.40 £ Xk/XI £ 0.65 17 ms £ t £ 24 ms (fast relay)
	0.75 £ Xk/XI £ 0.95 27 ms £ t £ 38 ms (fast relay)
	1.01 £ Xk/XI £ 1.10 t = T2 ; Overreach < 1 % (fast relay)
	$f_{rated} = 60 \text{ Hz}$:
	0.00 £ Xk/XI £ 0.35 13 ms £ t £ 24 ms (fast relay)
	0.40 £ Xk/XI £ 0.65 16 ms £ t £ 24 ms (fast relay)
	0.75 £ Xk/XI £ 0.95 27 ms £ t £ 38 ms (fast relay)
	1.01 £ Xk/XI £ 1.10 t = T2 ; Overreach < 1 % (fast relay)

1.5.10 Processing of functions

1.5.10.1 Residual compensation

Test condition:	Configurable separately for each zone: -0.33 £ Kr £ +11.00 and -0.33 £ Kx £ +11.00 or 0.000 £ K0 £ +11.000 and -180.00° £ PHI(K0) £ +180.00°
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct

1.5.10.2 Emergency operation

Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct

Summary**1.6 68 Power Swing Blocking****1.6.1 Power swing detection****1.6.1.1 With Z< fault detection (Polygon)**

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.6.1.2 With MHO characteristic

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.6.2 Power swing programs**1.6.2.1 Block all zones**

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.6.2.2 Block polygone zone

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.6.2.3 Block MHO zone

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

Summary

1.7 Fault Locator

1.7.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.7.2 Distance-to-fault measuring (FOR)

Test condition:	Measuring tolerances for sinusoidal values and fault duration > 25 ms
Permissive tolerance/Limiting values:	± 2.0 % of fault location (without intermediate infeed)
Test results/Remarks:	< 2.0 %

1.7.3 Start-to-measure command

Test condition:	- by trip signal - by drop-off of pickup
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct

Summary

1.8 85-21 Teleprotection With Distance Protection

1.8.1 Permissive underreach transfer trip schemes (PUTT schemes, conventional)

1.8.1.1 PUTT with zone Z1B

Test condition:	2 - 6 line ends
Test values:	2 and 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.1.2 PUTT with pickup

Test condition:	2 - 6 line ends
Test values:	2 and 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.2 Permissive overreach transfer trip schemes (POTT schemes, conventional)

1.8.2.1 POTT with zone Z1B

Test condition:	2 - 6 line ends
Test values:	2 and 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.2.2 Directional comparison

Test condition:	2 - 6 line ends
Test values:	2 and 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.2.3 Z1B unblock

Test condition:	2 - 6 line ends
Test values:	2 and 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.2.4 Z1B blocking

Test condition:	2 - 6 line ends
Test values:	2 and 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.3 Echo function

Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.4 Transient blocking

Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.8.5 Reverse Interlocking

Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

Summary

1.9 67N Ground-Fault Protection for High-Resistance Ground Faults in Grounded Systems

1.9.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC60255-151

1.9.2 Definite time overcurrent stages (3I0-definite time)

1.9.2.1 Pickup values

Test condition:	3I0 calculated, 3I0 measured
	0.030 A £ 3I0 £ 100.000 A for 3I0 ($I_{N-rated} = 1 A$)
	0.150 A £ 3I0 £ 500.000 A for 3I0 ($I_{N-rated} = 5 A$)
	0.003 A £ 3I0 £ 100.000 A for 3I0 ($I_{Nsens-rated} = 1 A + I_{L-rated} = 1 A$)
	0.003 A £ 3I0 £ 500.000 A for 3I0 ($I_{Nsens-rated} = 1 A + I_{L-rated} = 5 A$)
	0.015 A £ 3I0 £ 100.000 A for 3I0 ($I_{Nsens-rated} = 5 A + I_{L-rated} = 1 A$)
	0.015 A £ 3I0 £ 500.000 A for 3I0 ($I_{Nsens-rated} = 5 A + I_{L-rated} = 5 A$)

Permissive tolerance/Limiting values: a) |d| £ 1 % of setting value or 1 % I_{rated} for I-prot.
b) |d| £ 1 % of setting value or 0.5 % I_{rated} for I-sens.

Test results/Remarks: a) |d| £ 1 % or 1 % I_{rated}
b) |d| £ 1 % or 0.5 % I_{rated}

1.9.2.2 Dropout ratio

Test condition: see item 1.9.2.1
Permissive tolerance/Limiting values: r approx. 0.95 threshold
Test results/Remarks: r approx. 0.95 threshold

1.9.2.3 Pickup times

Test condition: see item 1.9.2.1
Permissive tolerance/Limiting values: a) fundam. comp. over 1 cycle filter: approx. 25 ms + OOT
b) fundam. comp. over 2 cycle filter: approx. 30 ms + OOT
c) extension of pickup time with power transformer inrush-current detection: approx. 10 ms
Test results/Remarks: a) approx. 25 ms + OOT
b) approx. 25 ms + OOT
c) approx. 10 ms

1.9.2.4 Dropout times

Test condition: see item 1.9.2.1
Permissive tolerance/Limiting values: a) fundam. comp. over 1 cycle filter: approx. 20 ms + OOT
b) fundam. comp. over 2 cycle filter: approx. 40 ms + OOT
Test results/Remarks: a) approx. 30 ms + OOT
b) approx. 40 ms + OOT

1.9.2.5 Time delays

Test condition: added to the inherent operating times
Test values: 0.000 s £ T £ 60.000 s
Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
Test results/Remarks: |d| < 1 % of setting value or 10 ms

1.9.2.6 Direction of directional stage

Permissive tolerance/Limiting values: function according to manual
Test results/Remarks: function correct

1.9.3 Overcurrent Protection, 3I0 Inverse time overcurrent stage (inverse time)

1.9.3.1 Pickup

Test condition: see item 1.9.2.1
Permissive tolerance/Limiting values: a) |d| £ 1 % of setting value or 1 % I_{rated} for I-prot.
b) |d| £ 1 % of setting value or 0.5 % I_{rated} for I-sens.

Summary

Test results/Remarks:	a) $ d \leq 1\% \text{ or } 1\% I_{rated}$ b) $ d \leq 1\% \text{ or } 0.5\% I_{rated}$
1.9.3.2 Dropout ratio	
Test condition:	see item 1.9.2.1
Permissive tolerance/Limiting values:	a) disk emulation b) instantaneous
Test results/Remarks:	confirmed
1.9.3.3 Pickup times	
Test condition:	see item 1.9.2.1
Test values:	pickup time for $2 \leq I/I\text{-threshold value} \leq 20$
Permissive tolerance/Limiting values:	5 % of set point value or +2 % current tolerance or 30 ms
Test results/Remarks:	confirmed
1.9.3.4 Dropout times - instantaneous	
Test condition:	see item 1.9.2.1
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT
1.9.3.5 Dropout times – disk emulation	
Test condition:	see item 1.9.2.1
Test values:	dropout time for $I/I\text{-threshold value} \leq 0.90$
Permissive tolerance/Limiting values:	5 % of set point value or +2 % current tolerance or 30 ms
Test results/Remarks:	confirmed
1.9.3.6 Tripping time characteristics	
Test values:	tripping times t
Permissive tolerance/Limiting values:	$ d \leq 5\% \pm 15 \text{ ms for } 2 \leq I/I_P \leq 20$ $ d \leq 5\% \pm 15 \text{ ms for } 2 \leq 3I0/I_P \leq 20$
1.9.3.6.1 IEC normal inverse (type A)	
Test results/Remarks:	confirmed
1.9.3.6.2 IEC very inverse (type B)	
Test results/Remarks:	confirmed
1.9.3.6.3 IEC extremely inverse (type C)	
Test results/Remarks:	confirmed
1.9.3.6.4 IEC long-time inverse	
Test results/Remarks:	confirmed
1.9.3.6.5 ANSI long-time inverse	
Test results/Remarks:	confirmed
1.9.3.6.6 ANSI short-time inverse	
Test results/Remarks:	confirmed
1.9.3.6.7 ANSI extremely inverse (type C)	
Test results/Remarks:	confirmed
1.9.3.6.8 ANSI very inverse	
Test results/Remarks:	confirmed
1.9.3.6.9 ANSI normal inverse	
Test results/Remarks:	confirmed
1.9.3.6.10 ANSI moderately inverse	
Test results/Remarks:	confirmed

Summary

1.9.3.6.11 ANSI definite inverse

Test results/Remarks: confirmed

1.9.3.7 Dropout characteristics

Test values: dropout times

Permissive tolerance/Limiting values: |d| £ 5 % ± 30 ms for 0.05 £ I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I₀/I_P £ 0.90

1.9.3.7.1 IEC normal inverse (type A)

Test results/Remarks: confirmed

1.9.3.7.2 IEC very inverse (type B)

Test results/Remarks: confirmed

1.9.3.7.3 IEC extremely inverse (type C)

Test results/Remarks: confirmed

1.9.3.7.4 IEC long-time inverse

Test results/Remarks: confirmed

1.9.3.7.5 ANSI long-time inverse

Test results/Remarks: confirmed

1.9.3.7.6 ANSI short-time inverse

Test results/Remarks: confirmed

1.9.3.7.7 ANSI extremely inverse (type C)

Test results/Remarks: confirmed

1.9.3.7.8 ANSI very inverse

Test results/Remarks: confirmed

1.9.3.7.9 ANSI normal inverse

Test results/Remarks: confirmed

1.9.3.7.10 ANSI moderately inverse

Test results/Remarks: confirmed

1.9.3.7.11 ANSI definite inverse

Test results/Remarks: confirmed

1.9.3.8 Direction of directional stage

Permissive tolerance/Limiting values: function according to manual

Test results/Remarks: function correct

1.9.4 3I0 logarithmic inverse

1.9.4.1 Pickup

Test condition: threshold: see item 1.9.2.1
threshold-value multiplier: 1.00 £ tm £ 4.00
time dial: 0.05 s £ Td £ 15.00 s

Permissive tolerance/Limiting values: a) |d| £ 1 % of setting value or 1 % I_{rated} for I-prot.
b) |d| £ 1 % of setting value or 0.5 % I_{rated} for I-sens.

Test results/Remarks: a) |d| £ 1 % or 1 % I_{rated}
b) |d| £ 1 % or 0.5 % I_{rated}

1.9.4.2 Dropout ratio

Permissive tolerance/Limiting values: a) disk emulation
b) instantaneous

Test results/Remarks: confirmed

1.9.4.3 Pickup times

Test values: pickup time for 2 ≤ I/I-threshold value ≤ 20

Permissive tolerance/Limiting values: 5 % of set point value or
+2 % current tolerance or
30 ms

Summary

Test results/Remarks:	confirmed
1.9.4.4 Dropout times	
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT
1.9.4.5 Tripping time characteristics	
Test values:	tripping times t
Permissive tolerance/Limiting values:	d £ 3 % ± 10 ms
Test results/Remarks:	confirmed
1.9.4.6 Dropout characteristics	
Test values:	dropout times
Permissive tolerance/Limiting values:	d £ 5 % ± 30 ms for 0.05 £ I/I _P £ 0.90 d £ 5 % ± 30 ms for 0.05 £ 3I0/I _P £ 0.90
Test results/Remarks:	confirmed
1.9.4.7 Direction of directional stage	
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct
1.9.5 3I0 S_r inverse	
1.9.5.1 Pickup	
Test condition:	threshold: see item 1.9.2.1 threshold-value multiplier: 1.00 £ tm £ 4.00 ref. for S _r -characteristic: 1.00 VA £ S _{ref} £ 100.00 VA for I _{rated} = 1 A 5.00 VA £ S _{ref} £ 500.00 VA for I _{rated} = 5 A
Permissive tolerance/Limiting values:	a) d £ 1 % of setting value or 1 % I _{rated} for I-prot. b) d £ 1 % of setting value or 0.5 % I _{rated} for I-sens.
Test results/Remarks:	a) d £ 1 % or 1 % I _{rated} b) d £ 1 % or 0.5 % I _{rated}
1.9.5.2 Dropout ratio	
Permissive tolerance/Limiting values:	a) disk emulation b) instantaneous
Test results/Remarks:	confirmed
1.9.5.3 Pickup times	
Test values:	pickup time for 2 ≤ I/I-threshold value ≤ 20
Permissive tolerance/Limiting values:	5 % of set point value or +2 % current tolerance or 30 ms
Test results/Remarks:	confirmed
1.9.5.4 Dropout times	
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT
1.9.5.5 Tripping time characteristics	
Test values:	tripping times t
Permissive tolerance/Limiting values:	d £ 3 % ± 10 ms
Test results/Remarks:	confirmed
1.9.5.6 Dropout characteristics	
Test values:	dropout times
Permissive tolerance/Limiting values:	d £ 5 % ± 30 ms for 0.05 £ I/I _P £ 0.90 d £ 5 % ± 30 ms for 0.05 £ 3I0/I _P £ 0.90

Summary

Test results/Remarks:	confirmed
1.9.5.7 Direction of directional stage	
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct
1.9.6 3I0 V₀ inverse	
1.9.6.1 Pickup	
Test condition:	a) 3I0 calculated Threshold: 0.030 A £ 3I0 £ 35.00 A for 3I0 (I _{N-rated} = 1 A) 0.150 A £ 3I0 £ 175.000 A for 3I0 (I _{N-rated} = 5 A)
	b) V ₀ calculated, V ₀ measured Threshold: 0.30 V £ V ₀ £ 200.000 V V ₀ min for V ₀ -characteristic: 0 V £ V ₀ min £ 200.00 V
Permissive tolerance/Limiting values:	a) d £ 1 % of setting value or 1 % I _{rated} for I-prot. b) d £ 1% of setting value or or 1 % V _{rated}
Test results/Remarks:	a) d £ 1 % or 1 % I _{rated} b) d £ 1 % or 0.5 % I _{rated}
1.9.6.2 Dropout ratio	
Permissive tolerance/Limiting values:	a) 0.95 threshold b) 0.95 threshold or (threshold – 150mV)
Test results/Remarks:	confirmed
1.9.6.3 Pickup times	
Test values:	see 1.9.6.1
Permissive tolerance/Limiting values:	5 % of set point value or +2 % current tolerance or 30 ms
Test results/Remarks:	confirmed
1.9.6.4 Dropout times	
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT
1.9.6.5 Tripping time characteristics	
Test values:	tripping times t
Permissive tolerance/Limiting values:	d £ 3 % ± 20 ms
Test results/Remarks:	confirmed
1.9.6.6 Dropout characteristics	
Test values:	dropout times
Permissive tolerance/Limiting values:	d £ 5 % ± 30 ms d £ 5 % ± 30 ms
Test results/Remarks:	confirmed
1.9.6.7 Direction of directional stage	
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct
1.9.7 Directional determination	
1.9.7.1 Release threshold of zero voltage V₀	
Test condition:	fault L-N 0.150 V £ V ₀ £ 34.000 V
Permissive tolerance/Limiting values:	d £ 1% of setting value or 1 V
Test results/Remarks:	confirmed

Summary

1.9.7.2 Release threshold of neutral point current IY

Test condition: fault L-N
0.030 A \leq IY \leq 10.000 A for $I_{rated} = 1$ A
0.150 A \leq IY \leq 50.000 A for $I_{rated} = 5$ A

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of setting value or $1\% I_{rated}$

Test results/Remarks: confirmed

1.9.7.3 Release threshold of negative sequence current I2

Test condition: fault L-N
0.030 A \leq I2 \leq 10.000 A for $I_{rated} = 1$ A
0.150 A \leq I2 \leq 50.000 A for $I_{rated} = 5$ A

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of setting value or $1\% I_{rated}$

Test results/Remarks: confirmed

1.9.7.4 Release threshold of negative sequence voltage V2

Test condition: fault L-N
0.150 V \leq V2 \leq 20.000 V

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of setting value or $1\% I_{rated}$

Test results/Remarks: confirmed

1.9.7.5 Release angle

Test condition: fault L-N
 $0^\circ \leq \alpha \leq 360^\circ$
 $0^\circ \leq \beta \leq 360^\circ$

Test values: directional limits, stationary

Permissive tolerance/Limiting values: $\alpha, \beta \pm 1.5^\circ$

Test results/Remarks: confirmed

1.9.8 Processing of functions

1.9.8.1 Phase selector

Permissive tolerance/Limiting values: function according to manual

Test results/Remarks: function correct

1.9.8.2 Blocking

Permissive tolerance/Limiting values: function according to manual

Test results/Remarks: function correct

1.9.8.3 Inrush restraint

Test condition: 10 % \leq 2.HARMON.BLOCK \leq 45 %
0.50 $I_{rated} \leq$ I-RUSH-MAX \leq 25.00 I_{rated}

Permissive tolerance/Limiting values: function according to manual

Test results/Remarks: function correct

1.9.8.4 Switch-onto-fault

Permissive tolerance/Limiting values: function according to manual

Test results/Remarks: function correct

Summary**1.10 85-67N Teleprotection with Ground Fault Protection****1.10.1 Directional comparison pickup**

Test condition:	2 - 6 line ends
Test values:	2 line ends 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.10.2 Directional comparison unblocking

Test condition:	2 - 6 line ends
Test values:	2 line ends 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.10.3 Directional comparison blocking

Test condition:	2 - 6 line ends
Test values:	2 line ends 3 line ends
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.10.4 Echo function

Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

1.10.5 Transient blocking

Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	Function correct

Summary

1.11 Impedance Protection

1.11.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.11.2 Pickup values

1.11.2.1 Current

Test condition:	0.030 I_{rated} £ Iph £ 35.000 I_{rated}
Test values:	0.05 I_{rated} £ Iph £ 10.00 I_{rated}
Permissive tolerance/Limiting values:	d £ 5 % of setting value
Test results/Remarks:	d £ 1.0 % or 1 % I_{rated}

1.11.2.2 Voltage

Test condition:	0.500 V £ Vph-gnd £ 70.00 V 1.000 V £ Vph-ph £ 130.0 V
Test values:	5.00 V £ Vph-gnd £ 50.00 V 8.00 V £ Vph-ph £ 80.0 V
Permissive tolerance/Limiting values:	d £ 5 % of setting value
Test results/Remarks:	d < 5 % or 0.5 V

1.11.3 Dropout ratio

Test condition:	0.030 I_{rated} £ Iph £ 35.000 I_{rated}
Test values:	0.05 I_{rated} £ Iph £ 10.00 I_{rated}
Permissive tolerance/Limiting values:	r approx. 0.95
Test results/Remarks:	r approx. 0.95

1.11.4 Distance measurement

1.11.4.1 Polygonal characteristic

Test condition:	parameters: - Zone Z1: X1 = 2.5 W - Zone Z2: X2 = 5.0 W - Zone Z3: X3 = 10.0 W - Zone Z4: X4 = 12.0 W
Test values:	I = 1.5 I_{rated} ; Fault L-N,L-L,L-L-L ; Angle $\varphi(V,I)$ in range 0...360° with steps of 5°
Permissive tolerance/Limiting values:	X: d £ 5 % of setting value for 30° £ PHI(V,I) £ 90° R: d £ 5 % of setting value for 0° £ PHI(V,I) £ 60°
Test results/Remarks:	X, R: - Zone Z1: d < 3 % - Zone Z2: d < 3 % - Zone Z3: d < 3 % - Zone Z4: d < 3 %

1.11.5 Directional measurement

Test condition:	fault L-N,L-L,L-L-L,
Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct

1.11.6 Time stages of distance zones

1.11.6.1 Pickup times

Test condition:	fault L-N,L-L,L-L-L fault angle 90° SIR 1 measured with fast relay
Permissive tolerance/Limiting values:	t_{min} approx. 40/35 ms (fast relay/high speed relay)
Test results/Remarks:	50 Hz 60 Hz t_{min} = 25.9 ms 21.8 ms

Summary

t_{average} =	32.3 ms	27.4 ms
t_{max} =	37.4 ms	30.5 ms

1.11.6.2 Dropout times

Test condition:	fault L-N,L-L,L-L-L
Permissive tolerance/Limiting values:	t approx. 20 ms
Test results/Remarks:	t_{min} = 13.6 ms t_{average} = 18.2 ms t_{max} = 23.4 ms

1.11.6.3 Tolerances of time stages

Test condition:	time stages: $T1_{1\text{pol}}$; $T2_{1\text{pol}}$; $T3_{1\text{pol}}$; $T4_{1\text{pol}}$ $T1_{>1\text{pol}}$; $T2_{>1\text{pol}}$; $T3_{>1\text{pol}}$; $T4_{>1\text{pol}}$
Test values:	0.00 s £ T £ 60.00 s; ¥
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d < 1 % or 10 ms

1.11.6.4 Zone directions

Permissive tolerance/Limiting values:	function according to manual
Test results/Remarks:	function correct

Summary**1.12 External Trip Initiation****1.12.1 Pickup times**

Test condition:	with initiation via binary input signal
Test values:	$f_{rated}=50$ Hz, 60 Hz
Permissive tolerance/Limiting values:	t approx. 5 ms + OOT
Test results/Remarks:	t < 5 ms + OOT

1.12.2 Dropout times

Test condition:	with initiation via binary input signal
Test values:	$f_{rated}=50$ Hz, 60 Hz
Permissive tolerance/Limiting values:	t approx. 3 ms + OOT
Test results/Remarks:	t < 3 ms + OOT

1.12.3 Time delays

Test condition:	added to the inherent operating times
Test values:	0.00 s to 60.00 s
Permissive tolerance/Limiting values:	± 1 % of setting value or 10 ms
Test results/Remarks:	< 1 % of setting value or 10 ms

Summary

1.13 50/51 Overcurrent Protection, Phases

1.13.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-151

1.13.2 Overcurrent Protection, phases with definite time overcurrent stages (definite time)

1.13.2.1 Pickup values

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$

Method of measurement = fundamental components of phases:

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}

Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value of phases, no filter applied:

Permissive tolerance/Limiting values: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or 0.02 I_{rated}

Method of measurement = RMS value of phases,

with filter for the compensation of the amplitude attenuation due to the anti-aliasing:

Permissive tolerance/Limiting values: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 2 % of setting value or 0.02 I_{rated}
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 2 % of setting value or 0.02 I_{rated}
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated}

Method of measurement = RMS value of phases,

with filter for the gain of harmonics (including compensation of the amplitude attenuation)¹

Permissive tolerance/Limiting values: up to 30th harmonic: 1.5 % of setting value or 0.01 I_{rated}
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonic: 1.5 % of setting value or 0.01 I_{rated} ²
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated} ³
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or 0.02 I_{rated} ³

1.13.2.2 Dropout ratio

Test condition: see item 1.13.2.1

Test values: 0.90 £ r £ 0.99

Permissive tolerance/Limiting values: 1 % of dropout value

Test results/Remarks: 1 % of dropout value

1.13.2.3 Pickup times

Test condition: see item 1.13.2.1

Test values: 1.2*threshold

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

¹ In case that the filter response exactly matches the user defined gain factor

² In case that the user-defined gain factor is set below 3. The tolerance is amplified if the gain factor is larger

³ In case that the user-defined gain factor is set below 7. The tolerance is amplified if the gain factor is larger

Summary

1.13.2.4 Dropout times

Test condition: see item 1.13.2.1
 Permissive tolerance/Limiting values: t approx.
 20 ms + OOT
 Test results/Remarks: t approx.
 20 ms + OOT

1.13.2.5 Time delay

Test condition: see item 1.13.2.1
 1.2*threshold
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: 1 % of setting value or 30 ms
 Test results/Remarks: 1 % of setting value or 30 ms

1.13.3 Overcurrent Protection, phases with inverse time overcurrent stage (inverse time)

1.13.3.1 Pickup values

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
 f_{rated} = 50 Hz, 60 Hz

Method of measurement = fundamental components of phases:

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}
 Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value of phases, no filter applied:

Permissive tolerance/Limiting values: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}
 Test results/Remarks: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

Method of measurement = RMS value of phases.

with filter for the compensation of the amplitude attenuation due to the anti-aliasing:

Permissive tolerance/Limiting values: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, f_{rated} = 50 Hz: 2 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, f_{rated} = 60 Hz: 3 % of setting value or 0.02 I_{rated}
 Test results/Remarks: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, f_{rated} = 50 Hz: 2 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, f_{rated} = 60 Hz: 3 % of setting value or 0.02 I_{rated}

Method of measurement = RMS value of phases.

with filter for the gain of harmonics (including compensation of the amplitude attenuation)¹

Permissive tolerance/Limiting values: up to 30th harmonic: 1.5 % of setting value or 0.01 I_{rated}
 up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}
 Test results/Remarks: up to 30th harmonic: 1.5 % of setting value or 0.01 I_{rated}²
 up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}³
 up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}³

1.13.3.2 Dropout ratio

Test condition: see item 1.13.3.1
 Instantaneous:
 Test values: 1.05 * threshold value
 0.95 * pickup value
 Disk emulation
 Test values: 0.90 * threshold value

¹ In case that the filter response exactly matches the user defined gain factor

² In case that the user-defined gain factor is set below 3. The tolerance is amplified if the gain factor is larger

³ In case that the user-defined gain factor is set below 7. The tolerance is amplified if the gain factor is larger

Summary

Permissive tolerance/Limiting values:	1 % of dropout value
Test results/Remarks:	1% of dropout value
1.13.3.3 Pickup times	
Test condition:	see item 1.13.3.1 1.2*threshold
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at 50 Hz 22 ms + OOT at 60 Hz
Test results/Remarks:	t approx. 25 ms + OOT at 50 Hz 22 ms + OOT at 60 Hz
1.13.3.4 Dropout times	
Test condition:	see item 1.13.3.1
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT
1.13.3.5 Tripping time characteristics	
Test condition:	see item 1.13.3.1 1.2*threshold
Test values:	Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.1 IEC normal inverse (type A)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.2 IEC very inverse (type B)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.3 IEC extremely inverse (type C)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.4 IEC long-time inverse (type B)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.5 ANSI long-time inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.6 ANSI short-time inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.7 ANSI extremely inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.8 ANSI very inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.9 ANSI normal inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.10 ANSI moderately inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.5.11 ANSI definite inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6 Dropout characteristics	
Test condition:	see item 1.13.3.1 Disk emulation: 0.8*threshold
Test values:	Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.1 IEC normal inverse (type A)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms

Summary

1.13.3.6.2 IEC very inverse (type B)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.3 IEC extremely inverse (type C)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.4 IEC long-time inverse (type B)	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.5 ANSI long-time inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.6 ANSI short-time inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.7 ANSI extremely inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.8 ANSI very inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.9 ANSI normal inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.10 ANSI moderately inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
1.13.3.6.11 ANSI definite inverse	
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms

1.13.4 Overcurrent Protection, phases with user-defined characteristic¹

1.13.4.1 Pickup

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
f_{rated} = 50 Hz, 60 Hz

Method of measurement = fundamental components of phases:

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}

Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value of phases, no filter applied :

Permissive tolerance/Limiting values: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

Method of measurement = RMS value of phases,

with filter for the compensation of the amplitude attenuation due to the anti-aliasing:

Permissive tolerance/Limiting values: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 2 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 3 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonic: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 2 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 3 % of setting value or 0.02 I_{rated}

Method of measurement = RMS value of phases,

with filter for the gain of harmonics (including compensation of the amplitude attenuation²

Permissive tolerance/Limiting values: up to 30th harmonic: 1.5 % of setting value or 0.01 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonic: 1.5 % of setting value or 0.01 I_{rated}³
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}¹
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}¹

¹ Not available for Busbar Protection

² In case that the filter response exactly matches the user defined gain factor

³ In case that the user-defined gain factor is set below 3. The tolerance is amplified if the gain factor is larger

Summary**1.13.4.2 Dropout ratio**

Test condition:	see item 1.13.4.1
Instantaneous:	
Test values:	1.05 * threshold value 0.95 * pickup value
Disk emulation	
Test values:	0.90 * threshold value
Permissive tolerance/Limiting values:	1 % of dropout value
Test results/Remarks:	1% of dropout value

1.13.4.3 Pickup times

Test condition:	see item 1.13.4.1 1.2*threshold
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at 50 Hz 22 ms + OOT at 60 Hz
Test results/Remarks:	t approx. 25 ms + OOT at 50 Hz 25 ms + OOT at 60 Hz

1.13.4.4 Dropout times

Test condition:	see item 1.13.4.1
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT
Test results/Remarks:	t approx. 25 ms + OOT

1.13.4.5 Tripping time characteristics

Test condition:	see item 1.13.4.1 1.2*threshold
Test values:	Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms

1.13.4.6 Dropout characteristics

Test condition:	see item 1.13.4.1 Disk emulation: 0.8*threshold
Test values:	Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms
Test results/Remarks:	5 % of the reference (calculated) value + 2 % of current tolerance or 30 ms

¹ In case that the user-defined gain factor is set below 7. The tolerance is amplified if the gain factor is larger

Summary

1.14 50/51 Overcurrent Protection 1-phase

1.14.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-151

1.14.2 Overcurrent protection, 1-phase with definite time-overcurrent stage

1.14.2.1 Pickup values

Test condition: 0.030 I_{rated} $\leq I < 35.000 I_{rated}$ for CT protection
0.001 I_{rated} $\leq I < 1.600 I_{rated}$ for CT sensitive

Test values: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
0.030 I_{rated} $\leq I < 35.000 I_{rated}$ for CT protection

Method of measurement = fundamental components:

Permissive tolerance/Limiting values: $|d| \leq 1 \%$ of setting value or $0.005 I_{rated}$

Test results/Remarks: $|d| < 1 \%$ of setting value or $0.005 I_{rated}$

Method of measurement = RMS value:

Permissive tolerance/Limiting values: up to 30th harmonics: $|d| \leq 1 \%$ of setting value or $0.005 I_{rated}$
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: $|d| \leq 3 \%$ of setting value or $0.02 I_{rated}$
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: $|d| \leq 4 \%$ of setting value or $0.02 I_{rated}$

Test results/Remarks: up to 30th harmonics: $|d| \leq 1 \%$ of setting value or $0.005 I_{rated}$
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: $|d| \leq 3 \%$ of setting value or $0.02 I_{rated}$
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: $|d| \leq 4 \%$ of setting value or $0.02 I_{rated}$

1.14.2.2 Dropout ratios

Test condition: see item 1.14.2.1

Test values: see item 1.14.2.1

Permissive tolerance/Limiting values: 0.95 (fixed)

Test results/Remarks: 0.95 (fixed)

1.14.2.3 Pickup times

Test condition: see item 1.14.2.1

Test values: $I/I_{rated/r} = 2$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$

Permissive tolerance/Limiting values: t approx.
15 ms + OOT at 50 Hz
14 ms + OOT at 60 Hz

Test results/Remarks: t approx.
15 ms + OOT at 50 Hz
14 ms + OOT at 60 Hz

1.14.2.4 Dropout times

Test condition: see item 1.14.2.1

Test values: see item 1.14.2.1

Permissive tolerance/Limiting values: t approx. 20 ms + OOT

Test results/Remarks: t approx. 20 ms + OOT

1.14.2.5 Time delays

Test condition: added to the inherent operating times

Test values: 0.000 s $\leq T \leq 60.000$ s

Permissive tolerance/Limiting values: $|d| \leq 1 \%$ of setting value or 10 ms

Test results/Remarks: $|d| < 1 \%$ of setting value or 10 ms

Summary

1.14.3 Overcurrent Protection, 1-ph with inverse-time overcurrent stage

1.14.3.1 Pickup values

Test condition: 0.030 I_{rated} $\leq I < 35.000 I_{rated}$ for CT protection
0.001 I_{rated} $\leq I < 1.600 I_{rated}$ for CT sensitive
Time dial:
0.05 $\leq T < 15.00$

Test values: $f_{rated} = 50$ Hz, 60 Hz
0.030 I_{rated} $\leq I < 35.000 I_{rated}$ for CT protection

Method of measurement = fundamental components:

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of setting value or $0.005 I_{rated}$
Test results/Remarks: $|d| < 1\%$ of setting value or $0.005 I_{rated}$

Method of measurement = RMS value:

Permissive tolerance/Limiting values: up to 30th harmonics: $|d| \leq 1\%$ of setting value or $0.005 I_{rated}$
up to 50th harmonic, $f_{rated} = 50$ Hz: $|d| \leq 3\%$ of setting value or $0.02 I_{rated}$
up to 50th harmonic, $f_{rated} = 60$ Hz: $|d| \leq 4\%$ of setting value or $0.02 I_{rated}$

Test results/Remarks: up to 30th harmonics: $|d| \leq 1\%$ of setting value or $0.005 I_{rated}$
up to 50th harmonic, $f_{rated} = 50$ Hz: $|d| \leq 3\%$ of setting value or $0.02 I_{rated}$
up to 50th harmonic, $f_{rated} = 60$ Hz: $|d| \leq 4\%$ of setting value or $0.02 I_{rated}$

1.14.3.2 Dropout ratios

Test condition: see item 1.14.3.1
Test values: see item 1.14.3.1
Instantaneous:
Permissive tolerance/Limiting values: approx. $1.05 \cdot$ threshold value
approx. $0.95 \cdot$ pickup value
Test results/Remarks: approx. $1.05 \cdot$ threshold value
approx. $0.95 \cdot$ pickup value
Disk emulation
Permissive tolerance/Limiting values: approx. $0.90 \cdot$ threshold value
Test results/Remarks: approx. $0.90 \cdot$ threshold value

1.14.3.3 Pickup times

Test values: pickup time for $2 \leq I/I_{threshold} \leq 20$
Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz
Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

1.14.3.4 Dropout times

Instantaneous:
Permissive tolerance/Limiting values: t approx. 20 ms + OOT
Test results/Remarks: t approx. 20 ms + OOT
Disk emulation
Test values: dropout time for $I/I_{threshold} \leq 0.90$
Permissive tolerance/Limiting values: 5 % of set point value or
+2 % current tolerance or
30 ms
Test results/Remarks: 5 % of set point value or
+2 % current tolerance or
30 ms

Summary

1.14.3.5 Tripping time characteristics

Test values: tripping times t
Permissive tolerance/Limiting values: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.1 IEC normal inverse (type A)

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.2 IEC very inverse (type B)

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.3 IEC extremely inverse (type C)

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.4 IEC long-time inverse (type B)

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.5 ANSI long-time inverse

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.6 ANSI short-time inverse

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.7 ANSI extremely inverse

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.8 ANSI very inverse

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.9 ANSI normal inverse

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.10 ANSI moderately inverse

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.5.11 ANSI definite inverse

Test results/Remarks: |d| $\pm 5\% \pm 15$ ms for 2 $\pm I_{LP}$ ± 20
|d| $\pm 5\% \pm 15$ ms for 2 $\pm 3I_{LP}$ ± 20

1.14.3.6 Dropout characteristics

Test values: dropout times
Permissive tolerance/Limiting values: |d| $\pm 5\% \pm 30$ ms for 0.05 $\pm I_{LP}$ ± 0.90
|d| $\pm 5\% \pm 30$ ms for 0.05 $\pm 3I_{LP}$ ± 0.90

1.14.3.6.1 IEC normal inverse (type A)

Test results/Remarks: |d| $\pm 5\% \pm 30$ ms for 0.05 $\pm I_{LP}$ ± 0.90
|d| $\pm 5\% \pm 30$ ms for 0.05 $\pm 3I_{LP}$ ± 0.90

1.14.3.6.2 IEC very inverse (type B)

Test results/Remarks: |d| $\pm 5\% \pm 30$ ms for 0.05 $\pm I_{LP}$ ± 0.90
|d| $\pm 5\% \pm 30$ ms for 0.05 $\pm 3I_{LP}$ ± 0.90

1.14.3.6.3 IEC extremely inverse (type C)

Test results/Remarks: |d| $\pm 5\% \pm 30$ ms for 0.05 $\pm I_{LP}$ ± 0.90
|d| $\pm 5\% \pm 30$ ms for 0.05 $\pm 3I_{LP}$ ± 0.90

1.14.3.6.4 IEC long-time inverse (type B)

Test results/Remarks: |d| $\pm 5\% \pm 30$ ms for 0.05 $\pm I_{LP}$ ± 0.90
|d| $\pm 5\% \pm 30$ ms for 0.05 $\pm 3I_{LP}$ ± 0.90

Summary

1.14.3.6.5 ANSI long-time inverse

Test results/Remarks:

|d| £ 5 % ± 30 ms for 0.05 £ I/I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I0/I_P £ 0.90

1.14.3.6.6 ANSI short-time inverse

Test results/Remarks:

|d| £ 5 % ± 30 ms for 0.05 £ I/I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I0/I_P £ 0.90

1.14.3.6.7 ANSI extremely inverse

Test results/Remarks:

|d| £ 5 % ± 30 ms for 0.05 £ I/I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I0/I_P £ 0.90

1.14.3.6.8 ANSI very inverse

Test results/Remarks:

|d| £ 5 % ± 30 ms for 0.05 £ I/I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I0/I_P £ 0.90

1.14.3.6.9 ANSI normal inverse

Test results/Remarks:

|d| £ 5 % ± 30 ms for 0.05 £ I/I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I0/I_P £ 0.90

1.14.3.6.10 ANSI moderately inverse

Test results/Remarks:

|d| £ 5 % ± 30 ms for 0.05 £ I/I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I0/I_P £ 0.90

1.14.3.6.11 ANSI definite inverse

Test results/Remarks:

|d| £ 5 % ± 30 ms for 0.05 £ I/I_P £ 0.90
|d| £ 5 % ± 30 ms for 0.05 £ 3I0/I_P £ 0.90

1.14.4 Overcurrent Protection, 1-ph with user-defined characteristic curve stage

1.14.4.1 Pickup

Test condition:

0.030 I_{rated} £ I > £ 35.000 I_{rated} for CT protection
0.001 I_{rated} £ I > £ 1.600 I_{rated} for CT sensitive
Time dial:
0.05 £ T £ 15.00

Test values:

f_{rated} = 50 Hz, 60 Hz
0.030 I_{rated} £ I > £ 35.000 I_{rated} for CT protection

Method of measurement = fundamental components:

Permissive tolerance/Limiting values:

|d| £ 1 % of setting value or 0.005 I_{rated}

Test results/Remarks:

|d| < 1 % or 0.5 % I_{rated}

Method of measurement = RMS value:

Permissive tolerance/Limiting values:

up to 30th harmonics: |d| £ 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: |d| £ 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: |d| £ 4 % of setting value or 0.02 I_{rated}

Test results/Remarks:

up to 30th harmonics: |d| £ 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: |d| £ 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: |d| £ 4 % of setting value or 0.02 I_{rated}

1.14.4.2 Dropout ratios

Test condition:

see item 1.14.4.1

Test values:

see item 1.14.4.1

Instantaneous:

Permissive tolerance/Limiting values:

approx. 1.05 * threshold value
approx. 0.95 * pickup value

Test results/Remarks:

approx. 1.05 * threshold value
approx. 0.95 * pickup value

Disk emulation

Permissive tolerance/Limiting values:

approx. 0.90 * threshold value

Test results/Remarks:

approx. 0.90 * threshold value

Summary

1.14.4.3 Pickup times

Test values: pickup time for $2 \leq I/I\text{-threshold value} \leq 20$
 Permissive tolerance/Limiting values: t approx.
 25 ms + OOT at 50 Hz
 22 ms + OOT at 60 Hz
 Test results/Remarks: t approx.
 25 ms + OOT at 50 Hz
 22 ms + OOT at 60 Hz

1.14.4.4 Dropout times

Instantaneous:

Permissive tolerance/Limiting values: t approx. 20 ms + OOT
 Test results/Remarks: t approx. 20 ms + OOT

Disk emulation

Test values: dropout time for $I/I\text{-threshold value} \leq 0.90$
 Permissive tolerance/Limiting values: 5 % of set point value or
 +2 % current tolerance or
 30 ms
 Test results/Remarks: 5 % of set point value or
 +2 % current tolerance or
 30 ms

1.14.5 Overcurrent Protection, 1-phase with fast stage

1.14.5.1 Pickup

Test condition: $0.030 I_{rated} \leq I < 35.000 I_{rated}$ for CT protection
 $0.001 I_{rated} \leq I < 1.600 I_{rated}$ for CT sensitive
 Test values: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 $0.030 I_{rated} \leq I < 35.000 I_{rated}$ for CT protection
 $0.001 I_{rated} \leq I < 1.600 I_{rated}$ for CT sensitive
 Permissive tolerance/Limiting values: $|d| \leq 5 \% \text{ of setting value or } 0.01 I_{rated}$
 Test results/Remarks: $|d| \leq 5 \% \text{ or } 0.01 I_{rated}$

1.14.5.2 Dropout ratio

Test values: $r = \text{settable dropout ratio}$
 Permissive tolerance/Limiting values: $0.90 \leq r \leq 0.99$
 Test results/Remarks: confirmed

1.14.5.3 Pickup times

Test values: $I/I_{rated/r} = 2$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 Permissive tolerance/Limiting values: t approx.
 8 ms + OOT at 50 Hz / 60 Hz
 Test results/Remarks: t approx.
 8 ms + OOT at 50 Hz / 60 Hz

1.14.5.4 Dropout times

Test condition: see item 1.14.5.1
 Test values: see item 1.14.5.1
 Permissive tolerance/Limiting values: t approx. 25 ms + OOT
 Test results/Remarks: t approx. 25 ms + OOT

Summary**1.14.5.5 Time delays**

Test condition:	added to inherent operating times
Test values:	$0.00 \text{ s} \leq T_D < 60.00 \text{ s}$
Permissive tolerance/Limiting values:	$ d \leq 1 \% \text{ of setting value or } 10 \text{ ms}$
Test results/Remarks:	$ d < 1 \% \text{ of setting value or } 10 \text{ ms}$

Summary

1.15 67 Directional Overcurrent Protection, Phases

1.15.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-151

1.15.2 Directional overcurrent protection, phases with definite time overcurrent stages (definite time)

1.15.2.1 Pickup values

Test condition: 0.030 I_{rated} ≤ threshold value ≤ 35.000 I_{rated}
f_{rated} = 50 Hz, 60 Hz

Method of measurement = fundamental components:

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}

Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value:

Permissive tolerance/Limiting values: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

1.15.2.2 Dropout ratio

Test condition: see item 1.15.2.1

Test values: 0.90 ≤ r ≤ 0.99

Permissive tolerance/Limiting values: 1 % of dropout value

Test results/Remarks: 1 % of dropout value

1.15.2.3 Pickup times

Test condition: see item 1.15.2.1
1.2*threshold

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

1.15.2.4 Dropout times

Test condition: see item 1.15.2.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
20 ms + OOT

1.15.2.5 Time delay

Test condition: see item 1.15.2.1
1.2*threshold

Test values: 0.00 s ≤ T ≤ 60.00 s

Permissive tolerance/Limiting values: 1 % of setting value or 10 ms

Test results/Remarks: 1 % of setting value or 10 ms

Summary

1.15.3 Directional overcurrent protection, phases with inverse time overcurrent stage (inverse time)

1.15.3.1 Pickup values

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$

Method of measurement = fundamental components:

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}

Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value:

Permissive tolerance/Limiting values: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or 0.02 I_{rated}

1.15.3.2 Dropout ratio

Test condition: see item 1.15.3.1

Instantaneous:

Test values: 1.05 * threshold value
0.95 * pickup value

Disk emulation

Test values: 0.90 * threshold value

Permissive tolerance/Limiting values: 1 % of dropout value

Test results/Remarks: 1% of dropout value

1.15.3.3 Pickup times

Test condition: see item 1.15.3.1
1.2*threshold

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
25 ms + OOT at 60 Hz

1.15.3.4 Dropout times

Test condition: see item 1.15.3.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
20 ms + OOT

1.15.3.5 Tripping time characteristics

Test condition: see item 1.15.3.1
1.2*threshold

Test values: Time dial: 0.05 £ T £ 15.00

Permissive tolerance/Limiting values: 5 % of setting value or + 2 % of current tolerance or 10 ms

1.15.3.5.1 IEC normal inverse (type A)

Test results/Remarks: 5 % of setting value or ± 2 % of current tolerance or 30 ms

1.15.3.5.2 IEC very inverse (type B)

Test results/Remarks: 5 % of setting value or ± 2 % of current tolerance or 30 ms

1.15.3.5.3 IEC extremely inverse (type C)

Test results/Remarks: 5 % of setting value or ± 2 % of current tolerance or 30 ms

1.15.3.5.4 IEC long-time inverse (type B)

Test results/Remarks: 5 % of setting value or ± 2 % of current tolerance or 30 ms

Summary

1.15.3.5.5 ANSI long-time inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.5.6 ANSI short-time inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.5.7 ANSI extremely inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.5.8 ANSI very inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.5.9 ANSI normal inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.5.10 ANSI moderately inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.5.11 ANSI definite inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6 Dropout characteristics	
Test condition:	see item 1.15.3.1
Disk emulation:	0.8*threshold
Test values:	Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	5 % of setting value or + 2 % of current tolerance or 10 ms
1.15.3.6.1 IEC normal inverse (type A)	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.2 IEC very inverse (type B)	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.3 IEC extremely inverse (type C)	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.4 IEC long-time inverse (type B)	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.5 ANSI long-time inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.6 ANSI short-time inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.7 ANSI extremely inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.8 ANSI very inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.9 ANSI normal inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.10 ANSI moderately inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms
1.15.3.6.11 ANSI definite inverse	
Test results/Remarks:	5 % of setting value or ± 2 % of current tolerance or 30 ms

Summary

1.15.4 Overcurrent protection, phases with user-defined characteristic

1.15.4.1 Pickup

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
f_{rated} = 50 Hz, 60 Hz

Method of measurement = fundamental components:

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}

Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value:

Permissive tolerance/Limiting values: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

1.15.4.2 Dropout ratio

Test condition: see item 1.15.4.1

Instantaneous:

Test values: 1.05 * threshold value
0.95 * pickup value

Disk emulation

Test values: 0.90 * threshold value

Permissive tolerance/Limiting values: 1 % of dropout value

Test results/Remarks: 1% of dropout value

1.15.4.3 Pickup times

Test condition: see item 1.15.4.1
1.2*threshold

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
25 ms + OOT at 60 Hz

1.15.4.4 Dropout times

Test condition: see item 1.15.4.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
25 ms + OOT

1.15.4.5 Tripping time characteristics

Test condition: see item 1.15.4.1
1.2*threshold

Test values: Time dial: 0.05 £ T £ 15.00

Permissive tolerance/Limiting values: 5 % of setting value or + 2 % of current tolerance or 10 ms

Test results/Remarks: 5 % of setting value or ± 2 % of current tolerance or 10 ms

1.15.4.6 Dropout characteristics

Test condition: see item 1.15.4.1

Disk emulation: 0.8*threshold

Test values: Time dial: 0.05 £ T £ 15.00

Permissive tolerance/Limiting values: 5 % of setting value or + 2 % of current tolerance or 10 ms

Test results/Remarks: 5 % of setting value or ± 2 % of current tolerance or 10 ms

Summary**1.15.5 Directional determination**

Test condition:	$0.030 I_{rated} \leq \text{threshold value} \leq 35.000 I_{rated}$ $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
Test values:	$-180^\circ \leq \varphi \leq 180^\circ$
Permissive tolerance/Limiting values:	1°
Test results/Remarks:	4°

Summary

1.16 50 High-Speed Instantaneous Overcurrent Protection

1.16.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-151

1.16.2 General test conditions

f_{rated} 50 Hz, 60 Hz

1.16.3 Pickup values

Test condition: $0.030 I_{rated} \leq I < 35.000 I_{rated}$

Test values: $0.100 I_{rated} \leq I < 5.000 I_{rated}$

Permissive tolerance/Limiting values: $|d| \leq 5\% \text{ of setting value or } 0.010 I_{rated}$

Test results/Remarks: $|d| < 5\% \text{ of setting value or } 0.010 I_{rated}$

1.16.4 Dropout ratio

Test condition: see item 1.16.2

Test values: $r = \text{settable dropout ratio}$
 $0.50 \leq r \leq 0.90$

Permissive tolerance/Limiting values: $|d| \leq 5\% \text{ of setting value}$

Test results/Remarks: $|d| < 5\% \text{ of setting value}$

1.16.5 Pickup times

Test condition: current $> 2\sqrt{2}$ of threshold value

Test values: t in ms

Permissive tolerance/Limiting values: $t \leq 8 \text{ ms} + \text{OOT}$

Test results/Remarks: $t < 8 \text{ ms} + \text{OOT}$

1.16.6 Dropout times

Test condition: current change from $> 2\sqrt{2}$ to 0 of threshold value

Test values: t in ms

Test results/Remarks: t approx. 30 ms + OOT

Summary

1.17 46 Directional Negative-Sequence Protection with definite-time characteristic

1.17.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-151

1.17.2 Pickup values

Test condition: 0.030 I_{rated} £ I > £ 35.00 I_{rated}
 Permissive tolerance/Limiting values: |d| £ 2 % of setting value or 10 mA
 Test results/Remarks: |d| < 2 % or 0.8 % absolute

1.17.3 Dropout ratio

Test condition: see item 1.17.2
 Permissive tolerance/Limiting values: r approx. 0.95
 Test results/Remarks: 0.93 £ r £ 0.97

1.17.4 Pickup times

Test condition: see item 1.17.2
 Permissive tolerance/Limiting values: t approx. 40 ms + OOT
 Test results/Remarks: t < 40 ms + OOT

1.17.5 Dropout times

Permissive tolerance/Limiting values: t approx. 40 ms + OOT
 Test results/Remarks: t < 39 ms + OOT

1.17.6 Time delays

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: |d| < 1 % or 10 ms

1.17.7 Directional determination

1.17.7.1 Angle forward α

Test condition: 0° £ α £ 360°
 Test values: various settings
 Permissive tolerance/Limiting values: |d| £ 1°
 Test results/Remarks: |d| < 1°

1.17.7.2 Angle reverse β

Test condition: 0° £ β £ 360°
 Test values: various settings
 Permissive tolerance/Limiting values: |d| £ 1°
 Test results/Remarks: |d| < 1°

1.17.7.3 Min. neg.-seq. voltage V2

Test condition: 0.15 V £ V₂ £ 34.0 V
 Test values: various settings
 Permissive tolerance/Limiting values: |d| £ 1 %
 Test results/Remarks: |d| < 1 %

Summary**1.17.7.4 Minimum negative sequence current I₂**

Test condition:	0.030 A $\leq I_2 \leq 10.000 I_{\text{rated}}$
Test values:	various settings
Permissive tolerance/Limiting values:	$ d \leq 1 \%$
Test results/Remarks:	$ d < 1 \%$

Summary

1.18 37 Undercurrent Protection with 3-phase

1.18.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-151

1.18.2 Pickup values

Test condition: $0.030 I_{rated} \leq I < 35.000 I_{rated}$

Test values: $f_{rated} = 50 \text{ Hz}, 60\text{Hz}$
 $0.030 I_{rated} \leq I < 20.000 I_{rated}$

Method of measurement = fundamental components:

Permissive tolerance/Limiting values: $|d| \leq 1 \% \text{ of setting value or } 0.005 I_{rated}$

Test results/Remarks: $|d| \leq 2 \% \text{ of setting value or } 0.005 I_{rated}$

Method of measurement = RMS value:

Permissive tolerance/Limiting values: up to 30th harmonics: $|d| \leq 1 \% \text{ of setting value or } 0.005 I_{rated}$

Test results/Remarks: up to 30th harmonics: $|d| \leq 2 \% \text{ of setting value or } 0.005 I_{rated}$

1.18.3 Dropout ratio

Test condition: see item 1.18.2

Test values: see item 1.18.2

Permissive tolerance/Limiting values: 1.05 (fixed)

Test results/Remarks: 1.05 (fixed)

1.18.4 Pickup times

Test condition: see item 1.18.2

Test values: $I / I_{rated} = 1 ; I / I_{rated} = 2$

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

1.18.5 Dropout times

Test condition: see item 1.18.2

Test values: see item 1.18.2

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

1.18.6 Time delays

Test condition: added to the inherent operating times

Test values: $0.000 \text{ s} \leq T \leq 60.000 \text{ s}$

Permissive tolerance/Limiting values: $|d| \leq 1 \% \text{ of setting value or } 10 \text{ ms}$

Test results/Remarks: $|d| \leq 1 \% \text{ of setting value or } 10 \text{ ms}$

Summary

1.19 51V Voltage-dependent Overcurrent-Protection

1.19.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-127

1.19.2 Voltage-released stage

1.19.2.1 Pickup values I_p

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
 Test values: f_{rated} = 50 Hz, 60 Hz
 0.030 I_{rated} £ threshold value £ 18.000 I_{rated}

Method of measurement = fundamental components of phases

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}
 Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value of phases

Permissive tolerance/Limiting values: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}
 Test results/Remarks: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

1.19.2.2 Dropout ratio

Test condition: see item 1.19.2.1
 Instantaneous:
 Test values: 1.05 * threshold value
 0.95 * pickup value
 Disk emulation
 Test values: 0.90 * threshold value
 Permissive tolerance/Limiting values: 1 % of dropout value
 Test results/Remarks: 1% of dropout value

1.19.2.3 Pickup values V_{ph-ph}<

Test condition: 0.300 V £ threshold value £ 175.000V
 Test values: 0.300 V £ threshold value £ 175.000V
 Permissive tolerance/Limiting values: in the range f_{rated} ±10 %
 0.5 % of setting value or 0.05 V
 Test results/remarks: in the range f_{rated} ±10 %
 0.5 % of setting value or 0.05 V

1.19.2.4 Pickup time

Test condition: see item 1.19.2.1
 Test values: 1.2*threshold
 Permissive tolerance/Limiting values: t approx.
 25 ms + OOT at 50 Hz
 22 ms + OOT at 60 Hz
 Test results/Remarks: t approx.
 25 ms + OOT at 50 Hz
 22 ms + OOT at 60 Hz

1.19.2.5 Dropout times

Test condition: see item 1.19.2.1
 Permissive tolerance/Limiting values: t approx.
 20 ms + OOT
 Test results/Remarks: t approx.
 20 ms + OOT

Summary

1.19.2.6 Tripping time characteristics

Test condition: see item 1.19.2.1
1.2*threshold

Test values: Time dial: 0.05 £ T £ 15.00

Permissive tolerance/Limiting values: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.1 IEC normal inverse (type A)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.2 IEC very inverse (type B)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.3 IEC extremely inverse (type C)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.4 IEC long-time inverse (type B)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.5 ANSI long-time inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.6 ANSI short-time inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.7 ANSI extremely inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.8 ANSI very inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.9 ANSI normal inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.10 ANSI moderately inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.6.11 ANSI definite inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7 Dropout characteristics

Test condition: see item 1.19.2.1

Disk emulation: 0.8*threshold

Test values: Time dial: 0.05 £ T £ 15.00

Permissive tolerance/Limiting values: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.1 IEC normal inverse (type A)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.2 IEC very inverse (type B)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.3 IEC extremely inverse (type C)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.4 IEC long-time inverse (type B)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.5 ANSI long-time inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.6 ANSI short-time inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.7 ANSI extremely inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.8 ANSI very inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.9 ANSI normal inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

Summary

1.19.2.7.10 ANSI moderately inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.2.7.11 ANSI definite inverse

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.3 Voltage-dependent.Stage

1.19.3.1 Pickup values I>

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}

Test values: f_{rated} = 50 Hz, 60 Hz
0.030 I_{rated} £ threshold value £ 18.000 I_{rated}

Method of measurement = fundamental components of phases

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}

Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value of phases

Permissive tolerance/Limiting values: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

Test results/Remarks: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
up to 50th harmonic, f_{rated} = 50 Hz: 3 % of setting value or 0.02 I_{rated}
up to 50th harmonic, f_{rated} = 60 Hz: 4 % of setting value or 0.02 I_{rated}

1.19.3.2 Dropout ratio

Test condition: see item 1.19.3.1

Instantaneous:

Test values: 1.05 * threshold value
0.95 * pickup value

Disk emulation

Test values: 0.90 * threshold value

Permissive tolerance/Limiting values: 1 % of dropout value

Test results/Remarks: 1% of dropout value

1.19.3.3 Pickup time

Test condition: see item 1.19.3.1

Test values: 1.2*threshold

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

Test results/Remarks: t approx.
25 ms + OOT at 50 Hz
22 ms + OOT at 60 Hz

1.19.3.4 Dropout times

Test condition: see item 1.19.3.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
20 ms + OOT

1.19.3.5 Tripping time characteristics

Test condition: see item 1.19.3.1
1.2*threshold

Test values: Time dial: 0.05 £ T £ 15.00

Permissive tolerance/Limiting values: 5 % of setting value or + 2 % of current tolerance or 30 ms

1.19.3.5.1 IEC normal inverse (type A)

Test results/Remarks: 5 % of setting value or + 2 % of current tolerance or 30 ms

Summary

1.19.3.5.2 IEC very inverse (type B)	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.3 IEC extremely inverse (type C)	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.4 IEC long-time inverse (type B)	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.5 ANSI long-time inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.6 ANSI short-time inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.7 ANSI extremely inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.8 ANSI very inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.9 ANSI normal inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.10 ANSI moderately inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.5.11 ANSI definite inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6 Dropout characteristics	
Test condition:	see item 1.19.3.1
Disk emulation:	0.8*threshold
Test values:	Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.1 IEC normal inverse (type A)	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.2 IEC very inverse (type B)	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.3 IEC extremely inverse (type C)	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.4 IEC long-time inverse (type B)	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.5 ANSI long-time inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.6 ANSI short-time inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.7 ANSI extremely inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.8 ANSI very inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.9 ANSI normal inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.10 ANSI moderately inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.3.6.11 ANSI definite inverse	
Test results/Remarks:	5 % of setting value or + 2 % of current tolerance or 30 ms
1.19.4 Undervoltage seal-in stage	
1.19.4.1 Pickup values I>	
Test condition:	0.030 I _{rated} £ threshold value £ 35.000 I _{rated}

Summary

Test values: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 $0.030 I_{rated} \leq \text{threshold value} \leq 35.000 I_{rated}$

Method of measurement = fundamental components of phases

Permissive tolerance/Limiting values: 1 % of setting value or $0.005 I_{rated}$

Test results/Remarks: 1 % of setting value or $0.005 I_{rated}$

Method of measurement = RMS value of phases

Permissive tolerance/Limiting values: up to 30th harmonics: 1 % of setting value or $0.005 I_{rated}$
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or $0.02 I_{rated}$
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or $0.02 I_{rated}$

Test results/Remarks: up to 30th harmonics: 1 % of setting value or $0.005 I_{rated}$
up to 50th harmonic, $f_{rated} = 50 \text{ Hz}$: 3 % of setting value or $0.02 I_{rated}$
up to 50th harmonic, $f_{rated} = 60 \text{ Hz}$: 4 % of setting value or $0.02 I_{rated}$

1.19.4.2 Dropout ratio

Test condition: see item 1.19.4.1

Test values: $0.90 \leq r \leq 0.99$

Permissive tolerance/Limiting values: 1 % of dropout value

Test results/Remarks: 1 % of dropout value

1.19.4.3 Pickup values V-seal-in

Test condition: $0.300 \text{ V} \leq \text{threshold value} \leq 175.000 \text{ V}$

Test values: $0.300 \text{ V} \leq \text{threshold value} \leq 175.000 \text{ V}$

Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10 \%$
 0.5% of setting value or 0.05 V

Test results/remarks: in the range $f_{rated} \pm 10 \%$
 0.5% of setting value or 0.05 V

1.19.4.4 Dropout ratio of V-seal-in

Test condition: $0.300 \text{ V} \leq \text{threshold value} \leq 175.000 \text{ V}$

Test values: $1.01 \leq r \leq 1.20$

Permissive tolerance/Limiting values: 1 % of dropout value

Test results/Remarks: 1 % of dropout value

1.19.4.5 Pickup times

Test condition: see item 1.19.4.1

Test values: $1.2 \times \text{threshold}$

Permissive tolerance/Limiting values: t approx.
30 ms + OOT at 50 Hz
25 ms + OOT at 60 Hz

Test results/Remarks: t approx.
30 ms + OOT at 50 Hz
25 ms + OOT at 60 Hz

1.19.4.6 Dropout times

Test condition: see item 1.19.4.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
20 ms + OOT

1.19.4.7 Operate delays

Test condition: I_{rated} value

Test values: $0.00 \text{ s} \leq T \leq 60.00 \text{ s}$

Permissive tolerance/Limiting values: 1 % of setting value or 10 ms

Test results/Remarks: 1 % of setting value or 10 ms

Summary

1.19.4.8 Duration of V-seal-in time

Test condition: I_{rated} value
 Test values: 0.10 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: 1 % of setting value or 10 ms
 Test results/Remarks: 1 % of setting value or 10 ms

1.19.5 Undervoltage Seal-in and voltage released stage

1.19.5.1 Pickup values I>

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
 Test values: $f_{rated} = 50$ Hz, 60 Hz
 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}

Method of measurement = fundamental components of phases

Permissive tolerance/Limiting values: 1 % of setting value or 0.005 I_{rated}
 Test results/Remarks: 1 % of setting value or 0.005 I_{rated}

Method of measurement = RMS value of phases

Permissive tolerance/Limiting values: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, $f_{rated} = 50$ Hz: 3 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, $f_{rated} = 60$ Hz: 4 % of setting value or 0.02 I_{rated}
 Test results/Remarks: up to 30th harmonics: 1 % of setting value or 0.005 I_{rated}
 up to 50th harmonic, $f_{rated} = 50$ Hz: 3 % of setting value or 0.02 I_{rated}
 up to 50th harmonic, $f_{rated} = 60$ Hz: 4 % of setting value or 0.02 I_{rated}

1.19.5.2 Pickup values V2

Test condition: 0.300 V £ threshold value £ 200.000V
 Test values: 0.300 V £ threshold value £ 200.000V
 Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10$ %
 0.5 % of setting value or 0.05 V
 Test results/remarks: in the range $f_{rated} \pm 10$ %
 0.5 % of setting value or 0.05 V

1.19.5.3 Dropout ratio

Test condition: 0.030 I_{rated} £ threshold value £ 35.000 I_{rated}
 0.300 V £ threshold value £ 200.000V
 Test values: 0.90 £ r £ 0.99
 Permissive tolerance/Limiting values: 1 % of dropout value
 Test results/Remarks: 1 % of dropout value

1.19.5.4 Pickup values Vph-ph<, V-seal-in

Test condition: 0.300 V £ threshold value £ 175.000V
 Test values: 0.300 V £ threshold value £ 175.000V
 Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10$ %
 0.5 % of setting value or 0.05 V
 Test results/remarks: in the range $f_{rated} \pm 10$ %
 0.5 % of setting value or 0.05 V

1.19.5.5 Dropout ratio of V-seal-in

Test condition: 0.300 V £ threshold value £ 175.000V
 Test values: 1.01 £ r £ 1.20
 Permissive tolerance/Limiting values: 1 % of dropout value
 Test results/Remarks: 1 % of dropout value

1.19.5.6 Pickup time

Test condition: see item 1.19.5.1
 Test values: 1.2*threshold

Summary

Permissive tolerance/Limiting values: t approx.
30 ms + OOT at 50 Hz
25 ms + OOT at 60 Hz

Test results/Remarks: t approx.
30 ms + OOT at 50 Hz
25 ms + OOT at 60 Hz

1.19.5.7 Dropout times

Test condition: see item 1.19.5.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
20 ms + OOT

1.19.5.8 Operate delays

Test condition: I_{rated} value

Test values: 0.00 s $\leq T \leq$ 60.00 s

Permissive tolerance/Limiting values: 1 % of setting value or 10 ms

Test results/Remarks: 1 % of setting value or 10 ms

1.19.5.9 Duration of V-seal-in time

Test condition: I_{rated} value

Test values: 0.10 s $\leq T \leq$ 60.00 s

Permissive tolerance/Limiting values: 1 % of setting value or 10 ms

Test results/Remarks: 1 % of setting value or 10 ms

Summary

1.20 47/59 Overvoltage Protection

1.20.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-127

1.20.2 3ph Voltage ph-to-gnd, ph-to-ph V with definite time overvoltage stage

1.20.2.1 Pickup values

Test condition:	Fundamental components, RMS values $f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ 0.300 V £ threshold value £ 340.000 V
Permissive tolerance/Limiting values:	in the range $f_{rated} \pm 10 \%$ d £ 0.5 % of setting value or 0.05 V
Test results/Remarks:	in the range $f_{rated} \pm 10 \%$ d £ 0.5 % of setting value or 0.05 V

1.20.2.2 Dropout ratio

Test condition:	See item 1.20.2.1
Test values:	$r = \text{setable dropout ratio}$ 0.90 £ r £ 0.99
Permissive tolerance/Limiting values:	d £ 0.5 % of dropout value or 0.05 V
Test results/Remarks:	d £ 0.5 % of dropout value or 0.05 V

1.20.2.3 Pickup times

Test condition	See item 1.20.2.1 1.2* threshold value
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 22 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Test results/Remarks:	t approx. 25 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 22 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.20.2.4 Dropout times

Test condition:	See item 1.20.2.1
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT

1.20.2.5 Time delays

Test condition:	See item 1.20.2.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

1.20.3 3ph Voltage ph-to-gnd, ph-to-ph V with inverse time overvoltage stage

1.20.3.1 Pickup values

Test condition:	Fundamental components, RMS values $f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ 0.300 V £ pickup value £ 340.000 V
Permissive tolerance/Limiting values:	in the range $f_{rated} \pm 10 \%$ d £ 0.5 % of setting value or 0.05 V
Test results/Remarks:	in the range $f_{rated} \pm 10 \%$ d £ 0.5 % of setting value or 0.05 V

1.20.3.2 Dropout ratio

Test condition	See item 1.20.3.1
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Summary

Permissive tolerance/Limiting values:	d £ 0.5 % of setting value or 0.05 V
Test results/Remarks:	d £ 0.5 % of setting value or 0.05 V
1.20.3.3 Pickup times	
Test condition	See item 1.20.3.1 1.2* pickup value
Permissive tolerance/Limiting values:	Approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	Approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
1.20.3.4 Dropout times	
Test condition:	See item 1.20.3.1 Reset time is set 0 s
Permissive tolerance/Limiting values:	Approx. 20 ms + OOT
Test results/Remarks:	Approx. 20 ms + OOT
1.20.3.5 Definite time delays	
Test condition:	See item 1.20.3.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms
1.20.3.6 Reset time	
Test condition:	See item 1.20.3.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms
1.20.3.7 Inverse time characteristic	
Test condition:	See item 1.20.3.1 Charact.constant k: 0.00 £ k £ 300.00 Charact.constant α : 0.010 £ α £ 5.000 Charact.constant c: 0.000 £ c £ 5.000 Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	d £ 5 % of the setting value or 30 ms
Test results/Remarks:	d £ 5 % of the setting value or 30 ms
1.20.4 Positive sequence V1	
1.20.4.1 Pickup values	
Test condition:	$f_{rated} = 50$ Hz, 60Hz 0.300 V £ threshold value £ 200.000 V
Permissive tolerance/Limiting values:	in the range $f_{rated} \pm 10$ % d £ 0.5 % of setting value or 0.05 V
Test results/Remarks:	in the range $f_{rated} \pm 10$ % d £ 0.5 % of setting value or 0.05 V
1.20.4.2 Dropout ratio	
Test condition:	See item 1.20.4.1
Test values:	r = setable dropout ratio 0.90 £ r £ 0.99
Permissive tolerance/Limiting values:	d £ 0.5 % of dropout value or 0.05 V
Test results/Remarks:	d £ 0.5 % of dropout value or 0.05 V

Summary

1.20.4.3 Pickup times

Test condition	See item 1.20.4.1 1.2* threshold value
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz

1.20.4.4 Dropout times

Test condition	See item 1.20.4.1
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT

1.20.4.5 Time delays

Test condition:	See item 1.20.4.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

1.20.5 Zero Sequence, Residual Voltage V0

1.20.5.1 Pickup values

Test condition:	RMS values, fundamental components, fundamental components over 2 cycles 0.300 V £ threshold value £ 340.000 V
Permissive tolerance/Limiting values:	in the range $f_{rated} \pm 10$ % d £ 0.5 % of setting value or 0.05 V
Test results/Remarks:	in the range $f_{rated} \pm 10$ % d £ 0.5 % of setting value or 0.05 V

1.20.5.2 Dropout ratio

Test condition:	See item 1.20.5.1
Test values:	r = setable dropout ratio 0.90 £ r £ 0.99
Permissive tolerance/Limiting values:	d £ 0.5 % of dropout value or 0.05 V
Test results/Remarks:	d £ 0.5 % of dropout value or 0.05 V

1.20.5.3 Pickup times (Filter = RMS value, Standard Filter)

Test condition	See item 1.20.5.1 1.2* threshold value
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz

1.20.5.4 Dropout times (Filter = RMS value, Standard Filter)

Test condition	See item 1.20.5.1
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT at $f_{rated} = 50$ Hz 16.6 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 20 ms + OOT at $f_{rated} = 50$ Hz 16.6 ms + OOT at $f_{rated} = 60$ Hz

Summary

1.20.5.5 Pickup times (Filter = over 2 cycles)

Test condition	See item 1.20.5.1 1.2* threshold value
Permissive tolerance/Limiting values:	t approx. 45 ms + OOT at $f_{rated} = 50$ Hz 39 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 45 ms + OOT at $f_{rated} = 50$ Hz 39 ms + OOT at $f_{rated} = 60$ Hz

1.20.5.6 Dropout times (Filter = over 2 cycles)

Test condition	See item 1.20.5.1
Permissive tolerance/Limiting values:	t approx. 31.06 ms + OOT at $f_{rated} = 50$ Hz 27.06 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 31.06 ms + OOT at $f_{rated} = 50$ Hz 27.06 ms + OOT at $f_{rated} = 60$ Hz

1.20.5.7 Time delays

Test condition:	See item 1.20.5.1
Test values:	0.00 s \leq T \leq 60.00 s
Permissive tolerance/Limiting values:	d \leq 1 % of setting value or 10 ms
Test results/Remarks:	d \leq 1 % of setting value or 10 ms

1.20.6 Any Voltage Vx

1.20.6.1 Pickup values

Test condition:	Fundamental components, RMS values $f_{rated} = 50$ Hz, 60Hz 0.300 V \leq threshold value \leq 340.000 V
Permissive tolerance/Limiting values:	in the range $f_{rated} \pm 10$ % d \leq 0.5 % of setting value or 0.05 V
Test results/Remarks:	in the range $f_{rated} \pm 10$ % d \leq 0.5 % of setting value or 0.05 V

1.20.6.2 Dropout ratio

Test condition:	See item 1.20.6.1
Test values:	r = setable dropout ratio 0.90 \leq r \leq 0.99
Permissive tolerance/Limiting values:	d \leq 0.5 % of setting value or 0.05 V
Test results/Remarks:	d \leq 0.5 % of setting value or 0.05 V

1.20.6.3 Pickup times

Test condition	See item 1.20.6.1 1.2* threshold value
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz

1.20.6.4 Dropout times

Test condition:	See item 1.20.6.1
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT

Summary

1.20.6.5 Time delays

Test condition: See item 1.20.6.1
 Test values: 0.00 s ≤ T ≤ 60.00 s
 Permissive tolerance/Limiting values: |d| ≤ 1 % of setting value or 10 ms
 Test results/Remarks: |d| ≤ 1 % of setting value or 10 ms

1.20.7 Negative sequence V2

1.20.7.1 Pickup values

Test condition: $f_{rated} = 50 \text{ Hz}, 60\text{Hz}$
 0.300 V ≤ threshold value ≤ 200.000 V
 Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10 \%$
 |d| ≤ 0.5 % of setting value or 0.05 V
 Test results/Remarks: in the range $f_{rated} \pm 10 \%$
 |d| ≤ 0.5 % of setting value or 0.05 V

1.20.7.2 Dropout ratio

Test condition: See item 1.20.7.1
 Test values: $r = \text{setable dropout ratio}$
 0.90 ≤ r ≤ 0.99
 Permissive tolerance/Limiting values: |d| ≤ 0.5 % of dropout value or 0.05 V
 Test results/Remarks: |d| ≤ 0.5 % of dropout value or 0.05 V

1.20.7.3 Pickup times

Test condition: See item 1.20.7.1
 1.2* threshold value
 Permissive tolerance/Limiting values: t approx.
 Measuring window length 1 cycle: 55ms + OOT
 Measuring window length 10 cycles: 210ms + OOT
 (depends on the measuring window length) at $f_{rated} = 50 \text{ Hz}$
 Measuring window length 1 cycle: 48ms + OOT
 Measuring window length 10 cycles: 190ms + OOT
 (depends on the measuring window length) at $f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t approx.
 Measuring window length 1 cycle: 55ms + OOT
 Measuring window length 10 cycles: 210ms + OOT
 (depends on the measuring window length) at $f_{rated} = 50 \text{ Hz}$
 Measuring window length 1 cycle: 48ms + OOT
 Measuring window length 10 cycles: 190ms + OOT
 (depends on the measuring window length) at $f_{rated} = 60 \text{ Hz}$

1.20.7.4 Dropout times

Test condition: See item 1.20.7.1
 Permissive tolerance/Limiting values: t approx.
 Measuring window length 1 cycle: 20ms + OOT
 Measuring window length 10 cycles: 70ms + OOT
 (depends on the measuring window length)
 Test results/Remarks: t approx.
 Measuring window length 1 cycle: 20ms + OOT
 Measuring window length 10 cycles: 70ms + OOT
 (depends on the measuring window length)

1.20.7.5 Time delays

Test condition: See item 1.20.7.1

Summary

Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: |d| £ 1 % of setting value or 10 ms

1.20.8 Ratio of negative-sequence to positive-sequence, V2/V1

1.20.8.1 Pickup values

Test condition: $f_{rated} = 50 \text{ Hz}, 60\text{Hz}$
 0.5% £ threshold value £ 100%
 Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10 \%$
 |d| £ 0.5 % of setting value or 0.05 V
 Test results/Remarks: in the range $f_{rated} \pm 10 \%$
 |d| £ 0.5 % of setting value or 0.05 V

1.20.8.2 Dropout ratio

Test condition: See item 1.20.8.1
 Test values: $r = \text{setable dropout ratio}$
 0.90 £ r £ 0.99
 Permissive tolerance/Limiting values: |d| £ 0.5 % of setting value or 0.05 V
 Test results/Remarks: |d| £ 0.5 % of setting value or 0.05 V

1.20.8.3 Pickup times

Test condition See item 1.20.8.1
 1.2* threshold value
 Permissive tolerance/Limiting values: t approx.
 Measuring window length 1 cycle: 55ms + OOT
 Measuring window length 10 cycles: 210ms + OOT
 (depends on the measuring window length) at $f_{rated} = 50 \text{ Hz}$
 Measuring window length 1 cycle: 48ms + OOT
 Measuring window length 10 cycles: 190ms + OOT
 (depends on the measuring window length) at $f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t approx.
 Measuring window length 1 cycle: 55ms + OOT
 Measuring window length 10 cycles: 210ms + OOT
 (depends on the measuring window length) at $f_{rated} = 50 \text{ Hz}$
 Measuring window length 1 cycle: 48ms + OOT
 Measuring window length 10 cycles: 190ms + OOT
 (depends on the measuring window length) at $f_{rated} = 60 \text{ Hz}$

1.20.8.4 Dropout times

Test condition: See item 1.20.8.1
 Permissive tolerance/Limiting values: t approx.
 Measuring window length 1 cycle: 22ms + OOT
 Measuring window length 10 cycles: 55ms + OOT
 (depends on the measuring window length) at $f_{rated} = 50 \text{ Hz}$
 Measuring window length 1 cycle: 18ms + OOT
 Measuring window length 10 cycles: 45ms + OOT
 (depends on the measuring window length) at $f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t approx.
 Measuring window length 1 cycle: 22ms + OOT
 Measuring window length 10 cycles: 55ms + OOT
 (depends on the measuring window length) at $f_{rated} = 50 \text{ Hz}$

Summary

Measuring window length 1 cycle: 18ms + OOT
Measuring window length 10 cycles: 45ms + OOT
(depends on the measuring window length) at $f_{\text{rated}} = 60 \text{ Hz}$

1.20.8.5 Time delays

Test condition:	See item 1.20.8.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

Summary

1.21 27 Undervoltage Protection

1.21.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-127

1.21.2 3ph Voltage ph-to-gnd, ph-to-ph define time with definite time undervoltage stages

1.21.2.1 Pickup values

Test condition:	fundamental components, RMS values 0.300 V £ threshold value £ 175.000 V
Permissive tolerance/Limiting values:	in the range $f_{rated} \pm 10\%$ d £ 0.5 % of setting value or 0.05 V
Test results/Remarks:	in the range $f_{rated} \pm 10\%$ d £ 0.5 % of setting value or 0.05 V

1.21.2.2 Dropout ratio

Test condition:	see item 1.21.2.1
Test values:	r = setable dropout ratio 1.01 £ r £ 1.20
Permissive tolerance/Limiting values:	d £ 0.5 % of dropout value or 0.05 V
Test results/Remarks:	d £ 0.5 % of dropout value or 0.05 V

1.21.2.3 Pickup times

Test condition	see item 1.21.2.1 0.8* threshold value no pickup delay
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz

1.21.2.4 Pickup delay

Test condition	see item 1.21.2.1 0.8* pickup value
Permissive tolerance/Limiting values:	t approx. 40 ms
Test results/Remarks:	t approx. 40 ms

1.21.2.5 Dropout times

Test condition:	see item 1.21.2.1
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT

1.21.2.6 Time delays

Test condition:	see item 1.21.2.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

1.21.3 3ph Voltage ph-to-gnd, ph-to-ph with inverse time undervoltage stages

1.21.3.1 Pickup values

Test condition:	fundamental components, RMS values 0.300 V £ threshold value £ 175.000 V
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Summary

Permissive tolerance/Limiting values:	in the range $f_{rated} \pm 10\%$ d £ 0.5 % of setting value or 0.05 V
Test results/Remarks:	in the range $f_{rated} \pm 10\%$ d £ 0.5 % of setting value or 0.05 V
1.21.3.2 Dropout ratio	
Test condition:	see item 1.21.3.1
Test values:	1.05
Permissive tolerance/Limiting values:	d £ 0.5 % of dropout value or 0.05 V
Test results/Remarks:	d £ 0.5 % of dropout value or 0.05 V
1.21.3.3 Pickup times	
Test condition	see item 1.21.3.1 0.8* pickup value no pickup delay
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
1.21.3.4 Pickup delay	
Test condition	see item 1.21.3.1 0.8* pickup value
Permissive tolerance/Limiting values:	t approx. 40 ms
Test results/Remarks:	t approx. 40 ms
1.21.3.5 Dropout times	
Test condition:	see item 1.21.3.1 with no reset time
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT
Test results/Remarks:	t approx. 20 ms + OOT
1.21.3.6 Inverse time characteristics	
Test condition:	see item 1.21.3.1 0.8*pickup value
Test values:	Charact.constant k: 0.00 £ k £ 300.00 Charact.constant α : 0.010 £ α £ 5.000 Charact.constant c: 0.000 £ c £ 5.000 Time dial: 0.05 £ T £ 15.00
Permissive tolerance/Limiting values:	5 % of setting value or 30 ms
Test results/Remarks:	5 % of setting value or 30 ms
1.21.3.7 Definite Time delays	
Test condition:	see item 1.21.3.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms
1.21.3.8 Reset Time	
Test condition:	see item 1.21.3.1
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

Summary

1.21.4 Positive-Sequence Voltage V1

1.21.4.1 Pickup values

Test condition: fundamental components, RMS values
0.300 V £ threshold value £ 200.000 V

Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10\%$
|d| £ 0.5 % of setting value or 0.05 V

Test results/Remarks: in the range $f_{rated} \pm 10\%$
|d| £ 0.5 % of setting value or 0.05 V

1.21.4.2 Dropout ratio

Test condition: see item 1.21.4.1

Test values: $r =$ setable dropout ratio
1.01 £ r £ 1.20

Permissive tolerance/Limiting values: |d| £ 0.5 % of dropout value or 0.05 V

Test results/Remarks: |d| £ 0.5 % of dropout value or 0.05 V

1.21.4.3 Pickup times

Test condition see item 1.21.4.1
0.8* threshold value

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at $f_{rated} = 50$ Hz
22 ms + OOT at $f_{rated} = 60$ Hz

Test results/Remarks: t approx.
25 ms + OOT at $f_{rated} = 50$ Hz
22 ms + OOT at $f_{rated} = 60$ Hz

1.21.4.4 Dropout times

Test condition: see item 1.21.4.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
20 ms + OOT

1.21.4.5 Time delays

Test condition: see item 1.21.4.1

Test values: 0.00 s £ T £ 60.00 s

Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms

Test results/Remarks: |d| £ 1 % of setting value or 10 ms

1.21.5 Any Voltage Vx

1.21.5.1 Pickup values

Test condition: fundamental components, RMS values
0.300 V £ threshold value £ 200.000 V

Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10\%$
|d| £ 0.5 % of setting value or 0.05 V

Test results/Remarks: in the range $f_{rated} \pm 10\%$
|d| £ 0.5 % of setting value or 0.05 V

1.21.5.2 Dropout ratio

Test condition: see item 1.21.5.1

Test values: $r =$ setable dropout ratio
1.01 £ r £ 1.20

Permissive tolerance/Limiting values: |d| £ 0.5 % of dropout value or 0.05 V

Test results/Remarks: |d| £ 0.5 % of dropout value or 0.05 V

1.21.5.3 Pickup times

Test condition see item 1.21.5.1
0.8* threshold value

Summary

Permissive tolerance/Limiting values: t approx.
25 ms + OOT at $f_{rated} = 50$ Hz
22 ms + OOT at $f_{rated} = 60$ Hz

Test results/Remarks: t approx.
25 ms + OOT at $f_{rated} = 50$ Hz
22 ms + OOT at $f_{rated} = 60$ Hz

1.21.5.4 Dropout times

Test condition: see item 1.21.5.1

Permissive tolerance/Limiting values: t approx.
20 ms + OOT

Test results/Remarks: t approx.
20 ms + OOT

1.21.5.5 Time delays

Test condition: see item 1.21.5.1

Test values: 0.00 s \leq T \leq 60.00 s

Permissive tolerance/Limiting values: |d| \leq 1 % of setting value or 10 ms

Test results/Remarks: |d| \leq 1 % of setting value or 10 ms

Summary

1.22 51Ns Sensitive Ground Fault Protection

1.22.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.22.2 3I0

1.22.2.1 Pickup values

Test condition:	0.030 I _{rated} £ 3I0 > £ 35.000 I _{rated} for CT protection 0.001 I _{rated} £ 3I0 > £ 35.000 I _{rated} for CT sensitive
Test values:	f _{rated} = 50 Hz, 60 Hz 0.030 I _{rated} £ 3I0 > £ 35.000 I _{rated} for CT protection 0.001 I _{rated} £ 3I0 > £ 35.000 I _{rated} for CT sensitive
Permissive tolerance/Limiting values:	For CT protection: d £ 1 % of setting value or 0.5% of I _{rated} For CT sensitive: d £ 1 % of setting value or 0.01% of I _{rated}
Test results/Remarks:	For CT protection: d £ 1 % of setting value or 0.5% of I _{rated} For CT sensitive: d £ 1 % of setting value or 0.01% of I _{rated}

1.22.2.2 Dropout ratio

Test condition:	see item 1.22.2.1
Test values:	see item 1.22.2.1
Permissive tolerance/Limiting values:	0.95 (fixed)
Test results/Remarks:	0.95 (fixed)

1.22.2.3 Pickup times

Test condition:	see item 1.22.2.1
Test values:	I/I _{rated} = 2
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at f _{rated} = 50 Hz 23 ms + OOT at f _{rated} = 60 Hz
Test results/Remarks:	t approx. 25 ms + OOT at f _{rated} = 50 Hz 23 ms + OOT at f _{rated} = 60 Hz

1.22.2.4 Dropout times

Test condition:	see item 1.22.2.1
Test values:	see item 1.22.2.1
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at f _{rated} = 50 Hz 22 ms + OOT at f _{rated} = 60 Hz
Test results/Remarks:	t approx. 25 ms + OOT at f _{rated} = 50 Hz 22 ms + OOT at f _{rated} = 60 Hz

1.22.2.5 Time delays

Test condition:	added to the inherent operating times
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

Summary

1.22.3 Admittance protection stage Y0>

1.22.3.1 Pickup values Y0>

Test condition:	Fundamental components, RMS values 0.10 mS £ Y0> £ 100.00 mS
Test values:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
Permissive tolerance/Limiting values:	For CT protection: d £ 1 % of setting value or 1% of I_{rated} For CT measurement: d £ 1 % of setting value or 0.1% of I_{rated}
Test results/Remarks:	For CT protection: d £ 1 % of setting value or 1% of I_{rated} For CT measurement: d £ 1 % of setting value or 0.1% of I_{rated}

1.22.3.2 Threshold values V0>

Test condition:	0.300 V £V0> £ 200.000V
Test values:	0.300 V £V0> £ 200.000V
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 0.5 V
Test results/remarks:	d £ 1 % of setting value or 0.5 V

1.22.3.3 Pickup time

Test condition:	see item 1.22.3.1
Test values:	$I/I_{rated} = 2$
Permissive tolerance/Limiting values:	t approx. 32 ms + OOT at 50 Hz 29 ms + OOT at 60 Hz
Test results/Remarks:	t approx. 32 ms + OOT at 50 Hz 29 ms + OOT at 60 Hz

1.22.3.4 Dropout times

Test condition:	see item 1.22.3.1
Test values:	see item 1.22.3.1
Permissive tolerance/Limiting values:	t approx. 32 ms + OOT
Test results/Remarks:	t approx. 32 ms + OOT

1.22.3.5 Time delays

Test condition:	added to the inherent operating times
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % from setting value or 10 ms
Test results/Remarks:	d < 1 % or 10 ms

Summary

1.23 67Ns Directional Sensitive Ground Fault Protection

1.23.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.23.2 3I0 stage

1.23.2.1 Pickup values

Test condition:	Fundamental components, RMS values 0.030 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT protection 0.001 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT sensitive
Test values:	f_{rated} = 50 Hz, 60 Hz 0.030 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT protection
Permissive tolerance/Limiting values:	For CT protection: d £ 1 % from setting value or 1% of I_{rated} For CT measurement: d £ 1 % from setting value or 0.1% of I_{rated}
Test results/Remarks:	d < 1 %

1.23.2.2 Dropout ratio

Test condition:	see item 1.23.2.1
Test values:	see item 1.23.2.1
Permissive tolerance/Limiting values:	approx. 0.95
Test results/Remarks:	0.93...0.97

1.23.2.3 Pickup times

Test condition:	see item 1.23.2.1
Test values:	$I/I_{rated} = 2$
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 23 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 23 ms + OOT at $f_{rated} = 60$ Hz

1.23.2.4 Dropout times

Test condition:	see item 1.23.2.1
Test values:	see item 1.23.2.1
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT
Test results/Remarks:	t approx. 25 ms + OOT

1.23.2.5 Time delays

Test condition:	added to the inherent operating times
Test values:	0.00 s £ T > £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % from setting value or 10 ms
Test results/Remarks:	d < 1 % or 10 ms

Summary

1.23.3 3I0 with cos φ - or sin φ -measurement stage

1.23.3.1 Pickup values 3I0

Test condition:	Fundamental components, RMS values 0.030 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT protection 0.001 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT sensitive
Test values:	f_{rated} = 50 Hz, 60 Hz 0.030 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT protection ¹
Permissive tolerance/Limiting values:	For CT protection: d £ 1 % from setting value or 1% of I_{rated} For CT measurement: d £ 1 % from setting value or 0.1% of I_{rated}
Test results/Remarks:	d < 1 %

1.23.3.2 Pickup values V0

Test condition:	f_{rated} = 50 Hz, 60 Hz 0.300 V £ V0 > £ 200.000 V
Test values:	0.300 V £ V0 > £ 200.000 V
Permissive tolerance/Limiting values:	d £ 1 % from setting value or 0.05 V
Test results/Remarks:	d < 1 % or 0.05 V

1.23.3.3 Angle correction φ

Test condition:	-45° £ φ £ 45°
Test values:	-45° £ φ £ 45°
Permissive tolerance/Limiting values:	d £ 1° at 3I0 > 5 mA, V0 > = 0.6 V
Test results/Remarks:	d < 1° at 3I0 > 5 mA, V0 > = 0.6 V

1.23.3.4 Dropout ratio

Test condition:	see item 1.23.3.1 and 1.23.3.2
Test values:	see item 1.23.3.1 and 1.23.3.2
Permissive tolerance/Limiting values:	approx. 0.95
Test results/Remarks:	0.93...0.97

1.23.3.5 Pickup times

Test condition:	see item 1.23.3.1 and 1.23.3.2
Test values:	I/I_{rated} = 2
Permissive tolerance/Limiting values:	t approx. 32 ms + OOT at f_{rated} = 50 Hz 29 ms + OOT at f_{rated} = 60 Hz
Test results/Remarks:	t approx. 32 ms + OOT at f_{rated} = 50 Hz 29 ms + OOT at f_{rated} = 60 Hz

1.23.3.6 Dropout times

Test condition:	see item 1.23.3.1 and 1.23.3.2
Test values:	see item 1.23.3.1 and 1.23.3.2
Permissive tolerance/Limiting values:	t approx. 32 ms + OOT
Test results/Remarks:	t approx. 32 ms + OOT

1.23.3.7 Time delays

Test condition:	added to the inherent operating times
Test values:	0.00 s £ T > £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % from setting value or 10 ms
Test results/Remarks:	d < 1 % or 10 ms

Summary

1.23.4 3I0 with φ (V,I)-measurement stage

1.23.4.1 Pickup values 3I0

Test condition:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ Fundamental components, RMS values $0.030 I_{rated} \text{ } \text{£} 3I0 > \text{£} 35.000 I_{rated}$ for CT protection $0.001 I_{rated} \text{ } \text{£} 3I0 > \text{£} 35.000 I_{rated}$ for CT sensitive
Test values:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $0.030 I_{rated} \text{ } \text{£} 3I0 > \text{£} 35.000 I_{rated}$ for CT protection
Permissive tolerance/Limiting values:	For CT protection: $ d \text{ } \text{£} 1 \% \text{ from setting value or } 1\% \text{ of } I_{rated}$ For CT measurement: $ d \text{ } \text{£} 1 \% \text{ from setting value or } 0.1\% \text{ of } I_{rated}$
Test results/Remarks:	$ d < 1 \%$

1.23.4.2 Pickup values V0

Test condition:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $0.300 \text{ V } \text{£} V0 > \text{£} 200.000 \text{ V}$
Test values:	$0.300 \text{ V } \text{£} V0 > \text{£} 200.000 \text{ V}$
Permissive tolerance/Limiting values:	$ d \text{ } \text{£} 1 \% \text{ from setting value or } 0.05 \text{ V}$
Test results/Remarks:	$ d < 1 \% \text{ or } 0.05 \text{ V}$

1.23.4.3 Rotation angle of the reference voltage

Test condition:	$-180^\circ \text{ } \text{£} \varphi \text{ } \text{£} 180^\circ$
Test values:	$-180^\circ \text{ } \text{£} \varphi \text{ } \text{£} 180^\circ$
Permissive tolerance/Limiting values:	$ d \text{ } \text{£} 1^\circ \text{ at } 3I0 > 5 \text{ mA}, V0 \geq 0.6 \text{ V}$
Test results/Remarks:	$ d \text{ } \text{£} 3^\circ \text{ at } 3I0 \text{ } \text{£} 2 \text{ mA}, V0 \geq 0.6 \text{ V}$ $ d \text{ } \text{£} 2^\circ \text{ at } 2 \text{ mA} < 3I0 < 10 \text{ mA}, V0 \geq 0.6 \text{ V}$ $ d \text{ } \text{£} 1^\circ \text{ at } 3I0 \geq 10 \text{ mA}, V0 \geq 0.6 \text{ V}$

1.23.4.4 Dropout ratio

Test condition:	see item 1.23.4.1 and 1.23.4.2
Test values:	see item 1.23.4.1 and 1.23.4.2
Permissive tolerance/Limiting values:	0.5% of dropout value or 15mA
Test results/Remarks:	0.5% of dropout value or 15mA

1.23.4.5 Pickup times

Test condition:	see item 1.23.4.1 and 1.23.4.2
Test values:	1.2*threshold
Permissive tolerance/Limiting values:	t approx. 23 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 21 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Test results/Remarks:	t approx. 23 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 21 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.23.4.6 Dropout times

Test condition:	see item 1.23.4.1 and 1.23.4.2
Permissive tolerance/Limiting values:	t approx. 21 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 20 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Test results/Remarks:	t approx. 21 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 20 ms + OOT at $f_{rated} = 60 \text{ Hz}$

Summary

1.23.4.7 Time delays

Test condition: see item 1.23.4.1 and 1.23.4.2
1.2*threshold
Test values: 0.00 s ≤ T < 60.00 s
Permissive tolerance/Limiting values: ≤ 1 % of setting value or 10 ms
Test results/Remarks: ≤ 1 % of setting value or 10 ms

1.23.5 Overvoltage protection stage V0>

1.23.5.1 Pickup values

Test condition: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
Fundamental components, RMS values
0.300 V ≤ V0 < 200.000 V
Test values: 0.300 V ≤ V0 < 200.000 V
Permissive tolerance/Limiting values: |d| ≤ 0.5 % from setting value or 0.05 V
Test results/Remarks: |d| < 0.5 % or 0.05 V

1.23.5.2 Dropout ratio

Test condition: r = settable dropout ratio
0.90 ≤ r ≤ 0.99
Test values: 0.90 ≤ r ≤ 0.99
Test results/Remarks: 0.90 ≤ r ≤ 0.99

1.23.5.3 Pickup times

Test condition: see item 1.23.5.1
Test values: see item 1.23.5.1
Permissive tolerance/Limiting values: t approx.
RMS values, standard filter:
25 ms + OOT at $f_{rated} = 50 \text{ Hz}$
22 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Fundamental components, filter over 2 cycles:
45 ms + OOT at $f_{rated} = 50 \text{ Hz}$
39 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Test results/Remarks: t approx.
RMS values, standard filter:
25 ms + OOT at $f_{rated} = 50 \text{ Hz}$
22 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Fundamental components, filter over 2 cycles:
45 ms + OOT at $f_{rated} = 50 \text{ Hz}$
39 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.23.5.4 Dropout times

Test condition: see item 1.23.5.1
Test values: see item 1.23.5.1
Permissive tolerance/Limiting values: t approx.
RMS values, standard filter:
21 ms + OOT
Fundamental components, filter over 2 cycles:
30 ms + OOT
Test results/Remarks: t approx.
RMS values, standard filter:
21 ms + OOT
Fundamental components, filter over 2 cycles:
30 ms + OOT

1.23.5.5 Time delays

Test condition: added to the inherent operating times
Test values: 0.00 s ≤ T < 60.00 s
Permissive tolerance/Limiting values: |d| ≤ 1 % from setting value or 10 ms
Test results/Remarks: |d| < 1 % or 10 ms

Summary

1.23.6 Transient ground fault protection stage

1.23.6.1 Pickup values 3I0

Test condition:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ Fundamental components, RMS values $0.030 I_{rated} \text{ } \text{£} 3I0 > \text{£} 35.000 I_{rated}$ for CT protection $0.001 I_{rated} \text{ } \text{£} 3I0 > \text{£} 35.000 I_{rated}$ for CT sensitive
Test values:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $0.030 I_{rated} \text{ } \text{£} 3I0 > \text{£} 35.000 I_{rated}$ for CT protection
Permissive tolerance/Limiting values:	For CT protection: $ d \text{ } \text{£} 1 \% \text{ from setting value or } 1\% \text{ of } I_{rated}$ For CT measurement: $ d \text{ } \text{£} 1 \% \text{ from setting value or } 0.1\% \text{ of } I_{rated}$
Test results/Remarks:	For CT protection: $ d \text{ } \text{£} 1 \% \text{ from setting value or } 1\% \text{ of } I_{rated}$ For CT measurement: $ d \text{ } \text{£} 1 \% \text{ from setting value or } 0.1\% \text{ of } I_{rated}$

1.23.6.2 Pickup values V0

Test condition:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $0.300 \text{ V } \text{£} V0 > \text{£} 200.000 \text{ V}$
Test values:	$0.300 \text{ V } \text{£} V0 > \text{£} 200.000 \text{ V}$
Permissive tolerance/Limiting values:	$ d \text{ } \text{£} 1 \% \text{ from setting value or } 0.05 \text{ V}$
Test results/Remarks:	$ d \text{ } \text{£} 1 \% \text{ from setting value or } 0.05 \text{ V}$

1.23.6.3 Pickup times

Test condition:	see item 1.23.6.1 and 1.23.6.2
Test values:	$I/I_{rated} = 2$
Permissive tolerance/Limiting values:	t approx. 60 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 55 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Test results/Remarks:	t approx. 60 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 55 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.23.6.4 Dropout times

Test condition:	see item 1.23.6.1 and 1.23.6.2
Test values:	see item 1.23.6.1 and 1.23.6.2
Permissive tolerance/Limiting values:	t approx. 20 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 15 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Test results/Remarks:	t approx. 20 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 15 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.23.6.5 Time delays

Test condition:	added to the inherent operating times
Test values:	$0.00 \text{ s } \text{£} T > \text{£} 60.00 \text{ s}$
Permissive tolerance/Limiting values:	$ d \text{ } \text{£} 1 \% \text{ from setting value or } 10 \text{ ms}$
Test results/Remarks:	$ d < 1 \% \text{ or } 10 \text{ ms}$

Summary

1.23.7 Y0-with G0 or B0-measurement stage

1.23.7.1 Pickup values 3I0>

Test condition:	Fundamental components, RMS values 0.030 I _{rated} £ 3I0> £ 35.000 I _{rated} for CT protection 0.001 I _{rated} £ 3I0> £ 35.000 I _{rated} for CT sensitive
Test values:	f _{rated} = 50 Hz, 60 Hz 0.030 I _{rated} £ 3I0> £ 35.000 I _{rated} for CT protection
Permissive tolerance/Limiting values:	For CT protection: d £ 1 % from setting value or 1% of I _{rated} For CT measurement: d £ 1 % from setting value or 0.1% of I _{rated}
Test results/Remarks:	For CT protection: d £ 1 % from setting value or 1% of I _{rated} For CT measurement: d £ 1 % from setting value or 0.1% of I _{rated}

1.23.7.2 Pickup values V0>

Test condition:	0.300 V £V0> £ 200.000V
Test values:	0.300 V £V0> £ 200.000V
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 0.05 V
Test results/remarks:	d £ 1 % of setting value or 0.05 V

1.23.7.3 Angle correction φ

Test condition:	-45° £ φ £ 45°
Test values:	-45° £ φ £ 45°
Permissive tolerance/Limiting values:	d £ 1° at 3I0 > 5 mA, V0> = 0.6 V
Test results/Remarks:	d £ 1° at 3I0 > 5 mA, V0> = 0.6 V

1.23.7.4 Pickup time

Test condition:	see item 1.23.7.1
Test values:	I/I _{rated} = 2
Permissive tolerance/Limiting values:	t approx. 32 ms + OOT at 50 Hz 29 ms + OOT at 60 Hz
Test results/Remarks:	t approx. 32 ms + OOT at 50 Hz 29 ms + OOT at 60 Hz

1.23.7.5 Dropout times

Test condition:	see item 1.23.7.1
Test values:	see item 1.23.7.1
Permissive tolerance/Limiting values:	t approx. 32 ms + OOT at 50 Hz 27 ms + OOT at 60 Hz
Test results/Remarks:	t approx. 32 ms + OOT at 50 Hz 27 ms + OOT at 60 Hz

1.23.7.6 Time delays

Test condition:	added to the inherent operating times
Test values:	0.00 s £ T> £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % from setting value or 10 ms
Test results/Remarks:	d £ 1 % from setting value or 10 ms

Summary

1.23.7.7 Polarized G0/B0 threshold

Test condition: 0.10 mS £ Y0 £ 100.00 mS
 Test values: 0.10 mS £ Y0 £ 100.00 mS
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 0.05 mS ($I_{rated}=1A/1.6A$) or 0.25 mS ($I_{rated}=5A/8A$)
 Test results/Remarks: |d| £ 1 % of setting value or 0.05 mS ($I_{rated}=1A/1.6A$) or 0.25 mS ($I_{rated}=5A/8A$)

1.23.8 Admittance protection stage Y0>

1.23.8.1 Pickup values Y0>

Test condition: Fundamental components, RMS values
0.10 mS £ Y0> £ 100.00 mS
 Test values: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 Permissive tolerance/Limiting values: For CT protection:
|d| £ 1 % of setting value or 1% of I_{rated}
For CT measurement:
|d| £ 1 % of setting value or 0.1% of I_{rated}
 Test results/Remarks: For CT protection:
|d| £ 1 % of setting value or 1% of I_{rated}
For CT measurement:
|d| £ 1 % of setting value or 0.1% of I_{rated}

1.23.8.2 Threshold values V0>

Test condition: 0.300 V £V0> £ 200.000V
 Test values: 0.300 V £V0> £ 200.000V
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 0.5 V
 Test results/remarks: |d| £ 1 % of setting value or 0.5 V

1.23.8.3 Pickup time

Test condition: see item 1.23.8.1
 Test values: $I/I_{rated} = 2$
 Permissive tolerance/Limiting values: t approx.
32 ms + OOT at 50 Hz
29 ms + OOT at 60 Hz
 Test results/Remarks: t approx.
32 ms + OOT at 50 Hz
29 ms + OOT at 60 Hz

1.23.8.4 Dropout times

Test condition: see item 1.23.8.1
 Test values: see item 1.23.8.1
 Permissive tolerance/Limiting values: t approx.
32 ms + OOT
 Test results/Remarks: t approx.
32 ms + OOT

1.23.8.5 Time delays

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T> £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % from setting value or 10 ms
 Test results/Remarks: |d| < 1 % or 10 ms

1.23.9 pulse-pattern detection stage

1.23.9.1 Threshold values V0>

Test condition: 0.300 V £V0> £ 200.000V
 Test values: 0.300 V £V0> £ 200.000V
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 0.05 V
 Test results/remarks: |d| £ 1 % of setting value or 0.05 V

Summary

1.23.9.2 Threshold values 3I0>

Test condition: 0.030 I_{rated} £ 3I0> £ 35.000 I_{rated} for CT protection
0.001 I_{rated} £ 3I0> £ 35.000 I_{rated} for CT sensitive

Test values: f_{rated} = 50 Hz, 60 Hz
0.001 I_{rated} £ 3I0> £ 35.000 I_{rated} for CT sensitive

Permissive tolerance/Limiting values: For CT protection:
|d| £ 1 % from setting value or 0.5% of I_{rated}
For CT measurement:
|d| £ 1 % from setting value or 0.01% of I_{rated}

Test results/Remarks: For CT protection:
|d| £ 1 % from setting value or 0.5% of I_{rated}
For CT measurement:
|d| £ 1 % from setting value or 0.01% of I_{rated}

1.23.9.3 Pickup time

Test condition: Pulse-on duration=1s, Pulse-off duration=1.5s, Max.tolera.pulse-on or off=0.15s¹

Test values: see item 1.23.9.1 and 1.23.9.2

Permissive tolerance/Limiting values: t approx.
2.5s + 0.3s + OOT

Test results/Remarks: t approx.
2.5s + 0.3s + OOT

1.23.9.4 Dropout times

Test condition: see item 1.23.9.1

Test values: see item 1.23.9.1

Permissive tolerance/Limiting values: t approx.
32 ms + OOT

Test results/Remarks: t approx.
32 ms + OOT

1.23.10 Directional stage with phasor measurement of a harmonic

1.23.10.1 Threshold values V0>

Test condition: 0.300 V £V0> £ 200.000V

Test values: 0.300 V £V0> £ 200.000V

Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 0.05 V

Test results/remarks: |d| £ 1 % of setting value or 0.05 V

1.23.10.2 Threshold values 3I0> harmonic

Test condition: 0.030 I_{rated} £ 3I0> £ 35.000 I_{rated} for CT protection
0.001 I_{rated} £ 3I0> £ 35.000 I_{rated} for CT sensitive

Test values: f_{rated} = 50 Hz, 60 Hz
0.030 I_{rated} £ 3I0> £ 35.000 I_{rated} for CT protection
0.001 I_{rated} £ 3I0> £ 35.000 I_{rated} for CT sensitive

Permissive tolerance/Limiting values: For CT protection:
|d| £ 1 % of setting value or 0.5% of I_{rated}
For CT measurement:
|d| £ 1 % of setting value or 0.01% of I_{rated}

Test results/Remarks: For CT protection:
|d| £ 1 % of setting value or 0.5% of I_{rated}
For CT measurement:
|d| £ 1 % of setting value or 0.01% of I_{rated}

1.23.10.3 Pickup time

Test condition: see item 1.23.10.1 and 1.23.10.2

Test values: 1.2*Threshold

¹ After the first valid pulse is detected, the function picks up. For a typical Pulse-on/off duration setting of e.g. 1.0/1.5 s, a typical Max.tolera.pulse-on or off setting of e.g. 0.15s, the inherent pickup time is approx. 1s+1.5s+2*0.15s+OOT.

Summary

Permissive tolerance/Limiting values: t approx.
70 ms + OOT at 50 Hz
60 ms + OOT at 60 Hz

Test results/Remarks: t approx.
70 ms + OOT at 50 Hz
60 ms + OOT at 60 Hz

1.23.10.4 Dropout times

Test condition: see item 1.23.10.1 and 1.23.10.2

Test values: see item 1.23.10.1 and 1.23.10.2

Permissive tolerance/Limiting values: t approx.
30 ms + OOT at 50 Hz
20 ms + OOT at 60 Hz

Test results/Remarks: t approx.
30 ms + OOT at 50 Hz
20 ms + OOT at 60 Hz

1.23.10.5 Dropout ratio 310 harmonic

Test condition: see item 1.23.10.2

Test values: see item 1.23.10.2

Permissive tolerance/Limiting values: For CT protection:
 $|d| \leq 1\%$ of dropout value or 1.5% of I_{rated}
For CT measurement:
 $|d| \leq 1\%$ of dropout value or 0.05% of I_{rated}

Test results/Remarks: For CT protection:
 $|d| \leq 1\%$ of dropout value or 1.5% of I_{rated}
For CT measurement:
 $|d| \leq 1\%$ of dropout value or 0.05% of I_{rated}

1.23.10.6 Time delays

Test condition: added to the inherent operating times

Test values: 0.00 s $\leq T \leq$ 60.00 s

Permissive tolerance/Limiting values: $|d| \leq 1\%$ from setting value or 10 ms

Test results/Remarks: $|d| \leq 1\%$ from setting value or 10 ms

Summary

1.24 Non-Directional Intermittent-Ground-Fault-Protection

1.24.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC60255-151

1.24.2 Intermittent ground fault protection stage

1.24.2.1 Pickup values 3I0>

Test condition:	Fundamental components, RMS values 0.030 I _{rated} £ 3I0> £ 35.000 I _{rated} for CT protection 0.001 I _{rated} £ 3I0> £ 1.600 I _{rated} for CT sensitive
Test values:	f _{rated} = 50 Hz, 60 Hz 0.030 I _{rated} £ 3I0> £ 35.000 I _{rated} for CT protection 0.001 I _{rated} £ 3I0> £ 1.600 I _{rated} for CT sensitive
Permissive tolerance/Limiting values:	For CT protection: d £ 1 % of setting value or 0.005 I _{rated} For CT sensitive: d £ 1 % of setting value or 0.0001 I _{rated}
Test results/Remarks:	For CT protection: d £ 1 % of setting value or 0.005 I _{rated} For CT sensitive: d £ 1 % of setting value or 0.0001 I _{rated}

1.24.2.2 Dropout ratio

Test condition:	see item 1.24.2.1
Test values:	see item 1.24.2.1
Permissive tolerance/Limiting values:	approx. 0.95
Test results/Remarks:	approx. 0.95

1.24.2.3 Pickup time

Test condition:	see item 1.24.2.1
Test values:	I/I _{rated} = 2
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at 50 Hz 23 ms + OOT at 60 Hz
Test results/Remarks:	t approx. 25 ms + OOT at 50 Hz 23 ms + OOT at 60 Hz

1.24.2.4 Dropout times

Test condition:	see item 1.24.2.1
Test values:	see item 1.24.2.1
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at 50 Hz 22 ms + OOT at 60 Hz
Test results/Remarks:	t approx. 25 ms + OOT at 50 Hz 22 ms + OOT at 60 Hz

1.24.2.5 Pickup extension time

Test condition:	0.00 s £ T £ 10.00 s
Test values:	0.00 s £ T £ 10.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

Summary**1.24.2.6 Sum of extended pickup times**

Test condition:	0.00 s £ T £ 100.00 s
Test values:	0.00 s £ T £ 100.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

1.24.2.7 Reset time

Test condition:	0.00 s £ T £ 600.00 s
Test values:	0.00 s £ T £ 600.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d £ 1 % of setting value or 10 ms

Summary

1.25 Directional Intermittent Ground Fault Protection

1.25.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.25.2 Pickup values

Test condition:	0.030 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT type: protection 0.001 I_{rated} £ 3I0 > £ 1.600 I_{rated} for CT type: sensitive
Test values:	$I_{rated}=1A$, $f_{rated} = 50$ Hz: 0.030 I_{rated} £ 3I0 > £ 35.000 I_{rated} for CT type: protection 0.001 I_{rated} £ 3I0 > £ 1.600 I_{rated} for CT type: sensitive $I_{rated}=5A$, $f_{rated} = 60$ Hz: 0.030 I_{rated} £ 3I0 > £ 20.000 I_{rated} for CT type: 4* protection 0.001 I_{rated} £ 3I0 > £ 1.600 I_{rated} for CT type: sensitive
Permissive tolerance/Limiting values:	For CT protection: £ 1 % of setting value or 0.5% of I_{rated} For CT sensitive: £ 1 % of setting value or 0.01% of I_{rated}
Test results/Remarks:	For CT protection: £ 1 % of setting value or 0.5% of I_{rated} For CT sensitive: £ 1 % of setting value or 0.01% of I_{rated}

1.25.3 Dropout ratio

Test condition:	see item 1.25.2
Test values:	see item 1.25.2
Permissive tolerance/Limiting values:	approx. 0.95
Test results/Remarks:	For CT protection: £ 1 % of setting value or 2% of I_{rated} For CT sensitive: £ 1 % of setting value or 0.06% of I_{rated}

1.25.4 Pickup times

Test condition:	see item 1.25.2
Test values:	$I/I_{rated} = 1.2$
Permissive tolerance/Limiting values:	t approx. 30 ms + OOT at $f_{rated} = 50$ Hz 23 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	30 ms + OOT at $f_{rated} = 50$ Hz 23 ms + OOT at $f_{rated} = 60$ Hz

1.25.5 Dropout times

Test condition:	see item 1.25.2
Permissive tolerance/Limiting values:	t approx. 25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz
Test results/Remarks:	25 ms + OOT at $f_{rated} = 50$ Hz 22 ms + OOT at $f_{rated} = 60$ Hz

1.25.6 Pickup extension time

Test condition:	see item 1.25.2
Test values:	0.00 s £ T £ 10.00 s
Permissive tolerance/Limiting values:	£ 1 % of setting value or 10 ms
Test results/Remarks:	£ 1 % of setting value or 10 ms

Summary**1.25.7 Sum of extended pickup times**

Test condition:	see item 1.25.2
Test values:	0.00 s £ T £ 100.00 s
Permissive tolerance/Limiting values:	£ 1 % of setting value or 10 ms
Test results/Remarks:	£ 1 % of setting value or 10 ms

1.25.8 Reset time

Test condition:	see item 1.25.2
Test values:	1.00 s £ T £ 600.00 s
Permissive tolerance/Limiting values:	£ 1 % of setting value or 10 ms
Test results/Remarks:	£ 1 % of setting value or 10 ms

Summary

1.26 87N Restricted Earth Fault Protection ($I_{REF>}$)

1.26.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.26.2 Pickup value ($I_{REF>}$)

Test condition: $0.05 \times I_{REF>} / I_{rated} / r_{Obj} \times 2.00$
 Test values: $0.05 \times I_{REF>} / I_{rated} / r_{Obj} \times 2.00$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 Permissive tolerance/Limiting values: $|d| \times 2 \% \text{ of setting value at } I < 5 I_{rated}$
 Test results/Remarks: $|d| < 2 \% \text{ of setting value at } I < 5 I_{rated}$

1.26.3 Pickup times ($I_{REF>}$)

1.26.3.1 1.5 x setting value ($I_{REF>}$)

Test condition: IEC/EN 60255-1
 Test values: $1.5 \times \text{setting value } I_{REF>}$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 Permissive tolerance/Limiting values: $t \text{ approx.}$
 $33 \text{ ms} + \text{OOT at } f_{rated} = 50 \text{ Hz}$
 $32 \text{ ms} + \text{OOT at } f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t
 $< 33 \text{ ms} + \text{OOT at } f_{rated} = 50 \text{ Hz}$
 $< 32 \text{ ms} + \text{OOT at } f_{rated} = 60 \text{ Hz}$

1.26.3.2 2.5 x setting value ($I_{REF>}$)

Test condition: see item 1.26.3.1
 Test values: $2.5 \times \text{setting value } I_{REF>}$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 Permissive tolerance/Limiting values: $t \text{ approx.}$
 $27 \text{ ms} + \text{OOT at } f_{rated} = 50 \text{ Hz}$
 $26 \text{ ms} + \text{OOT at } f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t
 $< 27 \text{ ms} + \text{OOT at } f_{rated} = 50 \text{ Hz}$
 $< 26 \text{ ms} + \text{OOT at } f_{rated} = 60 \text{ Hz}$

1.26.3.3 Dropout times

Test condition: see item 1.26.3.1
 Test values: see item 1.26.3.1
 Permissive tolerance/Limiting values: $t \text{ approx.}$
 $80 \text{ ms at } f_{rated} = 50 \text{ Hz}$
 $67 \text{ ms at } f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t
 $< 80 \text{ ms at } f_{rated} = 50 \text{ Hz}$
 $< 67 \text{ ms at } f_{rated} = 60 \text{ Hz}$

1.26.3.4 Time delays

Test condition: added to the inherent operating times
 Test values: $0.00 \text{ s} \leq T_D \leq 60.00 \text{ s}, \infty$
 Permissive tolerance/Limiting values: $|d| \leq 1 \% \text{ of setting value or } 10 \text{ ms}$
 Test results/Remarks: $|d| < 1 \% \text{ of setting value or } 10 \text{ ms}$

1.26.3.5 Dropout ratio ($I_{REF>}$)

Test condition: see item 1.26.3.1
 Test values: see item 1.26.3.1
 Permissive tolerance/Limiting values: $r \text{ approx. } 0.70$
 Test results/Remarks: $0.68 \leq r \leq 0.72$

Summary

1.27 Inrush-Current Detection

1.27.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.27.2 General test conditions

f_{rated} 50 Hz, 60 Hz

1.27.3 Operating-range limit I_{max}

Test condition: 0.030 I_{rated} £ I_{max} £ 35.000 I_{rated}

Test values: 0.030 I_{rated} £ I_{max} £ 35.000 I_{rated}

Permissive tolerance/Limiting values: $|d|$ £ 1 % of setting value or 0.005 I_{rated}

Test results/Remarks: $|d|$ £ 1 % of setting value or 0.005 I_{rated}

1.27.4 Content of 2nd harmonics

Test condition: 10 % £ $I/I_{2ndHarm}$. £ 45 %

Test values: 10 % £ $I/I_{2ndHarm}$. £ 45 %

Permissive tolerance/Limiting values: $|d|$ £ 1% of setting value

Test results/Remarks: $|d|$ < 1% of setting value

1.27.5 Duration of the cross-blocking

Test condition: 0.03 s £ T £ 200.00 s

Test values: 0.03 s £ T £ 200.00 s

Permissive tolerance/Limiting values: $|d|$ £ 1 % of setting value or 10 ms

Test results/Remarks: $|d|$ < 1 % of setting value or 10 ms

1.27.6 Pickup times

Permissive tolerance/Limiting values: approx. 29 ms + OOT

Test results/Remarks: approx. 29 ms + OOT

1.27.7 Dropout ratios

1.27.7.1 Current measurement I_{max}

Test condition: $r = 0.95$ or 0.015 A at $I_{rated} = 1$ A
 $r = 0.95$ or 0.075 A at $I_{rated} = 5$ A

Permissive tolerance/Limiting values: 1% of the setting value or 5mA

Test results/Remarks: 1% of the setting value or 5mA

1.27.7.2 Harmonics $I_{2.Harm}/I_{1.Harm}$

Test condition: $r = 0.95$

Permissive tolerance/Limiting values: 1% of the setting value for settings of $I_{2ndHarm}/I_{1stHarm}$ Time delays

Test results/Remarks: 1% of the setting value for settings of $I_{2ndHarm}/I_{1stHarm}$ Time delays

Summary**1.28 Jump Detection****1.28.1 Current jump detection ¹****1.28.1.1 Pickup values**

Test condition:	L-N, 3I0 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $0.030 I_{rated} \leq I < 35.000 I_{rated}$
Permissive tolerance/Limiting values:	$ d \leq 3 \% \text{ of setting value or } 0.01 I_{rated}$
Test results/Remarks:	$ d \leq 3 \% \text{ of setting value or } 0.01 I_{rated}$

1.28.1.2 Pickup times

Test condition:	see item 1.28.1.1
Test values:	see item 1.28.1.1
Permissive tolerance/Limiting values:	t approx. 8 ms + OOT
Test results/Remarks:	t approx. 8 ms + OOT

1.28.2 Voltage jump detection**1.28.2.1 Pickup values**

Test condition:	L-N, L-L, V0 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $0.30V \leq V < 340.000 \text{ V}$
Permissive tolerance/Limiting values:	$ d \leq 2 \% \text{ of setting value or } 0.1 \text{ V}$
Test results/Remarks:	$ d \leq 2 \% \text{ of setting value or } 0.1 \text{ V}$

1.28.2.2 Pickup times

Test condition:	see item 1.28.2.1
Test values:	see item 1.28.2.1
Permissive tolerance/Limiting values:	t approx. 8 ms + OOT
Test results/Remarks:	t approx. 8 ms + OOT

¹ Not applicable for Busbar Protection

Summary

1.29 50BF Circuit Breaker Failure Protection

1.29.1 Pickup values

f_{rated}	50 Hz, 60 Hz
I_{rated}	1A, 5A
3I0 criterion	Plausibility check / Direct release
I2 criterion	Plausibility check / Direct release

1.29.2 Pickup values

Test condition:	$0.030 I_{rated} \leq I < 35.000 I_{rated}$
Permissive tolerance/Limiting values:	$\leq 2\%$ of setting value or $1\% I_{rated}$
Test results/Remarks:	$< 2\%$ of setting value or $1\% I_{rated}$

1.29.3 Dropout ratio

Test condition:	approx. 0.95
Permissive tolerance/Limiting values:	$\leq 2\%$ of setting value or $1\% I_{rated}$
Test results/Remarks:	$< 2\%$ of setting value or $1\% I_{rated}$

1.29.4 Pickup times

Test condition:	Pickup time
Permissive tolerance/Limiting values:	≤ 10 ms
Test results/Remarks:	< 10 ms

1.29.5 Dropout times

1.29.5.1 Dropout time via the current-flow criterion

Test condition:	dropout time via the current-flow criterion
Permissive tolerance/Limiting values:	≤ 15 ms typical
Test results/Remarks:	< 15 ms ¹

1.29.5.2 Dropout time, via circuit-breaker auxiliary contact criterion

Test condition:	dropout time, via circuit-breaker auxiliary contact criterion
Permissive tolerance/Limiting values:	≤ 5 ms
Test results/Remarks:	< 5 ms ¹

1.29.6 Time delays

Test condition:	added to the inherent operating times
Test values:	0.000 s to 60.000 s
Permissive tolerance/Limiting values:	$\leq 1\%$ of setting value or 10 ms
Test results/Remarks:	$< 1\%$ of setting value or 10 ms

1.29.7 Operation with CB auxiliary contact

Permissive tolerance/Limiting values:	funct. acc. to manual
Test results/Remarks:	function correct

1.29.8 Standard Characteristic Curve

1.29.8.1 Threshold I_{diff}

Test condition:	0.20 to 4.00 I_{rated} obj
Permissive tolerance/Limiting values:	$\leq 5\%$ of setting value or 50 mA
Test results/Remarks:	$< 5\%$ of setting value or 50 mA

¹ The dropout time is the time required by the CBFP function to detect that the CB is open. The time for switching a contact is not included

Summary**1.29.9 Frequency Operating Range**

Test condition: $f_{rated} - 10\% < f < f_{rated} + 5\%$	According to specified tolerances
Test results/Remarks:	confirmed
Test condition: $10 \text{ Hz} < f < f_{rated} - 10\%$ $f_{rated} + 5\% < f < 80 \text{ Hz}$	Slightly expanded tolerances
Test results/Remarks:	confirmed
Test condition: $f < 10 \text{ Hz}$, $f > 80 \text{ Hz}$	Active
Test results/Remarks:	confirmed

Summary

1.30 Circuit Breaker Restrike Protection

1.30.1 Pickup values

Test condition: $0.030 I_{rated} \leq I < 35.000 I_{rated}$
 Test values: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 $0.030 I_{rated} \leq I < 35.000 I_{rated}$
 Permissive tolerance/Limiting values: $\pm 1 \% \text{ of setting value or } 0.5 \% I_{rated}$
 Test results/Remarks: $\pm 1 \% \text{ of setting value or } 0.5 \% I_{rated}$

1.30.2 Dropout ratio

Test condition: see item 1.29.1
 Test value: 95% of threshold value
 Permissive tolerance/Limiting values: $\pm 1 \% \text{ of setting value or } 0.5 \% I_{rated}$
 Test results/Remarks: $\pm 1 \% \text{ of setting value or } 0.5 \% I_{rated}$

1.30.3 Pickup times

Test condition: see item 1.29.1
 $1.2 \cdot \text{threshold}$
 Permissive tolerance/Limiting values: t approx.
 25 ms + OOT at 50 Hz
 22 ms + OOT at 60 Hz
 Test results/Remarks: t approx.
 25 ms + OOT at 50 Hz
 22 ms + OOT at 60 Hz

1.30.4 Dropout times

Test condition: see item 1.29.1
 $1.2 \cdot \text{threshold}$
 Permissive tolerance/Limiting values: 20 ms + OOT
 Test results/Remarks: 20 ms + OOT

1.30.5 Time delay T1 for 3-pole retrip

Test condition: see item 1.29.1
 $1.2 \cdot \text{threshold}$
 Test values: 0.00 s to 60.00 s
 Permissive tolerance/Limiting values: $\pm 1 \% \text{ of setting value or } 10 \text{ ms}$
 Test results/Remarks: $\pm 1 \% \text{ of setting value or } 10 \text{ ms}$

1.30.6 Time delay T2 for 3-pole trip

Test condition: see item 1.29.1
 $1.2 \cdot \text{threshold}$
 Test values: 0.05 s to 60.00 s
 Permissive tolerance/Limiting values: $\pm 1 \% \text{ of setting value or } 10 \text{ ms}$
 Test results/Remarks: $\pm 1 \% \text{ of setting value or } 10 \text{ ms}$

1.30.7 Time delay for minimum operate

Test condition: see item 1.29.1
 $1.2 \cdot \text{threshold}$
 Test values: 0.00 s to 60.00 s
 Permissive tolerance/Limiting values: $\pm 1 \% \text{ of setting value or } 10 \text{ ms}$
 Test results/Remarks: $\pm 1 \% \text{ of setting value or } 10 \text{ ms}$

Summary**1.30.8 Time delay for dropout**

Test condition:	see item 1.29.1 1.2*threshold
Test values:	0.00 s to 60.00 s
Permissive tolerance/Limiting values:	£ 1 % of setting value or 35 ms
Test results/Remarks:	£ 1 % of setting value or 35 ms

1.30.9 Position recognition delay

Test condition:	see item 1.29.1 1.2*threshold
Test values:	0.00 s to 60.00 s
Permissive tolerance/Limiting values:	£ 1 % of setting value or 10 ms
Test results/Remarks:	£ 1 % of setting value or 10 ms

1.30.10 Monitoring duration

Test condition:	see item 1.29.1 1.2*threshold
Test values:	1.00 s to 600.00 s
Permissive tolerance/Limiting values:	£ 1 % of setting value or 10 ms
Test results/Remarks:	£ 1 % of setting value or 10 ms

Summary

1.31 25 Synchronization Function

1.31.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.31.2 Tolerances

1.31.2.1 Tolerances of the voltage settings

Permissive tolerance/Limiting values: 2 % of setting value or 1 V
Test results/Remarks: £ 2 % or £ 1 V

1.31.2.2 Voltage difference $V2 > V1$; $V2 < V1$

Permissive tolerance/Limiting values: 1 V
Test results/Remarks: £ 0,15 V

1.31.2.3 Frequency difference $f2 > f1$; $f2 < f1$

Permissive tolerance/Limiting values: 1 mHz
Test results/Remarks: £ 1mHz

1.31.2.4 Angular difference $\alpha2 > \alpha1$; $\alpha2 < \alpha1$

Permissive tolerance/Limiting values: 1 °
Test results/Remarks: £ 0,2 °

1.31.2.5 Tolerance of all time settings

Permissive tolerance/Limiting values: 10 ms
Test results/Remarks: £ 10 ms

1.31.2.6 Max. phase displacement angle

Permissive tolerance/Limiting values: 5 ° for $\Delta f \leq 1$ Hz
10 ° for $\Delta f > 1$ Hz
Test results/Remarks: ≤ 5 ° for $\Delta f \leq 1$ Hz
 ≤ 10 ° for $\Delta f > 1$ Hz

1.31.3 Tested functionality

Test values:

- Synchronous operation mode
- Asynchronous operation mode
- De-energized switching
 - Dead line
 - Dead bus
- Df/dt limitation
- Low frequent oscillations
- Direct closing
- Function values
- Error reactions
- Threshold values for
 - Voltages and voltage difference
 - Frequency and frequency difference
 - Angle difference
 - Rate of frequency change
 - Delay time
- Binary inputs
 - Start and stop
 - Selection
 - Blocking
 - De-energized switching
- Start synchronization by
 - Control function
 - Auto recloser
 - Binary input
- Conditions
 - Connection types Ph-Ph and Ph-Gnd
 - 3ph and 1ph measuring points
 - V sync. Selection by measuring point ID

Test results/Remarks: Functionality according to manual confirmed

Summary

Summary

1.32 Balancing Command for Synchronization Function

1.32.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255- 8

1.32.2 Balancing Voltage v2

1.32.2.1 TV pulse min

Test values: 0.01 s £ TV pulse min £ 1.00 s
 Permissive tolerance/Limiting values: 10 ms
 Test results/Remarks: 10 ms

1.32.2.2 TV pulse max

Test values: 0.01 s £ TV pulse max £ 60.00 s
 Permissive tolerance/Limiting values: 10 ms
 Test results/Remarks: 10 ms

1.32.2.3 T position impulse (Calculated impulse length for voltage control)

Test values: 0.100 V £ dV per second £ 50.000 V
 -5.000 V £ dV £ 5.000 V
 Permissive tolerance/Limiting values: 1 % of calculated impulse or 10 ms
 Test results/Remarks: 1 % of calculated impulse or 10 ms

1.32.2.4 T pause V

Test values: 0.10 s £ Tpause V £ 60.00 s
 Permissive tolerance/Limiting values: 10 ms
 Test results/Remarks: 10 ms

1.32.3 Balancing Frequency f2

1.32.3.1 T f pulse min

Test values: 0.01 s £ Tf pulse min £ 1.00 s
 Permissive tolerance/Limiting values: 10 ms
 Test results/Remarks: 10 ms

1.32.3.2 T f pulse max

Test values: 0.01 s £ Tf pulse max £ 60.00 s
 Permissive tolerance/Limiting values: 10 ms
 Test results/Remarks: 10 ms

1.32.3.3 T position impulse (Calculated impulse length for frequency control)

Test values: 0.05 Hz/s £ df/dt of the controller £ 5.00 Hz/s
 -1.00 Hz £ df £ 1.00 Hz
 Permissive tolerance/Limiting values: 1 % of calculated impulse or 10 ms
 Test results/Remarks: 1 % of calculated impulse or 10 ms

1.32.3.4 T pause f

Test values: 0.10 s £ T pause f £ 60.00 s
 Permissive tolerance/Limiting values: 10 ms
 Test results/Remarks: 10 ms

Summary**1.33 79 Automatic Reclosing Function**

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

Summary

1.34 81 Frequency Protection

1.34.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.34.2 Pickup values $f<$, $f>$

Test condition:	40.00 Hz $\leq f >$ \leq 70.00 Hz Method A: Angle difference method Method B : Filtering method
Test values:	A: $f_{rated} - 0.2 \text{ Hz} < f < f_{rated} + 0.2 \text{ Hz}$ B: $f_{rated} - 3.0 \text{ Hz} < f < f_{rated} + 3.0 \text{ Hz}$
Permissive tolerance/Limiting values:	A: $ d \leq 5 \text{ mHz}$ at $V = V_{rated}$ B: $ d \leq 10 \text{ mHz}$ at $V = V_{rated}$
Test results/Remarks:	A: $ d < 5 \text{ mHz}$ at $V = V_{rated}$ B: $ d < 10 \text{ mHz}$ at $V = V_{rated}$

1.34.3 Dropout ratio Δf

Test condition:	20 mHz to 2000 mHz
Permissive tolerance/Limiting values:	$ d \leq 5 \text{ mHz}$ at $V = V_{rated}$
Test results/Remarks:	$ d < 5 \text{ mHz}$ at $V = V_{rated}$

1.34.3.1 Pickup times $f<$, $f>$

Permissive tolerance/Limiting values:	Method A: t approx. 70 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 60 ms + OOT at $f_{rated} = 60 \text{ Hz}$ Method B: t approx. 75 ms + OOT at $f_{rated} = 50 \text{ Hz}$ 75 ms + OOT at $f_{rated} = 60 \text{ Hz}$
Test results/Remarks:	Method A: t < 70 ms + OOT at $f_{rated} = 50 \text{ Hz}$ < 60 ms + OOT at $f_{rated} = 60 \text{ Hz}$ Method B: t < 75 ms + OOT at $f_{rated} = 50 \text{ Hz}$ < 75 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.34.3.2 Dropout times $f<$, $f>$

Test values:	dropout by I, V -> 0
Permissive tolerance/Limiting values:	60 ms $\leq t \leq$ 80 ms
Test results/Remarks:	60 ms < t < 80 ms

1.34.3.3 Time delays

Test condition:	added to the inherent operating times
Test values:	0.00 s $\leq T \leq$ 60.00 s
Permissive tolerance/Limiting values:	$ d \leq 1 \%$ of setting value or 10 ms
Test results/Remarks:	$ d < 1 \%$ or 10 ms

Summary

1.35 81R Rate of Frequency Change

1.35.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.35.2 df/dt falling

1.35.2.1 Pickup values

Test condition:	$0.9 \leq f/f_{rated} \leq 1.1$
Test values:	$0.10 \text{ Hz/s} \leq df/dt \leq 20.00 \text{ Hz/s}$
Permissive tolerance/Limiting values:	< 5 % of set point value or 0.1 Hz/s
Test results/Remarks:	Measuring window ≤ 3 periods < 5 %; < 0.06 Hz/s Measuring window > 3 periods < 3 %; < 0.06 Hz/s

1.35.2.2 Dropout differential

Test condition:	$0.9 \leq f/f_{rated} \leq 1.1$
Test values:	$0.02 \text{ Hz/s} \leq \text{Dropout differential} \leq 0.99 \text{ Hz/s}$
Permissive tolerance/Limiting values:	< 5 % of Dropout value or 0.1 Hz/s
Test results/Remarks:	Measuring window ≤ 3 periods < 5 %; < 0.06 Hz/s Measuring window > 3 periods < 3 %; < 0.06 Hz/s

1.35.2.3 Pickup times

Test condition:	$0.10 \text{ Hz/s} \leq df/dt \leq 20.00 \text{ Hz/s}$
Test results/Remarks:	Approx.165 ms to 225 ms (depends on measuring window length)

1.35.2.4 Dropout times

Test condition:	$0.10 \text{ Hz/s} \leq df/dt \leq 20.00 \text{ Hz/s}$
Test results/Remarks:	Approx.165 ms to 225 ms (depends on measuring window length)

1.35.2.5 Time delays

Test condition:	Added to the inherent operating times
Test values:	0.00 s to 60.00 s
Permissive tolerance/Limiting values:	± 1 % of setting value or 10 ms
Test results/Remarks:	< 1 % or 10 ms

1.35.3 df/dt rising

1.35.3.1 Pickup values

Test condition:	$0.9 \leq f/f_{rated} \leq 1.1$
Test values:	$0.10 \text{ Hz/s} \leq df/dt \leq 20.00 \text{ Hz/s}$
Permissive tolerance/Limiting values:	< 5 % of set point value or 0,1 Hz/s
Test results/Remarks:	Measuring window ≤ 3 periods < 5 %; < 0.06 Hz/s Measuring window > 3 periods < 3 %; < 0.06 Hz/s

1.35.3.2 Dropout differential

Test condition:	$0.9 \leq f/f_{rated} \leq 1.1$
Test values:	$0.02 \text{ Hz/s} \leq \text{Dropout differential} \leq 0.99 \text{ Hz/s}$
Permissive tolerance/Limiting values:	< 5 % of Dropout value or 0,1 Hz/s
Test results/Remarks:	Measuring window ≤ 3 periods < 5 %; < 0.06 Hz/s Measuring window > 3 periods < 3 %; < 0.06 Hz/s

1.35.3.3 Pickup times

Test condition:	$0.10 \text{ Hz/s} \leq df/dt \leq 20.00 \text{ Hz/s}$
Test results/Remarks:	Approx.165 ms to 225 ms (depends on measuring window length)

Summary**1.35.3.4 Dropout times**

Test condition: 0.10 Hz/s \leq df/dt \leq 20.00 Hz/s
Test results/Remarks: Approx.165 ms to 225 ms (depends on measuring window length)

1.35.3.5 Time delays

Test condition: Added to the inherent operating times
Test values: 0.00 s to 60.00 s
Permissive tolerance/Limiting values: \pm 1 % of setting value or 10 ms
Test results/Remarks: < 1 % or 10 ms

Summary

1.36 Underfrequency Load Shedding Protection

1.36.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.36.2 General function block

1.36.2.1 Minimum Voltage

Test condition: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}.$
 Test values: 0.300 p.u. \leq threshold value \leq 0.900 p.u.
 Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10 \%$
 0.5 % of setting value or 0.05 V
 Test results/Remarks: in the range $f_{rated} \pm 10 \%$
 0.5 % of setting value or 0.05 V

1.36.2.2 Phi (power criterion)

Test condition: see item 1.36.2.1
 Test values: $-30^\circ \leq$ threshold value \leq 30°
 Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10 \%$
 1°
 Test results/remarks: in the range $f_{rated} \pm 10 \%$
 1°

Min.current(power crit.)

Test condition: see item 1.36.2.1
 Test values: 0.020 p.u. \leq threshold value \leq 0.200 p.u.
 Permissive tolerance/Limiting values: in the range $f_{rated} \pm 10 \%$
 1 % of setting value or 0.005 I_{rated}
 Test results/Remarks: in the range $f_{rated} \pm 10 \%$
 1 % of setting value or 0.005 I_{rated}

1.36.2.3 Df/dt-rising blk. threshold

Test condition: $0.9 \leq f/f_{rated} \leq 1.1$
 Test values: $0.10 \text{ Hz/s} \leq$ threshold value \leq 20.00 Hz/s
 Permissive tolerance/Limiting values: 5 % of setting value or 0.1 Hz/s
 Test results/Remarks: Measuring window \leq 3 periods, 5 % of setting value or 0.06 Hz/s
 Measuring window $>$ 3 periods, 3 % of setting value or 0.06 Hz/s

1.36.2.4 Df/dt-falling blk. threshold

Test condition: $0.9 \leq f/f_{rated} \leq 1.1$
 Test values: $0.10 \text{ Hz/s} \leq$ threshold value \leq 20.00 Hz/s
 Permissive tolerance/Limiting values: 5 % of setting value or 0.1 Hz/s
 Test results/Remarks: Measuring window \leq 3 periods, 5 % of setting value or 0.06 Hz/s
 Measuring window $>$ 3 periods, 3 % of setting value or 0.06 Hz/s

1.36.2.5 Df/df dropout differential

Test condition: $0.9 \leq f/f_{rated} \leq 1.1$
 Test values: $0.02 \text{ Hz/s} \leq$ Dropout differential \leq 0.99 Hz/s
 Permissive tolerance/Limiting values: 5 % of Dropout value or 0.1 Hz/s
 Test results/Remarks: Measuring window \leq 3 periods, 5 % of setting value or 0.06 Hz/s
 Measuring window $>$ 3 periods, 3 % of setting value or 0.06 Hz/s

1.36.3 Underfrequency Protection stage

1.36.3.1 Pickup values

Test condition: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 $f <$ stabilization counter = 6

Summary

Test values: $f_{rated} - 10.0 \text{ Hz} < f < f_{rated} + 10.0 \text{ Hz}$

Permissive tolerance/Limiting values: 5 mHz at $V = V_{rated}$

Test results/Remarks: 5 mHz at $V = V_{rated}$

1.36.3.2 Frequency dropout differential

Test condition: see item 1.36.3.1

Test values: 20 mHz to 2000 mHz

Permissive tolerance/Limiting values: 5 mHz at $V = V_{rated} (f_{rated} - 10.0 \text{ Hz} < f < f_{rated} + 10.0 \text{ Hz})$

Test results/Remarks: 5 mHz at $V = V_{rated} (f_{rated} - 10.0 \text{ Hz} < f < f_{rated} + 10.0 \text{ Hz})$

1.36.3.3 Pickup times

Test condition: see item 1.36.3.1

Test values: 1.2*threshold

Permissive tolerance/Limiting values: 85 ms + OOT at 50 Hz
80 ms + OOT at 60 Hz

Test results/Remarks: 85 ms + OOT at 50 Hz
80 ms + OOT at 60 Hz

1.36.3.4 Dropout times

Test condition: see item 1.36.3.1

Permissive tolerance/Limiting values: 80 ms + OOT at 50 Hz
75 ms + OOT at 60 Hz

Test results/Remarks: 80 ms + OOT at 50 Hz
75 ms + OOT at 60 Hz

1.36.3.5 Operate delay

Test condition: added to the inherent operating times

Test values: 0.00 s £ T £ 60.00 s

Permissive tolerance/Limiting values: 1% of setting value or 10ms

Test results/Remarks: 1% of setting value or 10ms

Summary

1.38 32 General Power Protection 3-phases

1.38.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.38.2 Pickup values

Test condition: -200.0 % to +200.0 %
 Test values: -200.0 % to +200.0 %
 Permissive tolerance/Limiting values: $|d| \leq 0.5 \% S_{nr} \pm 3 \% \text{ of setting value}$
 Test results/Remarks: $|d| < 0.5 \% S_{nr} \pm 3 \% \text{ of setting value}$

1.38.3 Tilt power characteristic

Test condition: -89.0 ° to +89.0 °
 Test values: -89.0 ° to +89.0 °
 Permissive tolerance/Limiting values: function according to manual
 Test results/Remarks: function correct

1.38.4 Dropout ratio

Test condition: 0.90 to 0.99 at >stage
 1.01 to 1.10 at <stage
 Test values: 0.90 to 0.99 at >stage
 1.01 to 1.10 at <stage
 Permissive tolerance/Limiting values: function according to manual
 Test results/Remarks: function correct

1.38.5 Pickup times

Permissive tolerance/Limiting values: t approx.
 55 ms + OOT at $f_{rated} = 50 \text{ Hz}$
 45 ms + OOT at $f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t
 < 55 ms + OOT at $f_{rated} = 50 \text{ Hz}$
 < 45 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.38.6 Dropout times

Permissive tolerance/Limiting values: t approx.
 55 ms + OOT at $f_{rated} = 50 \text{ Hz}$
 45 ms + OOT at $f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t
 < 55 ms + OOT at $f_{rated} = 50 \text{ Hz}$
 < 45 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.38.7 Time delays

Test condition: added to the inherent operating times
 Test values: 0.00 s to 60.00 s
 Permissive tolerance/Limiting values: $|d| \leq 1 \% \text{ of setting value or } 10 \text{ ms}$
 Test results/Remarks: $|d| < 1 \% \text{ or } 10 \text{ ms}$

Summary

1.39 27 Undervoltage-controlled Reactive Power Protection

1.39.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-127

1.39.2 Protection stage

1.39.2.1 Pickup values V<

Test condition:	$f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ $3.000 \text{ V} \leq V < \leq 175.000 \text{ V}$
Test values:	$3.000 \text{ V} \leq V < \leq 175.000 \text{ V}$
Permissive tolerance/Limiting values:	$< 0.5 \% \text{ of set point value or } 0.05 \text{ V}$
Test results/Remarks:	$< 0.5 \% \text{ of set point value or } 0.05 \text{ V}$

1.39.2.2 V dropout ratio

Test condition:	$f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ $r = \text{dropout ratio}$
Test values:	$r = 1.05$
Test results/Remarks:	$1.01 \leq r \leq 1.20$

1.39.2.3 Pickup values I1>

Test condition:	$0.030 \text{ A} \leq I1 > \leq 10.000 I_{rated}$
Test values:	$f_{rated} = 50 \text{ Hz}, 60\text{Hz}$
Permissive tolerance/Limiting values:	$1 \% \text{ of setting value or } 0.005 I_{rated}$
Test results/remarks:	$1 \% \text{ of setting value or } 0.005 I_{rated}$

1.39.2.4 Dropout ratio release current

Test condition:	$f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ $r = \text{dropout ratio}$
Test values:	$r = 0.95$
Test results / remarks:	$0.90 \leq r \leq 0.99$

1.39.2.5 Pickup values Q<

Test condition:	$f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ $1.0\% \leq Q < \leq 200.0\%$
Test values:	$1.0\% \leq Q < \leq 200.0\%$
Permissive tolerance/Limiting values:	$<0.5 \% \text{ Sn/r} \pm 3 \% \text{ of setting value}$
Test results / remarks:	$<0.5 \% \text{ Sn/r} \pm 3 \% \text{ of setting value}$

1.39.2.6 Q dropout ratio

Test condition:	$f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ $r = \text{dropout ratio}$
Test values:	$r \leq 0.95$
Test results / remarks:	$0.90 \leq r \leq 0.99$

1.39.2.7 Pickup time

Test condition:	see item 1.39.2.1, 1.39.2.3, 1.39.2.5
Test values:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
Permissive tolerance/Limiting values:	t approx. $55 \text{ ms} + \text{OOT at } f_{rated} = 50 \text{ Hz}$ $45 \text{ ms} + \text{OOT at } f_{rated} = 60 \text{ Hz}$
Test results/Remarks:	t approx. $55 \text{ ms} + \text{OOT at } f_{rated} = 50 \text{ Hz}$ $45 \text{ ms} + \text{OOT at } f_{rated} = 60 \text{ Hz}$

Summary

1.39.2.8 Dropout times

Test condition: see item 1.39.2.1, 1.39.2.3, 1.39.2.5
 Test values: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 Permissive tolerance/Limiting values: t approx.
 55 ms + OOT at $f_{rated} = 50 \text{ Hz}$
 45 ms + OOT at $f_{rated} = 60 \text{ Hz}$
 Test results/Remarks: t approx.
 55 ms + OOT at $f_{rated} = 50 \text{ Hz}$
 45 ms + OOT at $f_{rated} = 60 \text{ Hz}$

1.39.2.9 Time delays

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: |d| £ 1 % of setting value or 10 ms

1.39.2.10 Operate delay generator CB

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: |d| £ 1 % of setting value or 10 ms

1.39.2.11 Operate delay grid CB

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: |d| £ 1 % of setting value or 10 ms

1.39.3 Recloser stage

1.39.3.1 V> reclosure threshold

Test condition: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 3.000 V £ V> £ 340.000 V
 Test values: 3.000 V £ V> £ 340.000 V
 Permissive tolerance/Limiting values: < 0.5 % of set point value or 0.05V
 Test results/Remarks: < 0.5 % of set point value or 0.05V

1.39.3.2 V dropout ratio

Test condition: $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
 r = dropout ratio
 Test values: r = 0.95
 Test results / remarks: 0.90 £ r £ 0.99

1.39.3.3 f-difference positive

Test condition: 0.01 Hz to 5.00 Hz
 Test values: 0.01 Hz to 5.00 Hz
 Permissive tolerance/Limiting values: 10 mHz
 Test results/Remarks: 10 mHz

1.39.3.4 f-difference negative

Test condition: -5.00 Hz to -0.01 Hz
 Test values: -5.00 Hz to -0.01 Hz
 Permissive tolerance/Limiting values: 10 mHz
 Test results/Remarks: 10 mHz

Summary**1.39.3.5 I_r release threshold**

Test condition:	$0.030 I_{rated} \leq I < 10.000 I_{rated}$
Test values:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$
Permissive tolerance/Limiting values:	1 % of setting value or $0.005 I_{rated}$
Test results/Remarks:	1 % of setting value or $0.005 I_{rated}$

1.39.3.6 Dropout ratio release current

Test condition:	$f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$ $r = \text{dropout ratio}$
Test values:	$r = 0.95$
Test results/Remarks:	$0.90 \leq r \leq 0.99$

1.39.3.7 Time delay

Test condition:	$0.00 \text{ s} \leq T \leq 3600.00 \text{ s}$
Test values:	$0.00 \text{ s} \leq T \leq 3600.00 \text{ s}$
Permissive tolerance/Limiting values:	±1% of setting value or 10 ms
Test results/Remarks:	±1% of setting value or 10 ms

Summary

1.40 49 Thermal Overload Protection 3phases

1.40.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-8

Test condition/Test values: calculation method = O/L-calculation
 - Modus Q-max = Q max
 - Modus Q-I_{max} = Q of I_{max}

Permissive tolerance/Limiting values: k = Factor according to IEC 60255-8 or VDE 0435 T3011

1.40.2 Pickup threshold $k \cdot I_N$

Test condition: $k = I_{max}/I_{rated}$
 0.10 ≤ k ≤ 4.00

Test values: k = 0.10, 1.00, 4.00

No filter applied

Permissive tolerance/Limiting values: Up to 30th harmonic, 2% or 0.01 I_{rated}, 2% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 50 Hz, 4% or 0.02 I_{rated}, 4% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 60 Hz, 5% or 0.025 I_{rated}, 5% class acc. to IEC60255-8

Test results/Remarks: Up to 30th harmonic, 2% or 0.01 I_{rated}, 2% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 50 Hz, 4% or 0.02 I_{rated}, 4% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 60 Hz, 5% or 0.025 I_{rated}, 5% class acc. to IEC60255-8

With the filter for the compensation of the amplitude attenuation due to the anti-aliasing

Permissive tolerance/Limiting values: Up to 30th harmonic, 2% or 0.01 I_{rated}, 2% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 50 Hz, 3% or 0.02 I_{rated}, 4% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 60 Hz, 4% or 0.02 I_{rated}, 5% class acc. to IEC60255-8

Test results/Remarks: Up to 30th harmonic, 2% or 0.01 I_{rated}, 2% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 50 Hz, 3% or 0.02 I_{rated}, 4% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 60 Hz, 4% or 0.02 I_{rated}, 5% class acc. to IEC60255-8

With filter for the gain of harmonics including compensation of the amplitude attenuation¹

Permissive tolerance/Limiting values: Up to 30th harmonic, 2% or 0.01 I_{rated}, 2% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 50 Hz, 4% or 0.02 I_{rated}, 4% class acc. to IEC60255-8
 Up to 50th harmonic, f_{rated} = 60 Hz, 5% or 0.025 I_{rated}, 5% class acc. to IEC60255-8

Test results/Remarks: Up to 30th harmonic, 2% or 0.01 I_{rated}, 2% class acc. to IEC60255-8²
 Up to 50th harmonic, f_{rated} = 50 Hz, 4% or 0.02 I_{rated}, 4% class acc. to IEC60255-8³
 Up to 50th harmonic, f_{rated} = 60 Hz, 5% or 0.025 I_{rated}, 5% class acc. to IEC60255-8⁴

1.40.3 Thermal warning stage

Test condition: 50 % ≤ Q-warn ≤ 100 %

Test values: Q-warn = 50 %, 63 %, 90 %, 100 %

Test results/Remarks: function correct

1.40.4 Current warning stage

Test condition: 0.03 I_{rated} ≤ I_{warn} ≤ 35.00 I_{rated}

Test results/Remarks: function correct

1.40.5 Dropout ratio

Test condition: dropout threshold ratio
 50 % ≤ r ≤ 99 %

Test results/Remarks: function correct

¹ In case that the filter response exactly matches the user defined gain factor

² In case that the user-defined gain factor is set below 3. The tolerance is amplified if the gain factor is larger

³ In case that the user-defined gain factor is set below 7. The tolerance is amplified if the gain factor is larger

⁴ In case that the user-defined gain factor is set below 7. The tolerance is amplified if the gain factor is larger

Summary

1.40.6 Tripping time characteristics

1.40.6.1 Parameter k, t

Test condition: $k = I_{max}/I_{rated}$ (IEC 60255-8)
t = Time constant

Test values: tripping times t

Permissive tolerance/Limiting values: |d| ≤ 3 % or 1 s
3 % class acc. to IEC 60255-8 for $I/(k * I_{rated}) > 1.25$

1.40.6.2 Range of k, t

Test condition: 0.10 ≤ k ≤ 4.00
30 s ≤ t ≤ 60000 s

Test values: fault L-N, Modus Q-max

Permissive tolerance/Limiting values: $t = t \cdot \ln\{ ((I/k I_{rated})^2 - (I_{pre}/k I_{rated})^2) / ((I/k I_{rated})^2 - 1) \}$ for $I/(k * I_{rated}) \geq 8$

1.40.6.3 With and without preload

Test condition: with and without preload

Test values: a) k = 0.1; t = (300, 500) min; I = 0.7 A
b) k = 1.1; t = (20, 100) min; I = 2.5 A
c) k = 4.0; t = (1, 5) min; I = 5.0 A
d) k = 1.0; t = (1, 3, 10) min; I = 1.0 A

1.40.6.4 Range $I/(k * I_{rated}) \geq 8$

Test condition: range $I/(k * I_{rated}) \geq 8$

Test values: a) k = 1.0: $I/(k * I_{rated}) = 8, 10, 12$
b) k = 0.1: $I/(k * I_{rated}) = 8, 10, 50$

Permissive tolerance/Limiting values: $t[\geq 8] = \text{const} = t[8]$
 $t[8] = t$ according to formula for $I/(k * I_{rated}) = 8$

Test results/Remarks: function correct

Summary

1.41 49 Thermal Overload Protection 1phase

1.41.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

Test condition/Test values: calculation method = O/L-calculation
 - Modus Q-max = Q max
 - Modus Q-I_{max} = Q of I_{max}

Permissive tolerance/Limiting values: k = Factor according to IEC 60255-8 or VDE 0435 T3011

1.41.2 Pickup threshold $k \cdot I_N$

Test condition: $k = I_{max}/I_{rated}$
 0.10 ≤ k ≤ 4.00

Test values: k = 0.10, 1.00, 4.00

Permissive tolerance/Limiting values: |d| ≤ 2% or 10mA at I_{rated} = 1A
 |d| ≤ 2% or 50mA at I_{rated} = 5A
 class 2% acc. to IEC 255-8

Test results/Remarks: |d| < 2 %

1.41.3 Thermal time constant

Test condition: 30s ≤ t_{th} ≤ 60000s

Test values: t_{th} = 30s, 100s, 60000s

Test results/Remarks: function correct

1.41.4 Thermal warning stage

Test condition: Q-warn/Q-trip
 50% ≤ Q-warn ≤ 100%

Test values: Q-warn = 50%, 70%, 90%, 100%

Test results/Remarks: function correct

1.41.5 Current warning stage

Test condition: 0.03 I_{rated} ≤ I_{warn} ≤ 35.00 I_{rated}

Test values: I_{warn} = 0.03A, 0.5A, 5A, 10A

Test results/Remarks: function correct

1.41.6 Maximum thermal current

Test condition: 0.03 I_{rated} ≤ I_{max thermal} ≤ 10.00 I_{rated}

Test values: I_{max thermal} = 1.1A, 2.5A, 10A

Test results/Remarks: function correct

1.41.7 Dropout ratio

Test condition: dropout threshold operate ratio
 50% ≤ r ≤ 99%

Test values: r = 50%, 70%, 90%, 99%

Test results/Remarks: function correct

Summary

1.41.8 Tripping time characteristics

Test condition:	$k = I_{max}/I_{rated}$ (IRC 255-8) 0.10 £ k £ 4.00
	t = Time constant 30 s £ t £ 60000 s
	with and without preload
Test values:	tripping times t Fault L-N, Modus Q-max
	$k = 0.1, 1, 4; t = 100s$ $k = 1; t = 30s, 100s, 60000s$
Permissible tolerance/Limiting values:	$ d $ £ 3 % or 1s class 3 % acc. to IEC 255-8 for $I/(k * I_{rated}) > 1.25$
	$t = t \ln\{ ((I/k I_{rated})^2 - (I_{pre}/k I_{rated})^2) / ((I/k I_{rated})^2 - 1) \}$ for $I/(k * I_{rated})$ £ 8
Test results/Remarks:	function correct $ d < 2\%$ or 0.2s

Summary

1.42 Arc Protection

1.42.1 General test conditions

f_{rated} 50 Hz, 60 Hz
 I_{rated} 1 A

1.42.2 Light only

1.42.2.1 Pickup time

Test condition: 100 measurements
Pickup of stage measured with high-speed-relais

Test results/Remarks: $t_{max} = 3.6$ ms
 $t_{min} = 2.6$ ms
 $t_{average} = 3.0$ ms

1.42.2.2 Dropout time

Test condition: 100 measurements
Pickup of stage measured with high-speed-relais

Test results/Remarks: $t_{max} = 27.3$ ms
 $t_{min} = 26.7$ ms
 $t_{average} = 27.3$ ms

1.42.3 Light and current

1.42.3.1 Threshold I>

Test condition: 1pol-fault, 3pol-fault
0.03 £ $I_{ratedObj}$ £ 10.00
Permissive tolerance/Limiting values: no operate below threshold, measurement accuracy not considered
Test results/Remarks: confirmed

1.42.3.2 Threshold 3I0>

Test condition: 1pol-fault, IN calculated, IN measured
0.03 £ $I_{ratedObj}$ £ 10.00
Permissive tolerance/Limiting values: no operate below threshold, measurement accuracy not considered
Test results/Remarks: confirmed

1.42.3.3 Dropout ratio I>

Test condition: 1pol-fault, 3pol-fault
0.03 £ $I_{ratedObj}$ £ 10.00
Permissive tolerance/Limiting values: approx. 0.90
Test results/Remarks: 0.80 – 0.95

1.42.3.4 Dropout ratio 3I0>

Test condition: 1pol-fault
0.03 £ $I_{ratedObj}$ £ 10.00
Permissive tolerance/Limiting values: approx. 0.90
Test results/Remarks: 0.80 – 0.95

1.42.3.5 Pickup time

Test condition: 100 measurements per fault type and frequency
fault inception angle 10x(0°, 18°, 36°...162°)
Current jump from 1A to 10A at default threshold
Pickup of stage measured with high-speed-relais

Test results/Remarks:	1pol, 50 Hz	1pol, 60 Hz	3pol, 50 Hz	3pol, 60 Hz
$t_{max} =$	9.2 ms	9.0 ms	6.9 ms	6.9 ms
$t_{min} =$	4.4 ms	3.8 ms	4.0 ms	3.8 ms
$t_{average} =$	5.5 ms	5.8 ms	5.3 ms	5.3 ms

Summary**1.42.3.6 Dropout time**

Test condition:

100 measurements
Current jump to 0 A
Pickup of stage measured with high-speed-relais

Test results/Remarks:

	1pol, 50 Hz	1pol, 60 Hz	3pol, 50 Hz	3pol, 60 Hz
t_{\max} =	27.3 ms	27.8 ms	27.3 ms	27.8 ms
t_{\min} =	26.7 ms	26.3 ms	26.2 ms	26.2 ms
t_{average} =	27.2 ms	27.3 ms	27.2 ms	27.3 ms

1.42.4 Frequency operating range

Test condition:

 $I_{\text{test}} = 5 I_{\text{rated}}$ at default threshold, $f = 5 \text{ Hz} - 100 \text{ Hz}$

Permissible tolerance/Limiting values:

10 Hz – 80 Hz

Test results/Remarks:

confirmed

Summary

1.43 Tripping on Weak Infeed (French Specification)

1.43.1 General test conditions

- VDE 0435
- IEC/EN 60255-1, Item 7, Annex A, B

f_{rated} 50 Hz
 I_{rated} 1 A

1.43.2 Pickup values

1.43.2.1 V_{ph-g}-factor

Test condition: 0.10 £ V_{ph-g-factor} £ 1
Permissive tolerance/Limiting values: Funct. acc. to manual
Test results/Remarks: confirmed

1.43.2.2 Undervoltage

Test condition: 0.30 V £ V_{ph-gnd} £ 50 V
Permissive tolerance/Limiting values: |d| £ 5 % of setting value
Test results/Remarks: |d| £ 5 % of setting value or 0.1 V

1.43.2.3 3I0 > threshold

Test condition: 0.20 A £ 3I0 £ 1 A
Permissive tolerance/Limiting values: |d| £ 5 % of setting value
Test results/Remarks: |d| £ 3 % of setting value or 0.01 I_{rated}

1.43.2.4 Time constant Tau

Test condition: 1 s £ Tau £ 60 s
Permissive tolerance/Limiting values: Funct. acc. to manual
Test results/Remarks: confirmed

1.43.3 Pickup times

Test condition: 10 measurements with receive signal
Voltage jump from V_n to 0 at default threshold
Pickup of stage measured with fast-relais

Test results/Remarks: 1pol, 50Hz
 $t_{max} = 31.4$ ms
 $t_{min} = 18.4$ ms
 $t_{average} = 25.1$ ms

1.43.4 Time delays

1.43.4.1 Operate delay 1-phase (TM)

Test condition: 0.0 s £ T £ 30 s
Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
Test results/Remarks: confirmed

1.43.4.2 Operate delay multi phases (TT)

Test condition: 0.0 s £ T £ 30 s
Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
Test results/Remarks: confirmed

1.43.4.3 T 3I0 > extension

Test condition: 0.0 s £ T £ 30 s
Permissive tolerance/Limiting values: Funct. acc. to manual
Test results/Remarks: confirmed

Summary**1.43.4.4 Receive extension**

Test condition:	0.0 s £ T £ 30 s
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	confirmed

1.43.4.5 T 3I0> alarm

Test condition:	0.0 s £ T £ 30 s
Permissive tolerance/Limiting values:	Funct. acc. to manual
Test results/Remarks:	confirmed

Summary**1.44 Temperature Supervision****1.44.1 Pickup values**

Test condition:	-50 °C to 250 °C -58 °F to 482 °F
Permissive tolerance/Limiting values:	±0.5 % of the setting value or ±1 °C or ±2 °F
Test results/Remarks:	±0.5 % of the setting value or ±1 °C or ±2 °F

1.44.2 Dropout ratio

Test condition:	-50 °C to 250 °C -58 °F to 482 °F
Permissive tolerance/Limiting values:	3 °C or 6 °F
Test results/Remarks:	3 °C or 6 °F

1.44.3 Time delays

Permissive tolerance/Limiting values:	0.00 s to 60.00 s
Permissive tolerance/Limiting values:	£ 1 % of setting value or 10 ms
Test results/Remarks:	< 1 % or 10 ms

Summary

1.45 MAXI-L Overcurrent Protection (French Specification)

1.45.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.45.2 Fast stage

1.45.2.1 Threshold I_{ph}

Test condition: 0.030 I_{rated} ≤ I < 35.000 I_{rated}
 Test values: 0.030 I_{rated} ≤ I < 35.000 I_{rated}
 f_{rated} = 50 Hz, 60 Hz
 Permissive tolerance/Limiting values: |d| ≤ 1 % of setting value or 0.5 % I_{rated}
 Test results/Remarks: |d| < 1 % of setting value or 0.5 % I_{rated}

1.45.2.2 Threshold 3I0

Test condition: 0.030 I_{rated} ≤ I < 35.000 I_{rated}
 Test values: 0.030 I_{rated} ≤ I < 35.000 I_{rated}
 f_{rated} = 50 Hz, 60 Hz
 Permissive tolerance/Limiting values: |d| ≤ 1 % of setting value or 0.5 % I_{rated}
 Test results/Remarks: |d| < 1 % of setting value or 0.5 % I_{rated}

1.45.2.3 Dropout ratio

Test condition: see item 1.45.2.1
 Test values: r = 0.95 (fixed)
 Permissive tolerance/Limiting values: ≤ 1 % of dropout value
 Test results/Remarks: < 1 % of dropout value

1.45.2.4 Pickup times

Test condition: 30 measurements per fault type
 Test values: I/I_{threshold} = 1.2
 f_{rated} = 50 Hz, 60 Hz
 Test results:

		3pol, 50Hz	3pol, 60Hz
t _{max}	=	30.8 ms + OOT	25.9 ms + OOT
t _{min}	=	17.1 ms + OOT	14.0 ms + OOT
t _{average}	=	23.9 ms + OOT	19.5 ms + OOT

1.45.2.5 Dropout times

Test condition: 30 measurements per fault type
 Test values: I/I_{threshold} = 1.2
 f_{rated} = 50 Hz, 60 Hz
 Test results:

		3pol, 50Hz	3pol, 60Hz
t _{max}	=	20.1 ms + OOT	17.9 ms + OOT
t _{min}	=	6.0 ms + OOT	5.3ms + OOT
t _{average}	=	12.1 ms + OOT	10.8 ms + OOT

1.45.2.6 Operate delay I_{ph}

Test condition: added to the inherent operating times
 Test values: 0.000 s ≤ T ≤ 60.000 s
 Permissive tolerance/Limiting values: |d| ≤ 1 % of setting value or 10 ms
 Test results/Remarks: |d| < 1 % of setting value or 10 ms

Summary

1.45.2.7 Operate delay 3I0

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: confirmed

1.45.2.8 Operate delay manual close

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: confirmed

1.45.3 Normal stage

1.45.3.1 Pickup values

Test condition: 0.030 I_{rated} £ I > £ 35.000 I_{rated}
 Test values: 0.030 I_{rated} £ I > £ 35.000 I_{rated}
 f_{rated} = 50 Hz, 60 Hz
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 0.5 % I_{rated}
 Test results/Remarks: confirmed

1.45.3.2 Dropout ratio

Test condition: see item 1.45.2.1
 Test values: r = 0.95 (fixed)
 Permissive tolerance/Limiting values: 1 % of dropout value
 Test results/Remarks: confirmed

1.45.3.3 Pickup times

Test condition: 30 measurements per fault type
 Test values: I/I_{threshold} = 1.2
 f_{rated} = 50 Hz, 60 Hz
 Test results:

	3pol, 50Hz	3pol, 60Hz
t _{max} =	27.4 ms + OOT	25.5 ms + OOT
t _{min} =	18.1 ms + OOT	14.1 ms + OOT
t _{average} =	23.1 ms + OOT	20.9 ms + OOT

1.45.3.4 Dropout times

Test condition: 30 measurements per fault type
 Test values: I/I_{threshold} = 1.2
 f_{rated} = 50 Hz, 60 Hz
 Test results:

	3pol, 50Hz	3pol, 60Hz
t _{max} =	17.8 ms + OOT	16.2 ms + OOT
t _{min} =	7.0 ms + OOT	5.6 ms + OOT
t _{average} =	12.8 ms + OOT	11.6 ms + OOT

1.45.3.5 Operate delay

Test condition: added to the inherent operating times
 Test values: 0.00 s £ T £ 60.00 s
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 10 ms
 Test results/Remarks: confirmed

Summary

1.46 Overload Protection for Transformers (French Specification)

1.46.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.46.2 Pickup values

1.46.2.1 Threshold IN, IP, IS, IM, IAERO

Test condition: 0.030 I_{rated} £ I > £ 35.000 I_{rated}
 Test values: 0.030 I_{rated} £ I > £ 35.000 I_{rated}
 f_{rated} = 50 Hz, 60Hz
 Permissive tolerance/Limiting values: |d| £ 1 % of setting value or 0.5 % I_{rated}
 Test results/Remarks: |d| < 1 % of setting value or 0.5 % I_{rated}

1.46.2.2 Theta S

Test condition: 60 °C £ Theta £ 100 °C
 140 °F £ Theta £ 212 °F
 Permissive tolerance/Limiting values: |d| £ 0.5 % of setting value or 1 °C or 2 °F
 Test results/Remarks: |d| < 0.5 % of setting value or 1 °C or 2 °F

1.46.2.3 Theta L

Test condition: 40 °C £ Theta £ 100 °C
 104 °F £ Theta £ 212 °F
 Permissive tolerance/Limiting values: |d| £ 0.5 % of setting value or 1 °C or 2 °F
 Test results/Remarks: |d| < 0.5 % of setting value or 1 °C or 2 °F

1.46.3 Dropout ratio

1.46.3.1 Current

Test condition: see item 1.46.2.1
 Test values: r = 0.95 (fixed)
 Permissive tolerance/Limiting values: 1 % of dropout value
 Test results/Remarks: confirmed

1.46.3.2 Temperature

Test condition: see item 1.46.2.2
 Test values: r = 0.98 (fixed)
 Permissive tolerance/Limiting values: ±1 °C or ±2 °F
 Test results/Remarks: confirmed

1.46.4 Pickup times

Test condition: 90 measurements per fault type
 Test values: I/I_{threshold} = 1.2
 f_{rated} = 50 Hz, 60 Hz
 Test results:

		3pol, 50Hz	3pol, 60Hz
t _{max}	=	30.7 ms + OOT	25.4 ms + OOT
t _{min}	=	17.9 ms + OOT	14.5 ms + OOT
t _{average}	=	23.5 ms + OOT	20.6 ms + OOT

1.46.5 Dropout times

Test condition: 90 measurements per fault type
 Test values: I/I_{threshold} = 1.2
 f_{rated} = 50 Hz, 60 Hz
 Test results:

		3pol, 50Hz	3pol, 60Hz
t _{max}	=	20.6 ms + OOT	15.2 ms + OOT

Summary

t_{\min}	=	5.1 ms + OOT	4.4 ms + OOT
t_{average}	=	12.0 ms + OOT	11.5 ms + OOT

1.46.6 Alarm delay

Test condition:	added to the inherent operating times
Test values:	0.00 s £ T £ 60.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d < 1 % of setting value or 10 ms

1.46.7 Operate delay

Test condition:	added to the inherent operating times
Test values:	0.00 s £ T £ 1800.00 s
Permissive tolerance/Limiting values:	d £ 1 % of setting value or 10 ms
Test results/Remarks:	d < 1 % of setting value or 10 ms

Summary

1.47 ADA Net Decoupling Overcurrent Protection (French Specification)

1.47.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.47.2 Pickup values

Test condition: 0.030 A $\leq I < 35.000$ A @ 1 A
0.15 A $\leq I < 175.00$ A @ 5 A

Test values: 0.030 A $\leq I < 35.000$ A @ 1 A
0.15 A $\leq I < 175.00$ A @ 5 A
 $f_{rated} = 50$ Hz, 60 Hz

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of setting value or 0.5 % I_{rated}

Test results/Remarks: $|d| < 1\%$ of setting value or 0.5 % I_{rated}

1.47.3 Dropout ratio

Test condition: 0.90 $\leq r < 0.99$

Test values: $r = 0.95$

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of dropout value

Test results/Remarks: $|d| < 1\%$ of dropout value

1.47.4 Pickup times

Test condition: 60 measurements per fault type

Test values: $I/I_{threshold} = 1.2$
 $f_{rated} = 50$ Hz, 60 Hz

Test results:

		3pol, 50Hz	3pol, 60Hz
t_{max}	=	30 ms + OOT	25 ms + OOT
t_{min}	=	23 ms + OOT	16 ms + OOT
$t_{average}$	=	27 ms + OOT	20 ms + OOT

1.47.5 Dropout times

Test condition: 60 measurements per fault type

Test values: $I/I_{threshold} = 1.2$
 $f_{rated} = 50$ Hz, 60 Hz

Test results:

		3pol, 50Hz	3pol, 60Hz
t_{max}	=	18 ms + OOT	17 ms + OOT
t_{min}	=	11 ms + OOT	8 ms + OOT
$t_{average}$	=	15 ms + OOT	12 ms + OOT

1.47.6 Operate delay

Test condition: added to the inherent operating times

Test values: 0 s $\leq T < 300$ s

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of setting value or 10 ms

Test results/Remarks: $|d| < 1\%$ of setting value or 10 ms

1.47.7 Alarm delay

Test condition: added to the inherent operating times

Test values: 0 s $\leq T < 60$ s

Permissive tolerance/Limiting values: $|d| \leq 1\%$ of setting value or 10 ms

Test results/Remarks: $|d| < 1\%$ of setting value or 10 ms

Summary

1.48 PSL-PSC Overload Protection for Lines and Cables (French Specification)

1.48.1 Specifications

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B

1.48.2 Pickup values

Test condition: $0.030 I_{rated} \leq I < 35.000 I_{rated}$

Test values: $0.030 I_{rated} \leq I < 35.000 I_{rated}$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$

Permissive tolerance/Limiting values: $|d| \leq 1 \% \text{ of setting value or } 0.5 \% I_{rated}$

Test results/Remarks: $|d| < 1 \% \text{ of setting value or } 0.5 \% I_{rated}$

1.48.3 Dropout ratio

Test condition: see item 1.48.2

Test values: $r = 0.95$

Permissive tolerance/Limiting values: $\leq 1 \% \text{ of dropout value}$

Test results/Remarks: $< 1 \% \text{ of dropout value}$

1.48.4 Pickup times

Test condition: 40 measurements per fault type

Test values: $I/I_{threshold} = 1.2$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$

Test results:		3pol, 50Hz	3pol, 60Hz
t_{max}	=	30.2 ms + OOT	26.1 ms + OOT
t_{min}	=	18.2 ms + OOT	15.9 ms + OOT
$t_{average}$	=	23.1 ms + OOT	21.1 ms + OOT

1.48.5 Dropout times

Test condition: 40 measurements per fault type

Test values: $I/I_{threshold} = 1.2$
 $f_{rated} = 50 \text{ Hz}, 60 \text{ Hz}$

Test results:		3pol, 50Hz	3pol, 60Hz
t_{max}	=	19.4 ms + OOT	18.4 ms + OOT
t_{min}	=	6.7 ms + OOT	7.0 ms + OOT
$t_{average}$	=	12.6 ms + OOT	12.7 ms + OOT

1.48.6 Operate delay

Test condition: added to the inherent operating times

Test values: $0.00 \text{ s} \leq T \leq 7200.00 \text{ s}$

Permissive tolerance/Limiting values: $|d| \leq 1 \% \text{ of setting value or } 10 \text{ ms}$

Test results/Remarks: $|d| < 1 \% \text{ of setting value or } 10 \text{ ms}$

1.48.7 Alarm delay

Test condition: added to the inherent operating times

Test values: $0.00 \text{ s} \leq T \leq 60.00 \text{ s}$

Permissive tolerance/Limiting values: $|d| \leq 1 \% \text{ of setting value or } 10 \text{ ms}$

Test results/Remarks: $|d| < 1 \% \text{ of setting value or } 10 \text{ ms}$

Summary**1.49 Voltage-Comparison Supervision****1.49.1 Specifications**

- VDE 0435
- IEC/EN 60255-1, item 7, Annex A, B
- IEC/EN 60255-127

1.49.2 Function stage**1.49.2.1 Pickup times**

Permissive tolerance/Limiting values:

t approx.
5 ms + OOT at 50 Hz
5 ms + OOT at 60 Hz

Test results/Remarks:

t approx.
5 ms + OOT at 50 Hz
5 ms + OOT at 60 Hz

Summary**1.50 Supervision Functions****1.50.1 Voltage-transformer circuit breaker**

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.2 Current-balance supervision

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.3 Voltage-balance supervision

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.4 Current-sum supervision

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.5 Voltage-sum supervision

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.6 Measuring-voltage failure (Fuse failure monitor)

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.7 Current phase rotation supervision

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.8 Voltage phase rotation supervision

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

1.50.9 74TC Trip circuit supervisionTest condition: Number trip circuit: 1 to 3
Operation mode: with 1 or 2 BI

Permissive tolerance/Limiting values: funct. acc. to manual

Test results/Remarks: Function correct

Summary**1.51 Ancillary Functions****1.51.1 Log buffers****1.51.1.1 Operational log**

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.51.1.2 Fault log

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct. Not applicable for Fault Recorder 7KE85.

1.51.1.3 Ground fault log

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct.
Not applicable for Fault Recorder 7KE85 and Busbar Protection 7SS85.**1.51.2 Fault recording**

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.51.3 Date and time

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.51.4 Setting group switching

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct. Not applicable for Fault Recorder 7KE85.

1.51.5 Test functions**1.51.5.1 CB tripping test**

Test condition: Live tripping of CB

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct. Not applicable for Fault Recorder 7KE85.

1.51.5.2 Test record

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.51.6 CFC

Test condition: Funct. acc. to manual

Test results/Remarks: Function correct

Summary

1.52 Operational Measured Values

1.52.1 Specifications

- IEC/EN 60255-1, Annex A, B

1.52.2 Currents, instrument transformers

Test condition:	Current range	< 1.6 I _{rated}
	Nominal range	1 A, 5 A
	Measuring ranges	(0.1 to 1.6) I _{rated}
	Frequency range:	
	f _{rated} = 50 Hz:	49 Hz to 51 Hz
	f _{rated} = 60 Hz:	59 Hz to 61 Hz
Test values:	I _A , I _B , I _C , 3I ₀ in A (prim), A (sec), % (of I _{rated})	
Permissible tolerance/Limiting values:	£ 0.15 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.15 %	
Test condition:	Frequency range:	
	f _{rated} = 50 Hz:	40 Hz to 60 Hz
	f _{rated} = 60 Hz:	50 Hz to 70 Hz
Test values:	I _A , I _B , I _C , 3I ₀ in A (prim), A (sec), % (of I _{rated})	
Permissible tolerance/Limiting values:	£ 0.3 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.3 %	

1.52.3 Currents, protection-class transformers

Test condition:	Current range	<100 I _{rated} ¹ , <50 I _{rated} ²
	Nominal range	1 A, 5 A
	Measuring ranges	0.1 to 25 A
	Frequency range:	
	f _{rated} = 50 Hz:	49 Hz to 51 Hz
	f _{rated} = 60 Hz:	59 Hz to 61 Hz
Test values:	I _A , I _B , I _C , 3I ₀ in A (prim), A (sec), % (of I _{rated})	
Permissible tolerance/Limiting values:	£ 0.2 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.2 % of the measured value	
Test condition:	Frequency range:	
	f _{rated} = 50 Hz:	40 Hz to 60 Hz
	f _{rated} = 60 Hz:	50 Hz to 70 Hz
Test values:	I _A , I _B , I _C , 3I ₀ in A (prim), A (sec), % (of I _{rated})	
Permissible tolerance/Limiting values:	£ 0.3 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.3 %	

¹ for modular device only

² for non-modular device only

Summary

1.52.4 Voltages

Test condition:	Voltage Range	< 200 V (sec.)
	Secondary rated voltage	100 V to 125 V
	Measuring Range	(1.1 to 2) V_{rated}
	Frequency range:	
	$f_{rated} = 50$ Hz:	49 Hz to 51 Hz
	$f_{rated} = 60$ Hz:	59 Hz to 61 Hz
Test values:	$V_A, V_B, V_C, V_{AB}, V_{BC}, V_{CA}$ in kV (prim), in V (sec), % of V_{rated}	
Permissive tolerance/Limiting values:	0.2 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.2 %	
Test condition:	Frequency range:	
	$f_{rated} = 50$ Hz:	40 Hz to 60 Hz
	$f_{rated} = 60$ Hz:	50 Hz to 70 Hz
Test values:	$V_A, V_B, V_C, V_{AB}, V_{BC}, V_{CA}$ in kV (prim), in V (sec), % of V_{rated}	
Permissive tolerance/Limiting values:	0.3 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.3 %	

1.52.5 Phase angle, current and voltage

Test condition:	I_{rated}, V_{rated}	
	Frequency range:	
	$f_{rated} = 50$ Hz:	47.5 Hz to 52.5 Hz
	$f_{rated} = 60$ Hz:	57.5 Hz to 62.5 Hz
	(operative range 10 Hz to 80 Hz with higher tolerances)	
Test values:	$\varphi (I_A-I_B), \varphi (I_B-I_C), \varphi (I_C-I_A)$ in ° $\varphi (V_A-V_B), \varphi (V_B-V_C), \varphi (V_C-V_A)$ in °	
Permissive tolerance/Limiting values:	Current	$\leq 0.2^\circ$ at I_{rated}
	Voltage	$\leq 0.2^\circ$ at V_{rated}
Test results/Remarks:	Current	$< 0.2^\circ$ at I_{rated}
	Voltage	$< 0.2^\circ$ at V_{rated}

1.52.6 Power, ratings

1.52.6.1 Active Power P

Test condition:	W secondary	
	Measuring Range:	$ \cos\varphi \geq 0.01$
	Voltage Range:	(0.8 to 1.2) V_{rated}
	Current range:	(0.1 to 2) I_{rated}
	Frequency range:	
	$f_{rated} = 50$ Hz:	49 Hz to 51 Hz
	$f_{rated} = 60$ Hz:	59 Hz to 61 Hz
Test values:	P, P_A, P_B, P_C in W (secondary)	
Permissive tolerance/Limiting values:	£ 0.3 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.3 %	
Test condition:	Frequency range:	
	$f_{rated} = 50$ Hz:	40 Hz to 60 Hz
	$f_{rated} = 60$ Hz:	50 Hz to 70 Hz
Test values:	P, P_A, P_B, P_C in W (secondary)	
Permissive tolerance/Limiting values:	£ 0.5 % of the measured value in the above mentioned ranges	
Test results/Remarks:	£ 0.5 %	

Summary

1.52.6.2 Reactive Power Q

Test condition:	VAr secondary
Measuring Range:	$ \cos\phi \geq 0.984$
Voltage Range:	$(0.8 \text{ to } 1.2) V_{rated}$
Current range:	$(0.1 \text{ to } 2) I_{rated}$
Frequency range:	
$f_{rated} = 50 \text{ Hz}$:	49 Hz to 51 Hz
$f_{rated} = 60 \text{ Hz}$:	59 Hz to 61 Hz
Test values:	Q, Q _A , Q _B , Q _C in VAr (secondary)
Permissive tolerance/Limiting values:	£ 1 % of the measured value in the above mentioned ranges
Test results/Remarks:	£ 1 %
	Frequency range:
	$f_{rated} = 50 \text{ Hz}$: 40 Hz to 60 Hz
	$f_{rated} = 60 \text{ Hz}$: 50 Hz to 70 Hz
Test values:	Q, Q _A , Q _B , Q _C in VAr (secondary)
Permissive tolerance/Limiting values:	£ 1.5 % of the measured value in the above mentioned ranges
Test results/Remarks:	£ 1.5 %

1.52.6.3 Apparent Power S

Test condition:	VA secondary
Measuring Range:	$(0.01 \text{ to } 2) S_{rated}$
Voltage Range:	$(0.8 \text{ to } 1.2) V_{rated}$
Current range:	$(0.1 \text{ to } 2) I_{rated}$
Frequency range:	
$f_{rated} = 50 \text{ Hz}$:	49 Hz to 51 Hz
$f_{rated} = 60 \text{ Hz}$:	59 Hz to 61 Hz
Test values:	S, S _A , S _B , S _C in VA (secondary)
Permissive tolerance/Limiting values:	£ 0.3 % of the measured value in the above mentioned ranges
Test results/Remarks:	£ 0.3 %
Test condition:	Frequency range:
	$f_{rated} = 50 \text{ Hz}$: 40 Hz to 60 Hz
	$f_{rated} = 60 \text{ Hz}$: 50 Hz to 70 Hz
Test values:	S, S _A , S _B , S _C in VA (secondary)
Permissive tolerance/Limiting values:	£ 0.5 % of the measured value in the above mentioned ranges
Test results/Remarks:	£ 0.5 %

1.52.7 Frequency

Test condition:	Frequency range	10 Hz to 80 Hz
Test values:	f in Hz and f_{rated}	
Permissive tolerance/Limiting values:	£ 20 mHz in the range $f_{rated} \pm 10\%$ at V_{rated}, I_{rated}	
Test results/Remarks:	£ 10 mHz in the range $f_{rated} \pm 10\%$ at V_{rated}, I_{rated} (operative range > $f_{rated} \pm 10\%$ with higher tolerances)	

Summary

1.53 CB wear monitoring

1.53.1 $\sum I_x$ -method

No accuracies defined, because this method is a monitoring function, which contains no protection-specific task and the principles are based upon empiric determined data.

1.53.2 2P-method

No accuracies defined, because this method is a monitoring function, which contains no protection-specific task and the principles are based upon empiric determined data.

1.53.3 I²t-method

No accuracies defined, because this method is a monitoring function, which contains no protection-specific task and the principles are based upon empiric determined data.

1.53.4 Supv.CB make time

1.53.4.1 Circuit breaker closing time

Test condition/Operative range:	$f_{rated} = 50 \text{ Hz}, 60\text{Hz}$ $0.001 \text{ s} \leq t_{CBcltm} \leq 0.600 \text{ s}$
Test values:	$0.03 \text{ A} \leq I \leq 5 \text{ A}$
Permissive tolerance/Limiting values:	$t_{CBcltm} \leq 2 \text{ ms}$
Test results/Remarks:	$t_{CBcltm} < 2 \text{ ms}$

Summary**1.54 Interfaces****1.54.1 USB interface (front panel)**

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.2 Integrated ethernet interface (rear)

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.3 System interfaces**1.54.3.1 IEC 60870-5-103**

Test values: RS232, RS485, LWL

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.3.2 IEC 60870-5-104

Test values: LWL

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.3.3 DNP3.0

Test values: RS485, LWL

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.3.4 IEC 61850 (Edition 1 and 2)

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.4 Time synchronization

Test condition: IRIG-B, DCF77, SNTP

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.5 Protection interfaces

Test values: Transmission of status information

Permissive tolerance/Limiting values: Funct. acc. to manual

Test results/Remarks: Function correct

1.54.6 Phasor measurement unit (PMU)

Permissive tolerance/Limiting values: Accuracy according to IEEE C37.118.1 (class P)

Accuracy according to IEEE C37.118.1 (class M)

Test results/Remarks: Requirements for class P and M in accordance to IEEE C37.118.1 passed